

## FEATURES

- 16-bit ADC with 800 kSPS on all channels
- Input buffer with 5 M $\Omega$  analog input impedance
- Pin to pin compatible with the [AD7606](#)
- 40°C to +125°C operating temperature range
- Single 5 V analog supply and 1.71 V to 3.6 V  $V_{\text{DRIVE}}$  supply
- $\pm 21$  V input clamp protection with 8 kV ESD
- Extra modes available in software mode
  - Per channel selectable analog input ranges
    - Single-ended, bipolar:  $\pm 10$  V,  $\pm 5$  V, and  $\pm 2.5$  V
  - Per channel system phase, offset, and gain calibration
  - Analog input open circuit detection feature
    - <20 LSB open circuit code error ( $R_{\text{PD}} = 10$  k $\Omega$ )
  - Self diagnostics and monitoring features
    - CRC error checking on read/write data and registers

## APPLICATIONS

- Power line monitoring
- Protective relays
- Multiphase motor control
- Instrumentation and control systems
- Data acquisition systems

## FUNCTIONAL BLOCK DIAGRAM

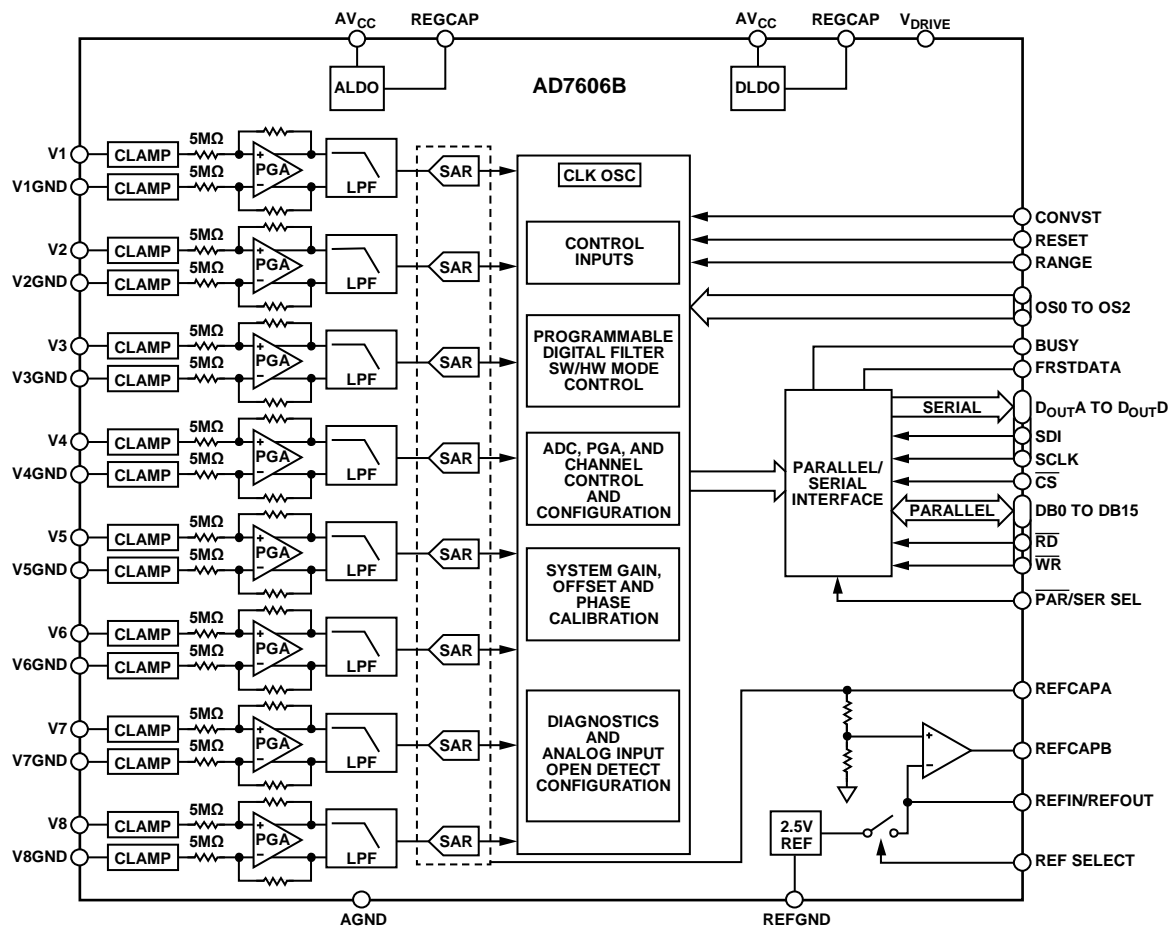


Figure 1.

Rev. 0

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## REVISION HISTORY

6/2019—Revision 0: Initial Version

## GENERAL DESCRIPTION

The AD7606B is a 16-bit, simultaneous sampling, analog-to-digital data acquisition system (DAS) with eight channels, each channel containing analog input clamp protection, a programmable gain amplifier (PGA), a low-pass filter, and a 16-bit successive approximation register (SAR), analog-to-digital converter (ADC). The AD7606B also contains a flexible digital filter, low drift, 2.5 V precision reference and reference buffer to drive the ADC and flexible parallel and serial interfaces.

The AD7606B operates from a single 5 V supply and accommodates  $\pm 10$  V,  $\pm 5$  V, and  $\pm 2.5$  V true bipolar input ranges when sampling at throughput rates of 800 kSPS for all channels. The input clamp protection tolerates voltages up to  $\pm 21$  V. The AD7606B has a 5 M $\Omega$  analog input impedance, resulting in less than 20 LSB bipolar zero code when the input signal is disconnected and pulled to ground through a 10 k $\Omega$  external resistor. The single supply operation, on-chip filtering, and high input impedance eliminates the need for external driver op amps, which require bipolar supplies. For applications with lower throughput rates, the AD7606B flexible digital filter can be used to improve noise performance.

In hardware mode, the AD7606B is fully compatible with the [AD7606](#). In software mode, the following advanced features are available:

- Additional  $\pm 2.5$  V analog input range.
- Analog input range ( $\pm 10$  V,  $\pm 5$  V, and  $\pm 2.5$  V), selectable per channel.
- Additional oversampling (OS) options, up to  $OS \times 256$ .
- System gain, system offset, and system phase calibration per channel.
- Analog input open circuit detector.
- Diagnostic multiplexer.
- Monitoring functions (serial peripheral interface (SPI) invalid read/write, cyclic redundancy check (CRC), overvoltage and undervoltage events, busy stuck monitor, and reset detection).

Note that throughout this data sheet, multifunction pins, such as the  $\overline{RD}/SCLK$  pin, are referred to either by the entire pin name or by a single function of the pin, for example, the SCLK pin, when only that function is relevant.

**Table 1. Pin to Pin Compatible Devices**

Resolution (Bits)	Single-Ended Bipolar Inputs	True Differential Bipolar Inputs
18	<a href="#">AD7608</a>	<a href="#">AD7609</a>
16	<a href="#">AD7606</a> <a href="#">AD7606B</a>	
14	<a href="#">AD7607</a>	

## SPECIFICATIONS

Voltage reference ( $V_{REF}$ ) = 2.5 V external and internal, analog supply voltage ( $AV_{CC}$ ) = 4.75 V to 5.25 V, logic supply voltage ( $V_{DRIVE}$ ) = 1.71 V to 3.6 V, sample frequency ( $f_{SAMPLE}$ ) = 800 kSPS, with no oversampling,  $T_A$  =  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , single-ended input, and all input voltage ranges, unless otherwise noted.

Table 2.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
<b>DYNAMIC PERFORMANCE</b>					
Signal-to-Noise Ratio (SNR) <sup>1</sup>	Input frequency ( $f_{IN}$ ) = 1 kHz sine wave, unless otherwise noted				
	No oversampling (OS), $\pm 10$ V range	87.5	89.5		dB
	No OS, $\pm 5$ V range	86.5	88.5		dB
	No OS, $\pm 2.5$ V range	83.5	86		dB
	Oversampling ratio (OSR) = $16\times$ , $\pm 10$ V range	92	93.5		dB
	OSR = $16\times$ , $\pm 5$ V range	90.5	92		dB
Total Harmonic Distortion (THD)	OSR = $16\times$ , $\pm 2.5$ V range	87.5	89		dB
	All input ranges				
	$f_{SAMPLE} = 200$ kSPS		−105	−94	dB
Signal-to-Noise-and-Distortion	$f_{SAMPLE} = 800$ kSPS		−100	−90	dB
	No OS, $\pm 10$ V range	86.5	88.5		dB
	No OS, $\pm 5$ V range	85.5	87.7		dB
	No OS, $\pm 2.5$ V range	83	85.5		dB
	OSR = $16\times$ , $\pm 10$ V range	89	92		dB
	OSR = $16\times$ , $\pm 5$ V range	89	91.3		dB
Spurious-Free Dynamic Range (SFDR)	OSR = $16\times$ , $\pm 2.5$ V range	86.5	88.7		dB
			−104		dB
Channel to Channel Isolation	$f_{IN}$ on unselected channels up to 160 kHz		−110		dB
Full Scale Step Settling Time	0.01% of full scale				
	$\pm 10$ V range		70		$\mu\text{s}$
	$\pm 5$ V range		110		$\mu\text{s}$
	$\pm 2.5$ V range		130		$\mu\text{s}$
<b>ANALOG INPUT FILTER</b>					
Full Power Bandwidth	−3 dB, $\pm 10$ V range		22.5		kHz
	−3 dB, $\pm 5$ V range		13.5		kHz
	−3 dB, $\pm 2.5$ V range		11.5		kHz
	−0.1 dB, $\pm 10$ V range		3		kHz
	−0.1 dB, $\pm 5$ V range		2		kHz
	−0.1 dB, $\pm 2.5$ V range		2		kHz
Phase Delay	$\pm 10$ V range		8		$\mu\text{s}$
	$\pm 5$ V range		9		$\mu\text{s}$
	$\pm 2.5$ V range		11		$\mu\text{s}$
Phase Delay Matching					
	$\pm 10$ V range			240	ns
	$\pm 5$ V range			365	ns
	$\pm 2.5$ V range			445	ns
<b>DC ACCURACY</b>					
Resolution	No missing codes	16			Bits
Differential Nonlinearity (DNL)			$\pm 0.5$	$\pm 0.99$	LSB <sup>2</sup>
Integral Nonlinearity (INL)	$f_{SAMPLE} = 200$ kSPS			$\pm 2$	LSB <sup>2</sup>
	$f_{SAMPLE} = 800$ kSPS		$\pm 1.16$	$\pm 2.5$	LSB <sup>2</sup>
Total Unadjusted Error (TUE)	Internal reference		$\pm 3$	$\pm 47$	LSB
Positive and Negative Full-Scale (FS) Error <sup>3</sup>	External reference		$\pm 2$	$\pm 30$	LSB
	Internal reference		$\pm 2$	$\pm 45$	LSB

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
Positive and Negative FS Error Drift Positive and Negative FS Error Matching Bipolar Zero Code Error Bipolar Zero Code Error Drift Bipolar Zero Code Error Matching Open Circuit Code Error	$R_{\text{FILTER}}^4 = 20 \text{ k}\Omega$ , system gain calibration disabled		126		LSB
	$R_{\text{FILTER}}^4 = 0 \text{ k}\Omega$ to $65 \text{ k}\Omega$ , system gain calibration enabled		4		LSB
	External reference		$\pm 1$	$\pm 5$	ppm/ $^{\circ}\text{C}$
	Internal reference		$\pm 4$	$\pm 15$	ppm/ $^{\circ}\text{C}$
	$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$		3	20	LSB
			$\pm 1$	$\pm 20$	LSB <sup>2</sup>
			$\pm 1$	$\pm 14$	LSB
			$\pm 0.2$	$\pm 2$	ppm/ $^{\circ}\text{C}$
	$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$		1.5	23	LSB <sup>2</sup>
			1.4	14	LSB
			$\pm 12$	$\pm 30$	LSB
			$\pm 12$	$\pm 20$	LSB
			$\pm 17$	$\pm 35$	LSB
			$\pm 17$	$\pm 25$	LSB
ANALOG INPUT Input Voltage Ranges Input Voltage Ranges Analog Input Current Input Capacitance ( $C_{\text{IN}}$ ) <sup>6</sup> Input Impedance ( $R_{\text{IN}}$ ) <sup>7</sup> Input Impedance Drift	$V_X - V_{X\text{GND}}$				
	$\pm 10 \text{ V}$ range	-10		+10	V
	$\pm 5 \text{ V}$ range	-5		+5	V
	$\pm 2.5 \text{ V}$ range	-2.5		+2.5	V
	$V_{X\text{GND}} - \text{AGND}$				
	$\pm 10 \text{ V}$ range	-0.7		+1.9	V
	$\pm 5 \text{ V}$ range	-0.1		+2.7	V
	$\pm 2.5 \text{ V}$ range	-0.1		+3.1	V
	See the Typical Performance Characteristics section		$(V_{\text{IN}} - 2)/R_{\text{IN}}$		$\mu\text{A}$
			5		pF
REFERENCE INPUT/OUTPUT Reference Input Voltage DC Leakage Current Input Capacitance <sup>6</sup> Reference Output Voltage Reference Temperature Coefficient Reference Voltage to the ADC	REF SELECT = 0, external reference	2.495	2.5	2.505	V
				$\pm 0.12$	$\mu\text{A}$
			7.5		pF
	REF SELECT = 1, internal reference, $T_A = 25^{\circ}\text{C}$	2.497	2.5	2.503	V
			$\pm 3$	$\pm 15$	ppm/ $^{\circ}\text{C}$
	REFCAPA (Pin 44) and REFCAPB (Pin 45)	4.39		4.41	V
LOGIC INPUTS Input High Voltage ( $V_{\text{INH}}$ ) Input Low Voltage ( $V_{\text{INL}}$ ) Input Current ( $I_{\text{IN}}$ ) Input Capacitance <sup>6</sup>		$0.7 \times V_{\text{DRIVE}}$			V
				$0.3 \times V_{\text{DRIVE}}$	V
				$\pm 1$	$\mu\text{A}$
			5		pF
LOGIC OUTPUTS Output High Voltage ( $V_{\text{OH}}$ ) Output Low Voltage ( $V_{\text{OL}}$ ) Floating State Leakage Current Output Capacitance <sup>6</sup> Output Coding	Current source ( $I_{\text{SOURCE}} = 100 \mu\text{A}$ )	$V_{\text{DRIVE}} - 0.2$			V
	Current sink ( $I_{\text{SINK}} = 100 \mu\text{A}$ )			0.2	V
			$\pm 1$	$\pm 20$	$\mu\text{A}$
			5		pF
	Twos complement				N/A <sup>8</sup>
CONVERSION RATE Conversion Time Acquisition Time Throughput Rate	See Table 3		0.75		$\mu\text{s}$
			0.5		$\mu\text{s}$
	Per channel			800	kSPS

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
POWER REQUIREMENTS					
$V_{CC}$		4.75	5	5.25	V
$V_{DRIVE}$		1.71		3.6	V
REGCAP		1.875		1.93	V
$I_{AVCC}$ Current ( $I_{AVCC}$ )					
Normal Mode (Static)			7.5	9.5	mA
Normal Mode (Operational)	$f_{SAMPLE} = 800$ kSPS		43	47.5	mA
	$f_{SAMPLE} = 10$ kSPS		8	10	mA
Standby			3.5	4.5	mA
Shutdown Mode			0.5	5	$\mu$ A
$I_{DRIVE}$ Current ( $I_{DRIVE}$ )					
Normal Mode (Static)			1.8	3.5	$\mu$ A
Normal Mode (Operational)	$f_{SAMPLE} = 800$ kSPS		1.1	1.5	mA
	$f_{SAMPLE} = 10$ kSPS		30	75	$\mu$ A
Standby			1.6	3	$\mu$ A
Shutdown Mode			0.8	2	$\mu$ A
Power Dissipation					
Normal Mode (Static)			40	50	mW
Normal Mode (Operational)	$f_{SAMPLE} = 800$ kSPS		230	255	mW
	$f_{SAMPLE} = 10$ kSPS		42	50	mW
Standby			18	24	mW
Shutdown Mode			2.5	25	$\mu$ W

<sup>1</sup> No OS means no oversampling is applied.

<sup>2</sup> LSB means least significant bit. With a  $\pm 2.5$  V input range, 1 LSB = 76.293  $\mu$ V. With a  $\pm 5$  V input range, 1 LSB = 152.58  $\mu$ V. With a  $\pm 10$  V input range, 1 LSB = 305.175  $\mu$ V.

<sup>3</sup> These specifications include the full temperature range variation and contribution from the internal reference and reference buffer.

<sup>4</sup>  $R_{FILTER}$  is a resistor placed in a series to the analog input front-end. See Figure 57.

<sup>5</sup> See Figure 59.

<sup>6</sup> Not production tested. Sample tested during initial release to ensure compliance.

<sup>7</sup> Input impedance variation is factory trimmed and accounted for in the System Gain Calibration section.

<sup>8</sup> N/A means not applicable.

## TIMING SPECIFICATIONS

### Universal Timing Specifications

$V_{CC} = 4.75$  V to 5.25 V,  $V_{DRIVE} = 1.71$  V to 3.6 V,  $V_{REF} = 2.5$  V external reference and internal reference, and  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , unless otherwise noted. Interface timing tested using a load capacitance of 20 pF, dependent on  $V_{DRIVE}$  and load capacitance for serial interface.

Table 3.

Parameter	Min	Typ	Max	Unit	Description
$t_{CYCLE}$	1.25			$\mu$ s	Minimum time between consecutive CONVST rising edges (excluding oversampling modes) <sup>1</sup>
$t_{LP\_CNV}$	10			ns	CONVST low pulse width
$t_{HP\_CNV}$	10			ns	CONVST high pulse width
$t_{D\_CNV\_BSY}$					CONVST high to BUSY high delay time
			20	ns	$V_{DRIVE} > 2.7$ V
			25	ns	$V_{DRIVE} < 2.7$ V
$t_{S\_BSY}$	0			ns	Minimum time from BUSY falling edge to $\overline{RD}$ falling edge setup time (in parallel interface) or to MSB being available on $D_{OUTx}$ line (in serial interface)
$t_{D\_BSY}$			25	ns	Maximum time between last $\overline{RD}$ falling edge (in parallel interface) or last LSB being clocked out (serial interface) and the following BUSY falling edge; read during conversion
$t_{CONV}$	0.65		0.85	$\mu$ s	Conversion time; no oversampling
	2.2		2.3	$\mu$ s	Oversampling by 2
	4.65		4.8	$\mu$ s	Oversampling by 4
	9.6		9.9	$\mu$ s	Oversampling by 8
	19.4		20	$\mu$ s	Oversampling by 16

Parameter	Min	Typ	Max	Unit	Description
$t_{\text{RESET}}$	39.2		40.2	$\mu\text{s}$	Oversampling by 32
	78.7		80.8	$\mu\text{s}$	Oversampling by 64
	157.6		161.9	$\mu\text{s}$	Oversampling by 128
	315.6		324	$\mu\text{s}$	Oversampling by 256
Partial Reset	55		2000	ns	Partial RESET high pulse width
Full Reset	3000			ns	Full RESET high pulse width
$t_{\text{DEVICE\_SETUP}}$				$\mu\text{s}$	Time between RESET falling edge and first CONVST rising edge
Partial Reset	50			ns	
Full Reset	253			$\mu\text{s}$	
$t_{\text{WAKE-UP}}$					Wake-up time after standby/shutdown mode
Standby	1			$\mu\text{s}$	
Shutdown	10			ms	
$t_{\text{POWER-UP}}$	10			ms	Time between stable $V_{\text{CC}}/V_{\text{DRIVE}}$ and assert of RESET

<sup>1</sup> Applies to serial mode when all four  $D_{\text{OUTX}}$  lines are selected.

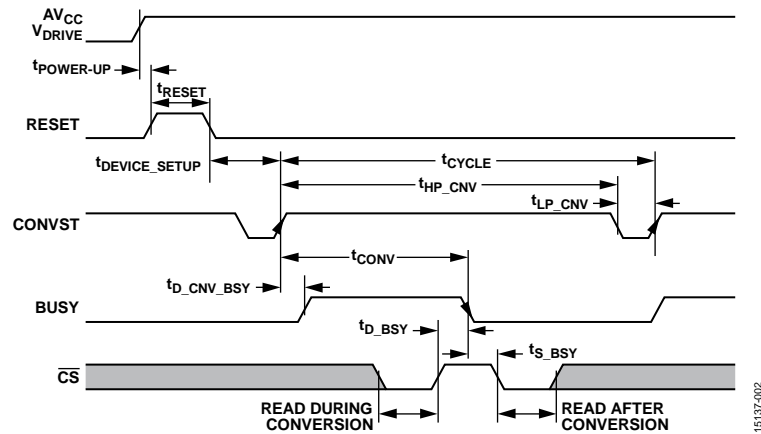


Figure 2. Universal Timing Diagram

### Parallel Mode Timing Specifications

Table 4.

Parameter	Min	Typ	Max	Unit	Description
$t_{\text{S\_}\overline{\text{CS}}\text{-RD}}$	0			ns	$\overline{\text{CS}}$ falling edge to $\overline{\text{RD}}$ falling edge setup time
$t_{\text{H\_RD-}\overline{\text{CS}}}$	0			ns	$\overline{\text{RD}}$ rising edge to $\overline{\text{CS}}$ rising edge hold time
$t_{\text{HP\_RD}}$	10			ns	$\overline{\text{RD}}$ high pulse width
$t_{\text{LP\_RD}}$	10			ns	$\overline{\text{RD}}$ low pulse width
$t_{\text{HP\_}\overline{\text{CS}}}$	10			ns	$\overline{\text{CS}}$ high pulse width
$t_{\text{D\_}\overline{\text{CS}}\text{-DB}}$			35	ns	Delay from $\overline{\text{CS}}$ until DBx three-state disabled
$t_{\text{H\_}\overline{\text{CS}}\text{-DB}}$	0			ns	$\overline{\text{CS}}$ to DBx hold time
$t_{\text{D\_RD-DB}}$					Data access time after falling edge of $\overline{\text{RD}}$
			27	ns	$V_{\text{DRIVE}} > 2.7\text{ V}$
			37	ns	$V_{\text{DRIVE}} < 2.7\text{ V}$
$t_{\text{H\_RD-DB}}$	12			ns	Data hold time after falling edge of $\overline{\text{RD}}$
$t_{\text{DHZ\_}\overline{\text{CS}}\text{-DB}}$			40	ns	$\overline{\text{CS}}$ rising edge to DBx high impedance
$t_{\text{CYC\_RD}}$					$\overline{\text{RD}}$ falling edge to next $\overline{\text{RD}}$ falling edge
	30			ns	$V_{\text{DRIVE}} > 2.7\text{ V}$
	40			ns	$V_{\text{DRIVE}} < 2.7\text{ V}$
$t_{\text{D\_}\overline{\text{CS}}\text{-FD}}$			26	ns	Delay from $\overline{\text{CS}}$ falling edge until FRSTDATA three-state disabled

Parameter	Min	Typ	Max	Unit	Description
$t_{D\_RD\_FDH}$			30	ns	Delay from $\overline{RD}$ falling edge until FRSTDATA high
$t_{D\_RD\_FDL}$			30	ns	Delay from $\overline{RD}$ falling edge until FRSTDATA low
$t_{DZH\_FD}$			28	ns	Delay from $\overline{CS}$ rising edge until FRSTDATA three-state enabled
$t_{S\_CS\_WR}$	0			ns	$\overline{CS}$ to $\overline{WR}$ setup time
$t_{HP\_WR}$	213			ns	$\overline{WR}$ high pulse width
$t_{LP\_WR}$				ns	$\overline{WR}$ low pulse width
	88			ns	$V_{DRIVE} > 2.7\text{ V}$
	213			ns	$V_{DRIVE} < 2.7\text{ V}$
$t_{H\_WR\_CS}$	0			ns	$\overline{WR}$ hold time
$t_{S\_DB\_WR}$	5			ns	Configuration data to $\overline{WR}$ setup time
$t_{H\_WR\_DB}$	5			ns	Configuration data to $\overline{WR}$ hold time
$t_{CYC\_WR}$	230			ns	Configuration data settle time, $\overline{WR}$ rising edge to next $\overline{WR}$ rising edge

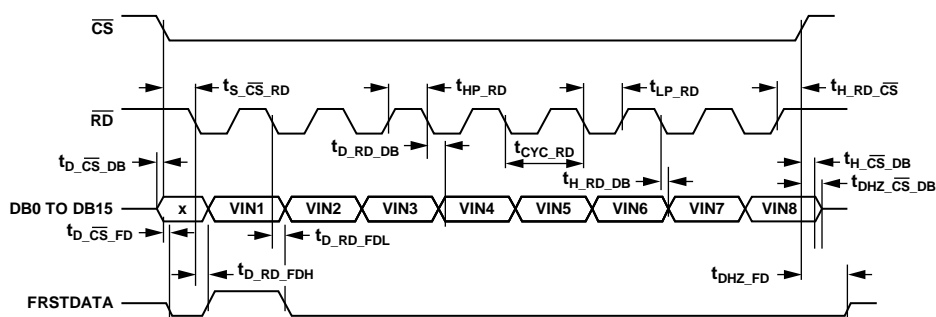
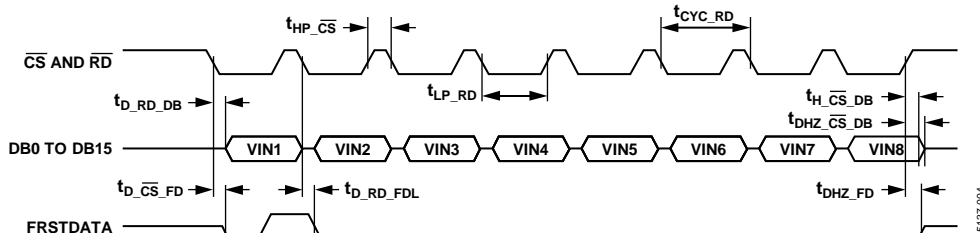
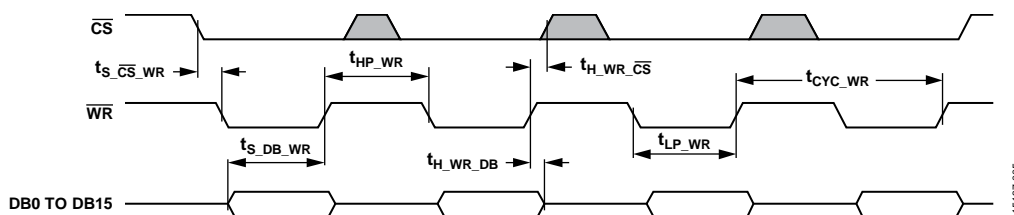
Figure 3. Parallel Mode Read Timing Diagram, Separate  $\overline{CS}$  and  $\overline{RD}$  PulsesFigure 4. Parallel Mode Read Timing Diagram, Linked  $\overline{CS}$  and  $\overline{RD}$ 

Figure 5. Parallel Mode Write Operation Timing Diagram



## Serial Mode Timing Specifications

Table 5.

Parameter	Min	Typ	Max	Unit	Description
$f_{SCLK}$			60 40	MHz MHz	SCLK frequency; $f_{SCLK} = 1/t_{SCLK}$ $V_{DRIVE} > 2.7 V$ $V_{DRIVE} < 2.7 V$
$t_{SCLK}$	$1/f_{SCLK}$			$\mu s$	Minimum SCLK period
$t_{S\_CS\_SCLK}$	2			ns	$\overline{CS}$ to SCLK falling edge setup time
$t_{H\_SCLK\_CS}$	2			ns	SCLK to $\overline{CS}$ rising edge hold time
$t_{LP\_SCLK}$	$0.4 \times t_{SCLK}$			ns	SCLK low pulse width
$t_{HP\_SCLK}$	$0.4 \times t_{SCLK}$			ns	SCLK high pulse width
$t_{D\_CS\_DO}$					Delay from $\overline{CS}$ until $D_{OUTX}$ three-state disabled
			9	ns	$V_{DRIVE} > 2.7 V$
			18	ns	$V_{DRIVE} < 2.7 V$
$t_{D\_SCLK\_DO}$					Data out access time after SCLK rising edge
			15	ns	$V_{DRIVE} > 2.7 V$
			25	ns	$V_{DRIVE} < 2.7 V$
$t_{H\_SCLK\_DO}$	8			ns	Data out hold time after SCLK rising edge
$t_{S\_SDI\_SCLK}$	8			ns	Data in setup time before SCLK falling edge
$t_{H\_SCLK\_SDI}$	0			ns	Data in hold time after SCLK falling edge
$t_{DHZ\_CS\_DO}$					$\overline{CS}$ rising edge to $D_{OUTX}$ high impedance
			7	ns	$V_{DRIVE} > 2.7 V$
			22	ns	$V_{DRIVE} < 2.7 V$
$t_{WR}$	25			ns	Time between writing and reading the same register or between two writes; if $f_{SCLK} > 50 MHz$
$t_{D\_CS\_FD}$			26	ns	Delay from $\overline{CS}$ until $D_{OUTX}$ three-state disabled/delay from $\overline{CS}$ until MSB valid
$t_{D\_SCLK\_FDL}$			18	ns	16 <sup>th</sup> SCLK falling edge to FRSTDATA low
$t_{DHZ\_FD}$			28	ns	$\overline{CS}$ rising edge until FRSTDATA three-state enabled

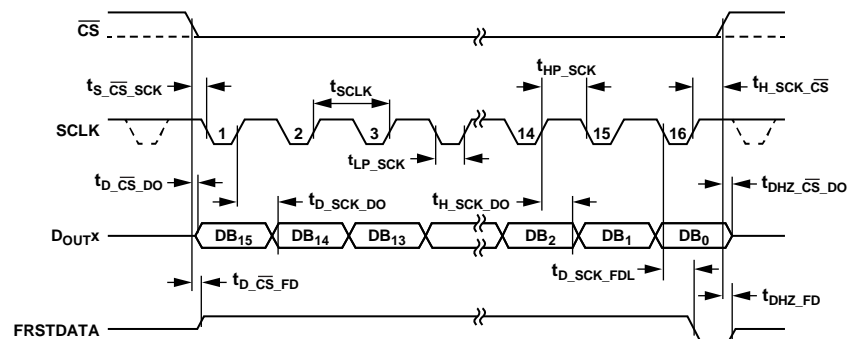


Figure 6. Serial Timing Diagram, ADC Read Mode (Channel 1)

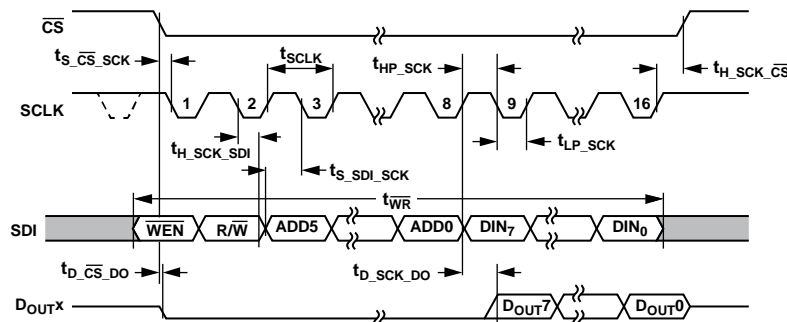


Figure 7. Serial Interface Timing Diagram, Register Map Read/Write Operations

## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless otherwise noted.

Table 6.

Parameter	Rating
$AV_{CC}$ to AGND	$-0.3\text{ V to }+7\text{ V}$
$V_{DRIVE}$ to AGND	$-0.3\text{ V to }AV_{CC} + 0.3\text{ V}$
Analog Input Voltage to AGND <sup>1</sup>	$\pm 21\text{ V}$
Digital Input Voltage to AGND	$-0.3\text{ V to }V_{DRIVE} + 0.3\text{ V}$
Digital Output Voltage to AGND	$-0.3\text{ V to }V_{DRIVE} + 0.3\text{ V}$
REFIN to AGND	$-0.3\text{ V to }AV_{CC} + 0.3\text{ V}$
Input Current to Any Pin Except Supplies <sup>1</sup>	$\pm 10\text{ mA}$
Operating Temperature Range	$-40^\circ\text{C to }+125^\circ\text{C}$
Storage Temperature Range	$-65^\circ\text{C to }+150^\circ\text{C}$
Junction Temperature	$150^\circ\text{C}$
Pb/Sn Temperature, Soldering	
Reflow (10 sec to 30 sec)	$240 (+0)^\circ\text{C}$
Pb-Free Temperature, Soldering Reflow	$260 (+0)^\circ\text{C}$
Electrostatic Discharge (ESD)	
All Pins Except Analog Inputs	$3.5\text{ kV}$
Analog Input Pins Only	$8\text{ kV}$

<sup>1</sup> Transient currents of up to 100 mA do not cause silicon controlled rectifier (SCR) latch-up.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Close attention to PCB thermal design is required.

$\theta_{JA}$  is the natural convection junction to ambient thermal resistance measured in a one cubic foot sealed enclosure.  $\theta_{JC}$  is the junction to case thermal resistance.

Table 7. Thermal Resistance

Package Type	$\theta_{JA}$ <sup>1</sup>	$\theta_{JC}$	Unit
ST-64-2	40	7	$^\circ\text{C/W}$

<sup>1</sup> Simulated data based on JEDEC 2s2p thermal test PCB in a JEDEC natural convection environment.

## ESD CAUTION



### ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

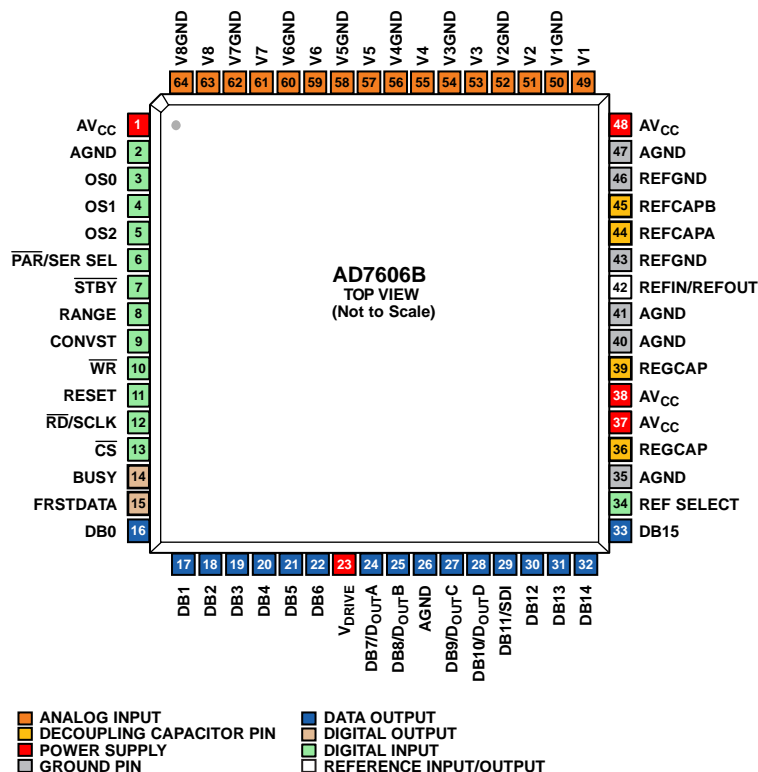


Figure 8. Pin Configuration

Table 8. Pin Function Description

Pin No.	Type <sup>1</sup>	Mnemonic	Description
1, 37, 38, 48	P	AV <sub>CC</sub>	Analog Supply Voltage, 4.75 V to 5.25 V. This supply voltage is applied to the internal front-end amplifiers and to the ADC core. Decouple these supply pins to AGND.
2, 26, 35, 40, 41, 47	P	AGND	Analog Ground. These pins are the ground reference points for all analog circuitry on the AD7606B. All analog input signals and external reference signals must be referred to these pins. All six of the AGND pins must connect to the AGND plane of a system.
3 to 5	DI	OS0 to OS2	Oversampling Mode Pins. These inputs select the oversampling ratio or enable software mode (see Table 12 for oversampling pin decoding). See the Digital Filter section for more details about the oversampling mode of operation.
6	DI	PAR/SER SEL	Parallel/Serial Interface Selection Input. If this pin is tied to a logic low, the parallel interface is selected. If this pin is tied to a logic high, the serial interface is selected. See the Digital Interface section for more information on each interface available.
7	DI	STBY	Standby Mode Input. In hardware mode, this pin, in combination with the RANGE pin, places the AD7606B in one of two power-down modes: standby mode or shutdown mode. In software mode, this pin is ignored. Therefore, it is recommended to connect this pin to logic high. See the Power-Down Modes section for more information on both hardware mode and software mode.
8	DI	RANGE	Analog Input Range Selection Input. In hardware mode, this pin determines the input range of the analog input channels (see Table 9). If the STBY pin is at logic low, this pin determines the power-down mode (see Table 14). In software mode, the RANGE pin is ignored. However, this pin must be tied high or low.
9	DI	CONVST	Conversion Start Input. When the CONVST pin transitions from low to high, the analog input is sampled on all eight SAR ADCs. In software mode, this pin can be configured as external oversampling clock. Providing a low jitter external clock improves the SNR performance for large oversampling ratios. See the External Oversampling Clock section for further details.
10	DI	WR	Digital Input. In hardware mode, this pin has no function. Therefore, it can be tied high, tied low, or shorted to CONVST. In software mode, this pin is an active low write pin for writing registers using the parallel interface. See the Parallel Interface section for more information.

Pin No.	Type <sup>1</sup>	Mnemonic	Description
11	DI	RESET	Reset Input, Active High. Full and partial reset options are available on the AD7606B. The type of reset is determined by the length of the reset pulse. It is recommended that the device receives a full reset pulse after power-up. See the Reset Functionality section for further details.
12	DI	$\overline{\text{RD}}$ /SCLK	Parallel Data Read Control Input when the Parallel Interface is Selected (RD). Serial Clock Input when the Serial Interface is Selected (SCLK). See the Digital Interface section for more details.
13	DI	$\overline{\text{CS}}$	Chip Select. This pin is the active low chip select input for ADC data read or register data read and write, in both serial and parallel interface. See the Digital Interface section for more details.
14	DO	BUSY	Busy Output. This pin transitions to a logic high along with the CONVST rising edge. The BUSY output remains high until the conversion process for all channels is complete.
15	DO	FRSTDATA	First Data Output. The FRSTDATA output signal indicates when the first channel, V1, is being read back on the parallel interface (see Figure 3) or the serial interface (see Figure 6). See the Digital Interface section for more details.
16 to 22	DO/DI	DB0 to DB6	Parallel Output/Input Data Bits. When using parallel interface, these pins act as three-state parallel digital input and output pins (see the Parallel Interface section). When using serial interface, tie these pins to AGND.
23	P	V <sub>DRIVE</sub>	Logic Power Supply Input. The voltage (1.71 V to 3.6 V) supplied at this pin determines the operating voltage of the interface. This pin is nominally at the same supply as the supply of the host interface, that is, data signal processing (DSP) and field programmable gate array (FPGA).
24	DO/DI	DB7/D <sub>OUT</sub> A	Parallel Output/Input Data Bit 7 (DB7)/Serial Interface Data Output Pin (D <sub>OUT</sub> A). When using the parallel interface, this pin acts as a three-state parallel digital input/output pin. When using the serial interface, this pin functions as D <sub>OUT</sub> A. See Table 21 and Table 22 for more details on each data interface and operation mode.
25	DO/DI	DB8/D <sub>OUT</sub> B	Parallel Output/Input Data Bit 8 (DB8)/Serial Interface Data Output Pin (D <sub>OUT</sub> B). When using the parallel interface, this pin acts as a three-state parallel digital input and output pin. When using the serial interface, this pin functions as D <sub>OUT</sub> B. See Table 21 and Table 22 for more details on each data interface and operation mode.
27	DO/DI	DB9/D <sub>OUT</sub> C	Parallel Output/Input Data Bit 9 (DB9)/Serial Interface Data Output Pin (D <sub>OUT</sub> C). When using the parallel interface, this pin acts as a three-state parallel digital input and output pin. When using the serial interface, this pin functions as D <sub>OUT</sub> C if in software mode and using four data output lines option. See Table 21 and Table 22 for more details on each data interface and operation mode.
28	DO/DI	DB10/D <sub>OUT</sub> D	Parallel Output/Input Data Bit 10 (DB10)/Serial Interface Data Output Pin (D <sub>OUT</sub> D). When using the parallel interface, this pin acts as a three-state parallel digital input/output pin. When using the serial interface, this pin functions as D <sub>OUT</sub> D if in software mode and using the four data output lines option. See Table 21 and Table 22 for more details on each data interface and operation mode.
29	DO/DI	DB11/SDI	Parallel Output/Input Data Bit DB11/Serail Data Input. When using the parallel interface, this pin acts as a three-state parallel digital input and output pin. When using the serial interface in software mode, this pin functions as serial data input. See Table 21 and Table 22 for more details on each data interface and operation mode.
30 to 33	DO/DI	DB12 to DB15	Parallel Output/Input Data Bits, DB15 to DB12. When using the parallel interface, these pins act as three-state parallel digital input and output pins (see the Parallel Interface section). When using the serial interface, tie these pins to AGND.
34	DI	REF SELECT	Internal/External Reference Selection Logic Input. If this pin is set to logic high, the internal reference is selected and enabled. If this pin is set to logic low, the internal reference is disabled and an external reference voltage must be applied to the REFIN/REFOUT pin.
36, 39	P	REGCAP	Decoupling Capacitor Pins for Voltage Output from 1.9 V Internal Regulator, Analog Low Dropout (ALDO) and Digital Low Dropout (DLDO). These output pins must be decoupled separately to AGND using a 1 $\mu\text{F}$ capacitor.
42	REF	REFIN/ REFOUT	Reference Input (REFIN)/Reference Output (REFOUT). The internal 2.5 V reference is available on the REFOUT pin for external use while the REF SELECT pin is set to logic high. Alternatively, by setting the REF SELECT pin to logic low, the internal reference is disabled and an external reference of 2.5 V must be applied to this input (REFIN). A 100 nF capacitor must be applied from the REFIN pin to ground, close to the REFGND pins, for both internal and external reference options. See the Reference section for more details.
43, 46	REF	REFGND	Reference Ground Pins. These pins must be connected to AGND.
44, 45	REF	REFCAPA, REFCAPB	Reference Buffer Output Force/Sense Pins. These pins must be connected together and decoupled to AGND using a low effective series resistance (ESR), 10 $\mu\text{F}$ ceramic capacitor. The voltage on these pins is typically 4.4 V.
49	AI	V1	Channel 1 Positive Analog Input Pin.
50	AI GND	V1GND	Channel 1 Negative Analog Input Pin.

Pin No.	Type <sup>1</sup>	Mnemonic	Description
51	AI	V2	Channel 2 Positive Analog Input Pin.
52	AI GND	V2GND	Channel 2 Negative Analog Input Pin.
53	AI	V3	Channel 3 Positive Analog Input Pin.
54	AI GND	V3GND	Channel 3 Negative Analog Input Pin.
55	AI	V4	Channel 4 Positive Analog Input Pin.
56	AI GND	V4GND	Channel 4 Negative Analog Input Pin.
57	AI	V5	Channel 5 Positive Analog Input Pin.
58	AI GND	V5GND	Channel 5 Negative Analog Input Pin.
59	AI	V6	Channel 6 Positive Analog Input Pin.
60	AI GND	V6GND	Channel 6 Negative Analog Input Pin.
61	AI	V7	Channel 7 Positive Analog Input Pin.
62	AI GND	V7GND	Channel 7 Negative Analog Input Pin.
63	AI	V8	Channel 8 Positive Analog Input Pin.
64	AI GND	V8GND	Channel 8 Negative Analog Input Pin.

<sup>1</sup> P is power supply, DI is digital input, DO is digital output, REF is reference input/output, AI is analog input, and GND is ground.

## TYPICAL PERFORMANCE CHARACTERISTICS

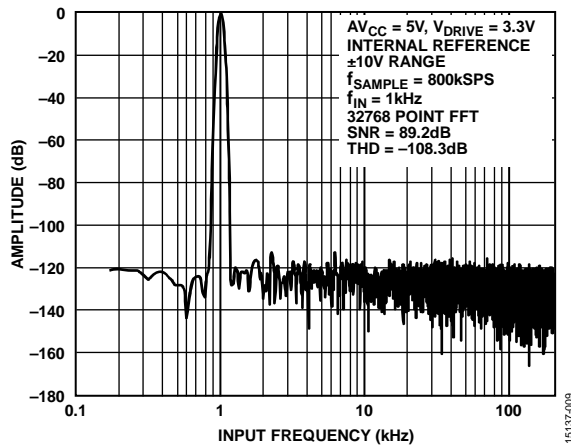
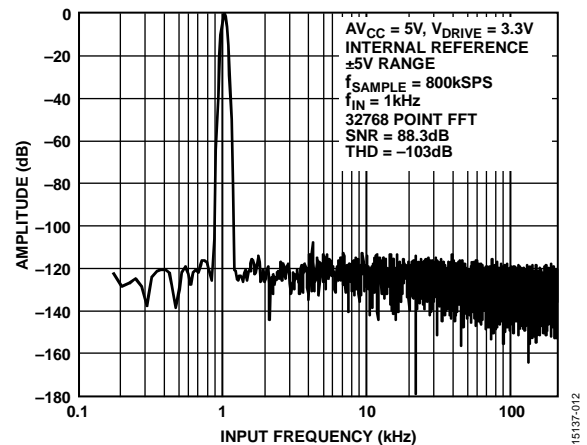
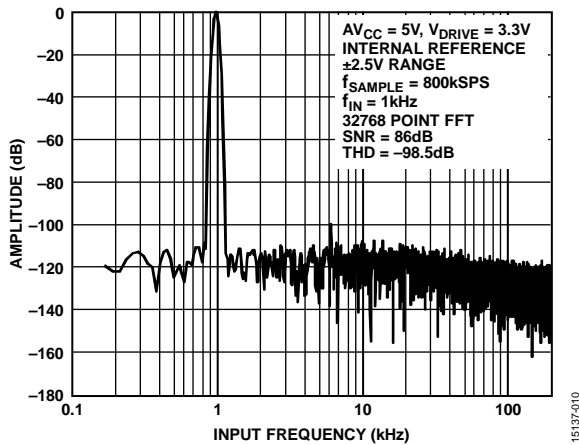
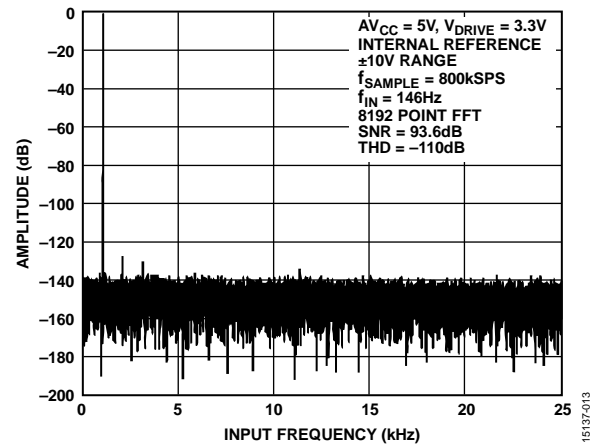
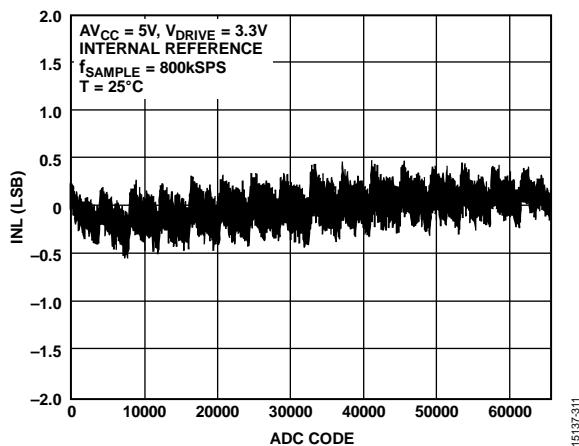
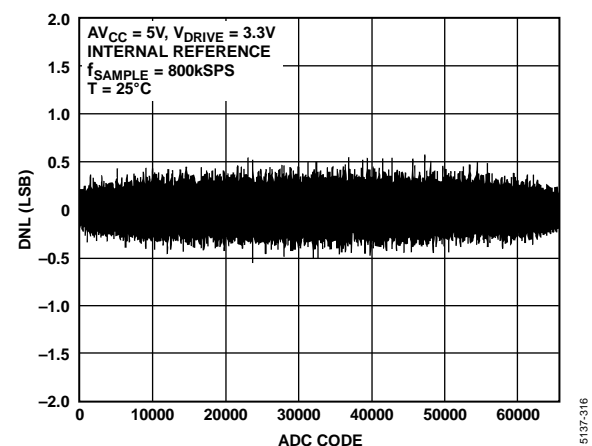
Figure 9. Fast Fourier Transform (FFT),  $\pm 10$  V RangeFigure 12. FFT,  $\pm 5$  V RangeFigure 10. FFT,  $\pm 2.5$  V RangeFigure 13. FFT Oversampling by 16,  $\pm 10$  V RangeFigure 11. Typical INL,  $\pm 10$  V Range

Figure 14. Typical DNL

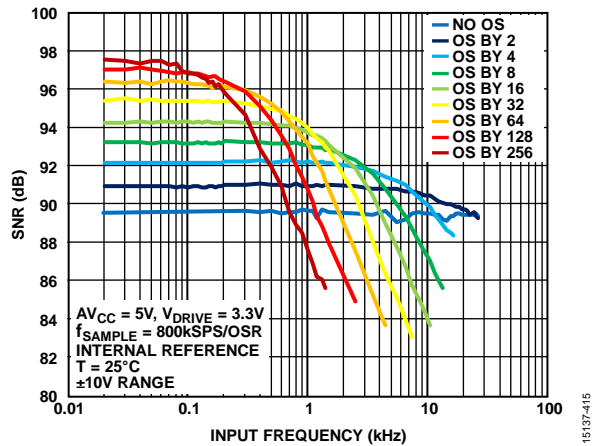


Figure 15. SNR vs. Input Frequency for Different OSR Values,  $\pm 10$  V Range, Internal OS Clock

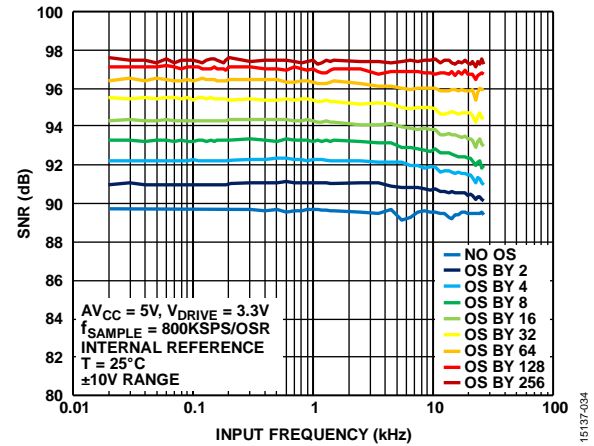


Figure 18. SNR vs. Input Frequency for Different OSR Values,  $\pm 10$  V Range, External OS Clock

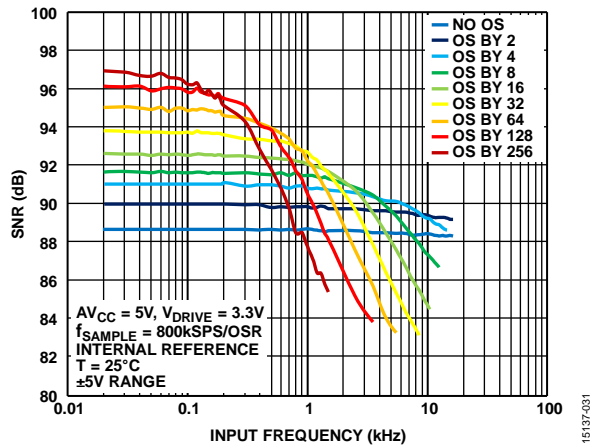


Figure 16. SNR vs. Input Frequency for Different OSR Values,  $\pm 5$  V Range, Internal OS Clock

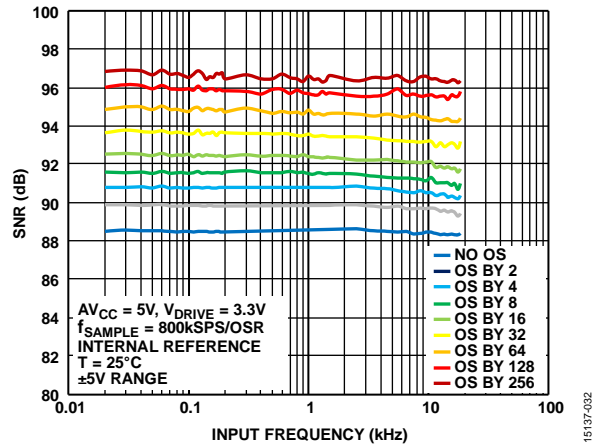


Figure 19. SNR vs. Input Frequency for Different OSR Values,  $\pm 5$  V Range, External OS Clock

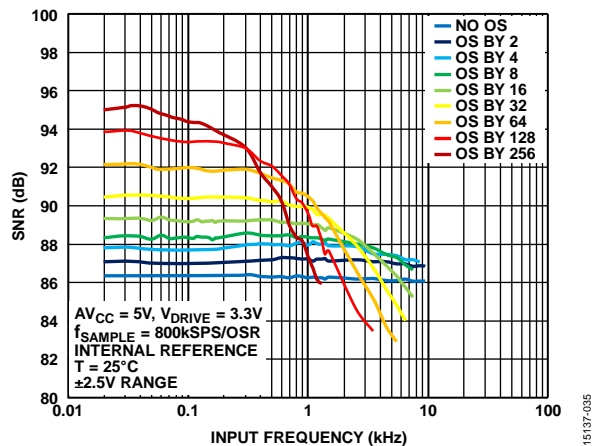


Figure 17. SNR vs. Input Frequency for Different OSR Values,  $\pm 2.5$  V Range, Internal OS Clock

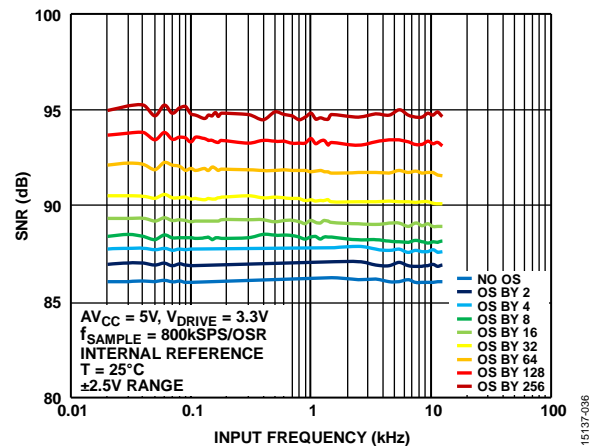


Figure 20. SNR vs. Input Frequency for Different OSR Values,  $\pm 2.5$  V Range, External OS Clock

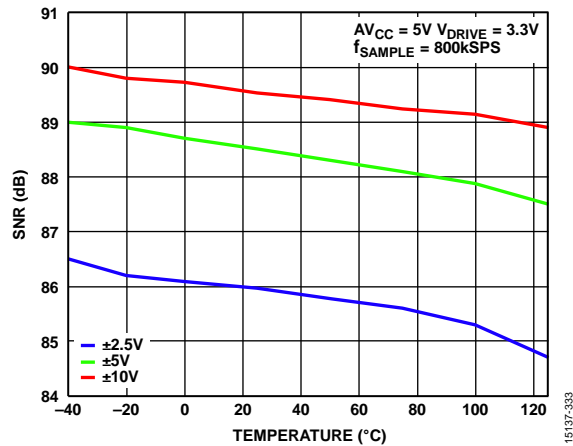


Figure 21. SNR vs. Temperature

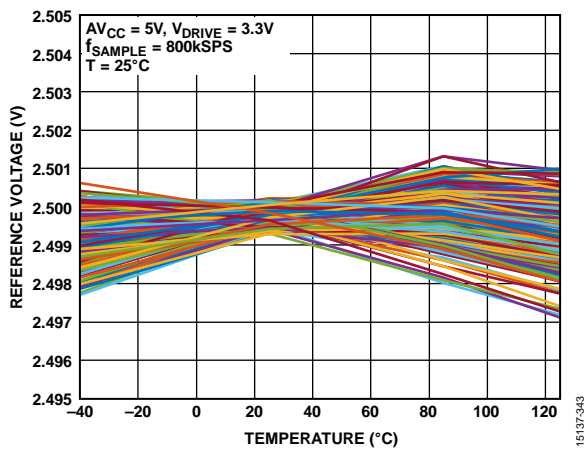


Figure 22. Reference Drift

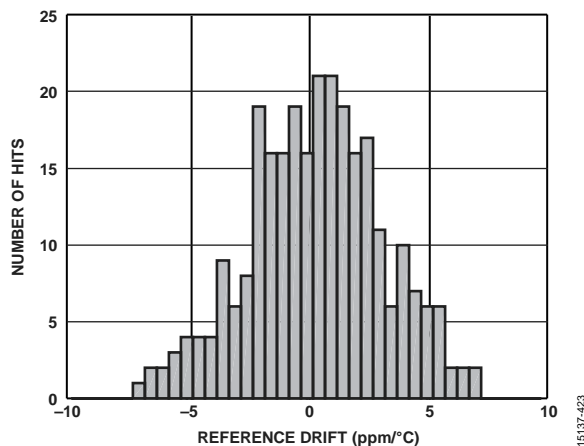


Figure 23. Reference Drift Histogram

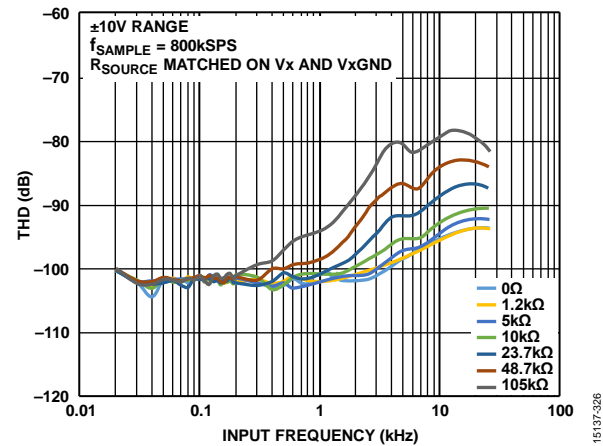


Figure 24. THD vs. Input Frequency for Various Source Impedances, ±10 V Range

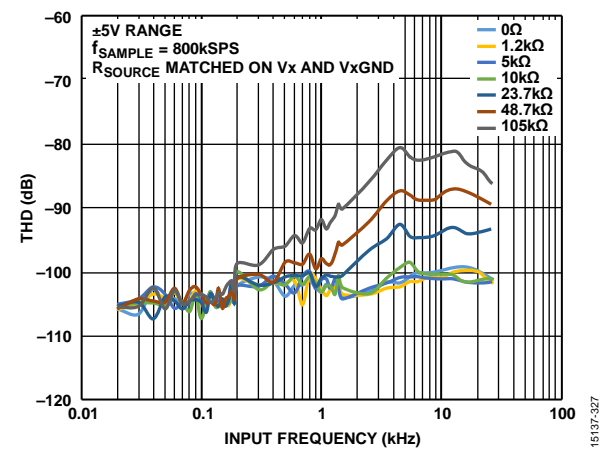


Figure 25. THD vs. Input Frequency for Various Source Impedances, ±5 V Range

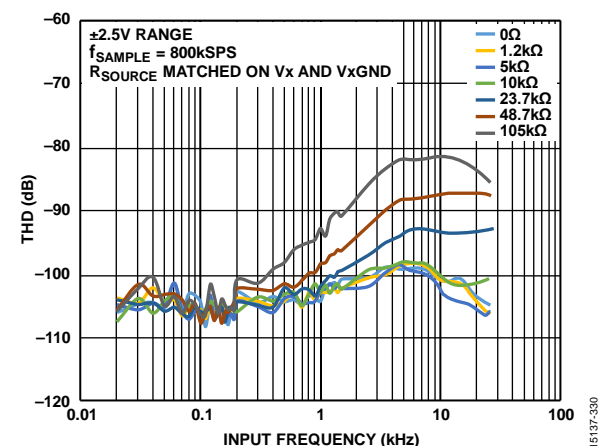


Figure 26. THD vs. Input Frequency for Various Source Impedances, ±2.5 V Range



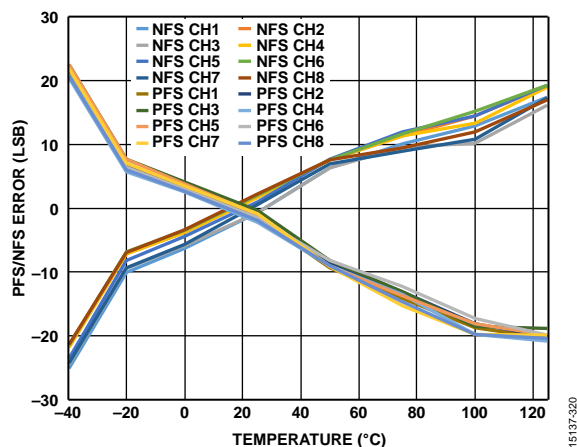


Figure 27. Positive Full-Scale(PFS)/Negative Full-Scale (NFS) Error vs. Temperature,  $\pm 10$  V Range

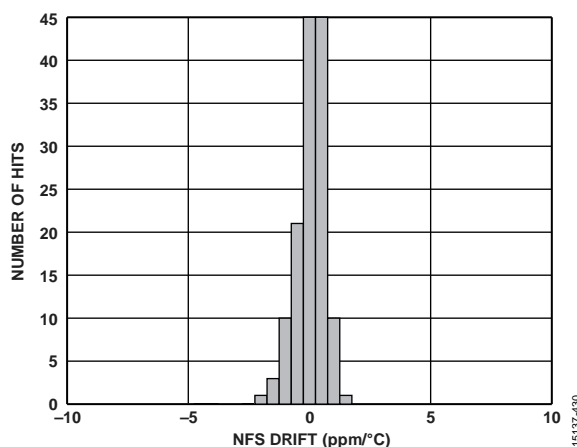


Figure 30. PFS/NFS Drift Histogram, External Reference

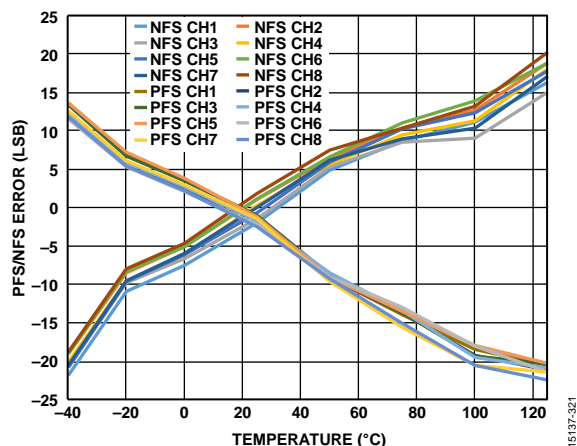


Figure 28. PFS/NFS Error vs. Temperature,  $\pm 5$  V Range

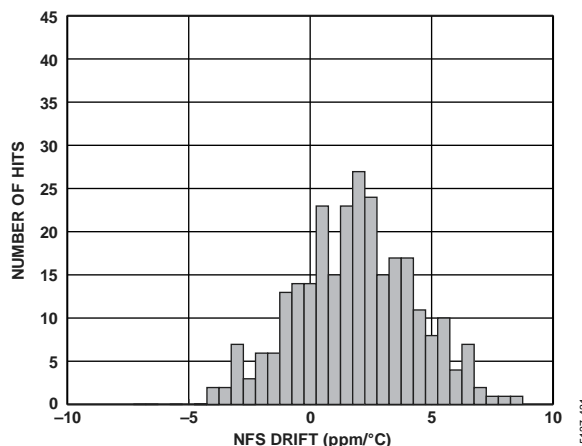


Figure 31. PFS/NFS Drift Histogram, Internal Reference

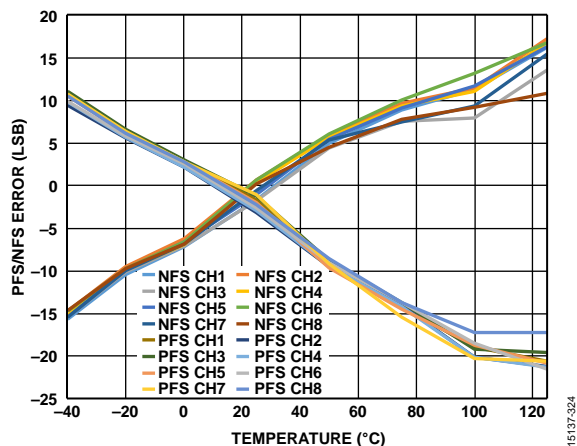


Figure 29. PFS/NFS Error vs. Temperature,  $\pm 2.5$  V Range

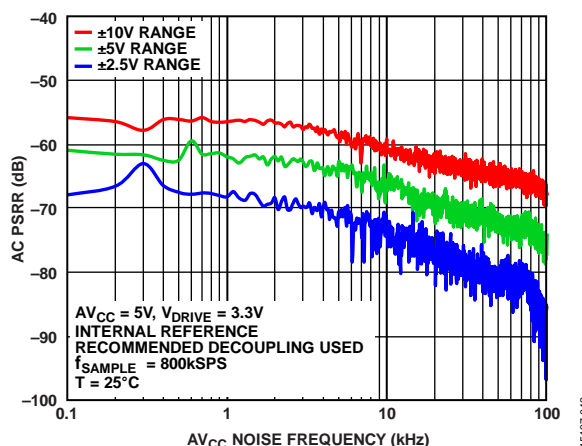
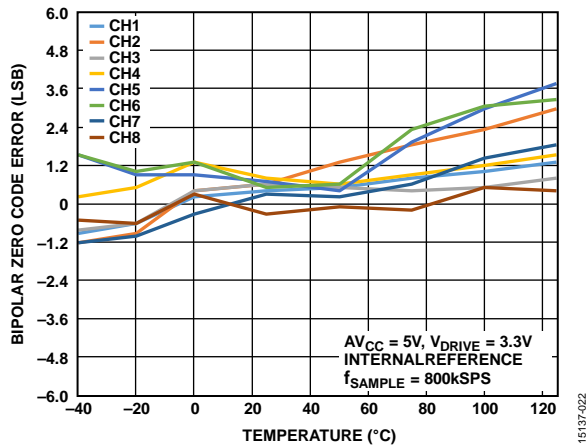
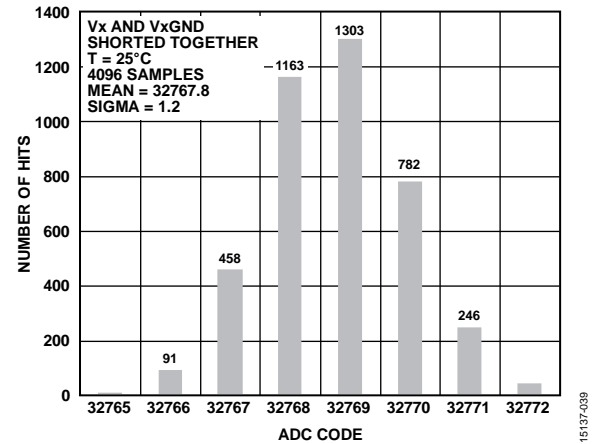
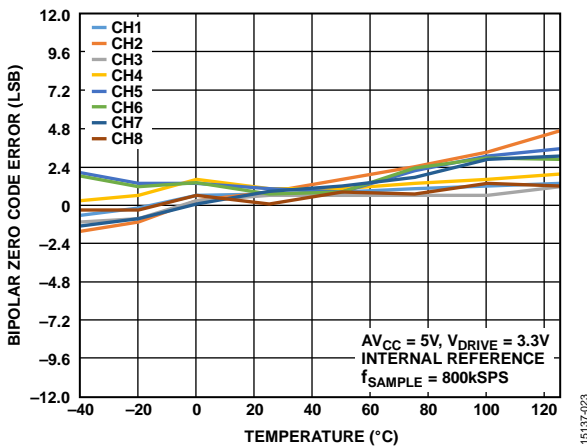
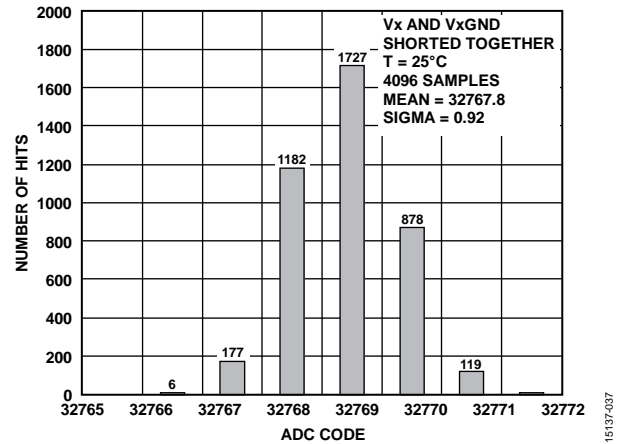
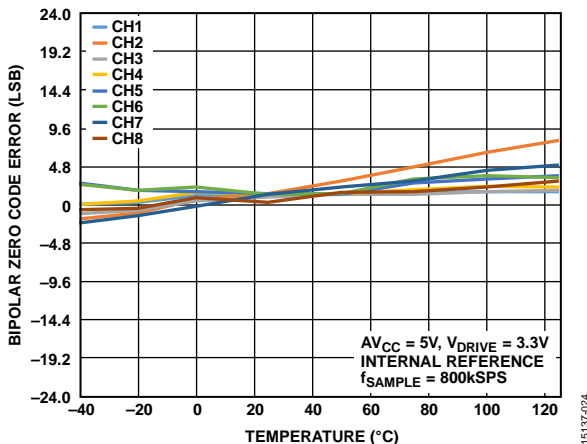
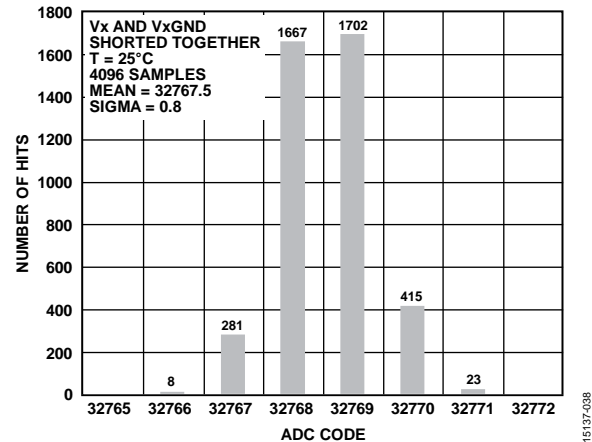


Figure 32. AC PSRR

Figure 33. Bipolar Zero Code Error vs. Temperature,  $\pm 10 V$  RangeFigure 36. Histogram of Codes,  $\pm 10 V$  RangeFigure 34. Bipolar Zero Code Error vs. Temperature,  $\pm 5 V$  RangeFigure 37. Histogram of Codes,  $\pm 5 V$  RangeFigure 35. Bipolar Zero Code Error vs. Temperature,  $\pm 2.5 V$  RangeFigure 38. Histogram of Codes,  $\pm 2.5 V$  Range

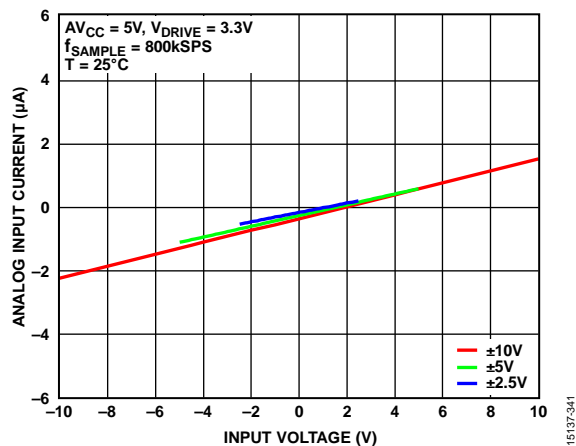


Figure 39. Analog Input Current vs. Input Voltage

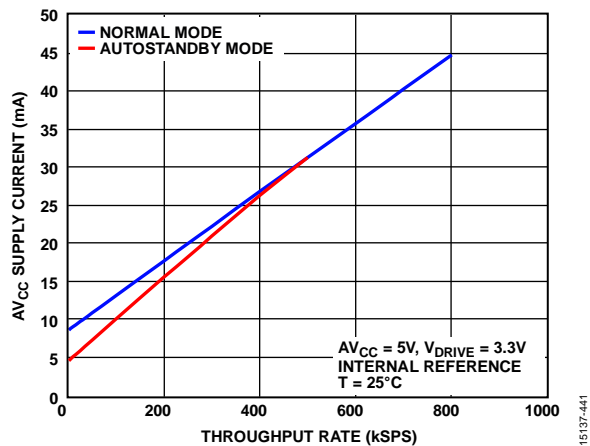
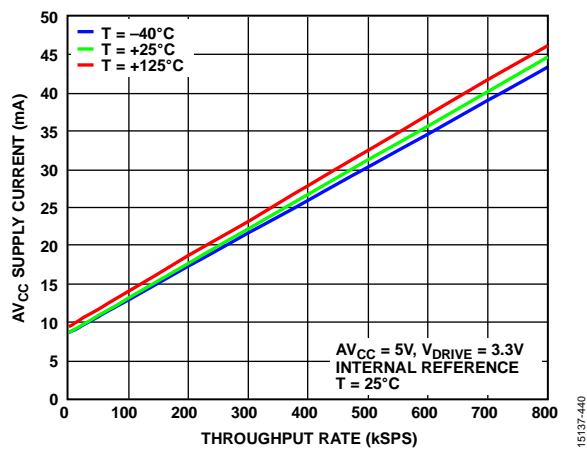
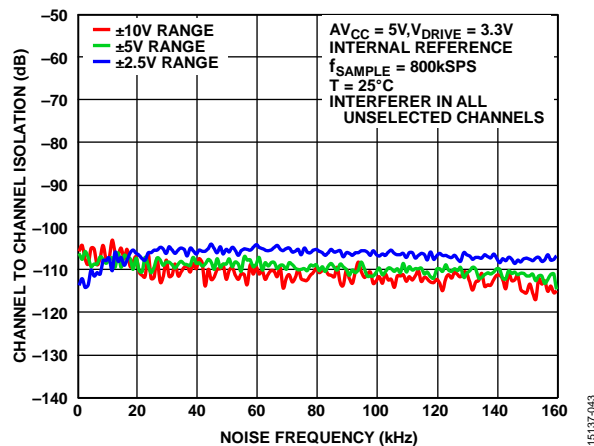
Figure 41.  $AV_{CC}$  Supply Current vs. Throughput RateFigure 40.  $AV_{CC}$  Supply Current vs. Throughput Rate

Figure 42. Channel to Channel Isolation vs. Noise Frequency

## TERMINOLOGY

### Integral Nonlinearity (INL)

INL is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are zero scale at ½ LSB below the first code transition and full scale at ½ LSB above the last code transition.

### Differential Nonlinearity (DNL)

DNL is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

### Bipolar Zero Code Error

Bipolar zero code error is the deviation of the midscale transition (all 1s to all 0s) from the ideal, which is 0 V – ½ LSB.

### Bipolar Zero Code Error Match

Bipolar zero code error match is the absolute difference in bipolar zero code error between any two input channels.

### Open Circuit Code Error

Open circuit code error is the ADC output code when there is an open circuit on the analog input, and a pull-down resistor ( $R_{PD}$ ) connected between the analog input pair of pins. See Figure 59 for more details.

### Positive Full-Scale (PFS) Error

PFS error is the deviation of the actual last code transition from the ideal last code transition (10 V – 1½ LSB (9.99954), 5 V – 1½ LSB (4.99977), and 2.5 V – 1½ LSB (2.49988)) after the bipolar zero code error is adjusted out. The positive full-scale error includes the contribution from the internal reference and reference buffer.

### Positive Full-Scale Error Match

PFS error match is the absolute difference in positive full-scale error between any two input channels.

### Negative Full-Scale (NFS) Error

NFS error is the deviation of the first code transition from the ideal first code transition (–10 V + ½ LSB (–9.99984), –5 V + ½ LSB (–4.99992), and –2.5 V + ½ LSB (–2.49996)) after the bipolar zero code error is adjusted out. The negative full-scale error includes the contribution from the internal reference and reference buffer.

### Negative Full-Scale Error Match

NFS error match is the absolute difference in negative full-scale error between any two input channels.

### Total Unadjusted Error (TUE)

TUE is the maximum deviation of the output code from the ideal. TUE includes INL errors, bipolar zero code and positive and negative full-scale errors, and reference errors.

### Signal-to-Noise-and-Distortion Ratio (SINAD)

SINAD ratio is the measured ratio of signal-to-noise-and-distortion at the output of the ADC. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ( $f_s/2$ , excluding dc).

The ratio depends on the number of quantization levels in the digitization process: the more levels, the smaller the quantization noise.

The theoretical SINAD for an ideal N-bit converter with a sine wave input is given by

$$SINAD = (6.02 N + 1.76) \text{ (dB)}$$

Thus, for a 16-bit converter, the SINAD is 98 dB.

### Total Harmonic Distortion (THD)

THD is the ratio of the rms sum of the harmonics to the fundamental. For the AD7606B, THD is defined as

$$THD \text{ (dB)} =$$

$$20 \log \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2 + V_6^2 + V_7^2 + V_8^2 + V_9^2}}{V_1}$$

where:

$V_1$  is the rms amplitude of the fundamental.

$V_2$  to  $V_9$  are the rms amplitudes of the second through ninth harmonics.

### Peak Harmonic or Spurious Noise

Peak harmonic or spurious noise is the ratio of the rms value of the next largest component in the ADC output spectrum (up to  $f_s/2$ , excluding dc) to the rms value of the fundamental. Normally, the value of this specification is determined by the largest harmonic in the spectrum, but for ADCs where the harmonics are buried in the noise floor, the value is determined by a noise peak.

### Power Supply Rejection Ratio (PSRR)

Variations in power supply affect the full-scale transition but not the linearity of the converter. The power supply rejection (PSR) is the maximum change in full-scale transition point due to a change in power supply voltage from the nominal value. The PSRR is defined as the ratio of the 100 mV p-p sine wave applied to the  $AV_{CC}$  supplies of the ADC frequency,  $f_s$ , to the power of the ADC output at that frequency,  $f_s$ .

$$PSRR \text{ (dB)} = 20 \log (0.1/Pf_s)$$

where:

$Pf_s$  is equal to the power at frequency,  $f_s$ , coupled on the  $AV_{CC}$  supply.

### Channel to Channel Isolation

Channel to channel isolation is a measure of the level of crosstalk between all input channels. It is measured by applying a full-scale sine wave signal, up to 160 kHz, to all unselected input channels and then determining the degree to which the signal attenuates in the selected channel with a 1 kHz sine wave signal applied (see Figure 42).

**Phase Delay**

Phase delay is a measure of the absolute time delay between when an input is sampled by the converter and when the result associated with that sample is available to be read back from the ADC, including delay induced by the analog front end of the device.

**Phase Delay Drift**

Phase delay drift is the change in phase delay per unit temperature across the entire operating temperature of the device.

**Phase Delay Matching**

Phase delay matching is the maximum phase delay seen between any simultaneously sampled pair.

## THEORY OF OPERATION

### ANALOG FRONT END

The AD7606B is a 16-bit, simultaneous sampling, analog-to-digital DAS with eight channels. Each channel contains analog input clamp protection, a PGA, a low-pass filter, and a 16-bit SAR ADC.

#### Analog Input Ranges

The AD7606B can handle true bipolar, single-ended input voltages. In hardware mode, the logic level on the RANGE pin determines either  $\pm 10$  V or  $\pm 5$  V as the analog input range of all analog input channels, as shown in Table 9.

A logic change on the RANGE pin has an immediate effect on the analog input range. However, there is typically a settling time of approximately 80  $\mu$ s in addition to the normal acquisition time requirement. Changing the RANGE pin during a conversion is not recommended for fast throughput rate applications.

In software mode, it is possible to configure an individual analog input range per channel using Address 0x03 through Address 0x06. The logic level on the RANGE pin is ignored in software mode.

**Table 9. Analog Input Range Selection**

Range (V)	Hardware Mode <sup>1</sup>	Software Mode <sup>2</sup>
$\pm 10$	RANGE pin high	Address 0x03 through Address 0x06
$\pm 5$	RANGE pin low	Address 0x03 through Address 0x06
$\pm 2.5$	Not applicable	Address 0x03 through Address 0x06

<sup>1</sup> The same analog input range,  $\pm 10$  V or  $\pm 5$  V, applies to all eight channels.

<sup>2</sup> The analog input range ( $\pm 10$  V,  $\pm 5$  V, or  $\pm 2.5$  V) is selected on a per channel basis using the memory map.

#### Analog Input Impedance

The analog input impedance of the AD7606B is typically 5 M $\Omega$ . This is a fixed input impedance that does not vary with the AD7606B sampling frequency. This high analog input impedance eliminates the need for a driver amplifier in front of the AD7606B, allowing direct connection to the source or sensor. Therefore, bipolar supplies can be removed from the signal chain.

#### Analog Input Clamp Protection

Figure 43 shows the analog input circuitry of the AD7606B. Each analog input of the AD7606B contains clamp protection circuitry. Despite single, 5 V supply operation, this analog input clamp protection allows an input overvoltage of up to  $\pm 21$  V.

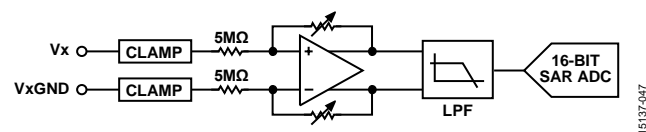


Figure 43. Analog Input Circuitry for Each Channel

Figure 44 shows the input clamp current vs. the source voltage characteristic of the clamp circuit. For input voltages of up to

$\pm 21$  V, no current flows in the clamp circuit. For input voltages that are above  $\pm 21$  V, the AD7606B clamp circuitry turns on.

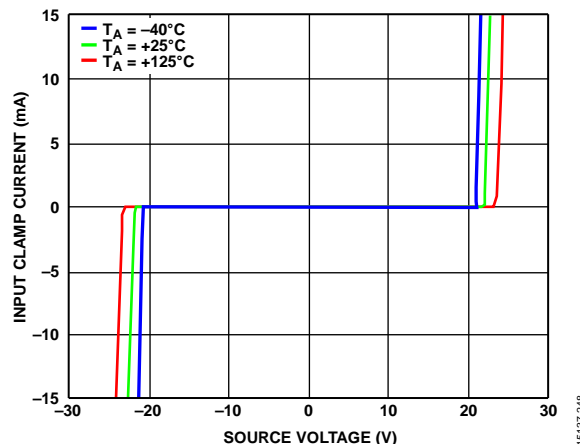


Figure 44. Input Protection Clamp Profile

It is recommended to place a series resistor on the analog input channels to limit the current to  $\pm 10$  mA for input voltages greater than  $\pm 21$  V. In an application where there is a series resistance (R) on an analog input channel, Vx, it is recommended to match the resistance (R) with the resistance on VxGND to eliminate any offset introduced to the system, as shown in Figure 45. However, in software mode, there is a per channel system offset calibration that removes the offset of the full system (see the System Offset Calibration section).

During normal operation, it is not recommended to leave the AD7606B in a condition where the analog input is greater than the input range for extended periods of time because this can degrade the bipolar zero code error performance. In shutdown or standby mode, there is no such concern.

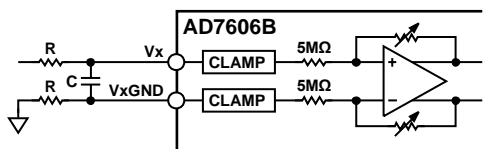


Figure 45. Input Resistance Matching on the Analog Input of the AD7606B

#### PGA

A PGA is provided at each input channel. The gain is configured depending on the analog input range selected (see Table 9) to scale the single-ended analog input signal to the ADC fully differential input range.

Input impedance on each input of the PGA is accurately trimmed to maintain the overall gain error. This trimmed value is then used when the gain calibration is enabled to compensate for the gain error introduced by an external series resistor. See the System Gain Calibration section for more information on the PGA feature.

### Analog Input Antialiasing Filter

An analog antialiasing filter is provided on the AD7606B. Figure 46 and Figure 47 show the frequency response and phase response, respectively, of the analog antialiasing filter. In the  $\pm 10$  V range, the  $-3$  dB frequency is typically 22.5 kHz.

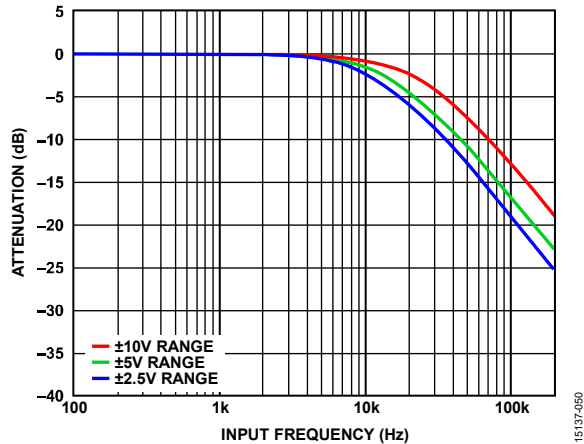


Figure 46. Analog Antialiasing Filter Frequency Response

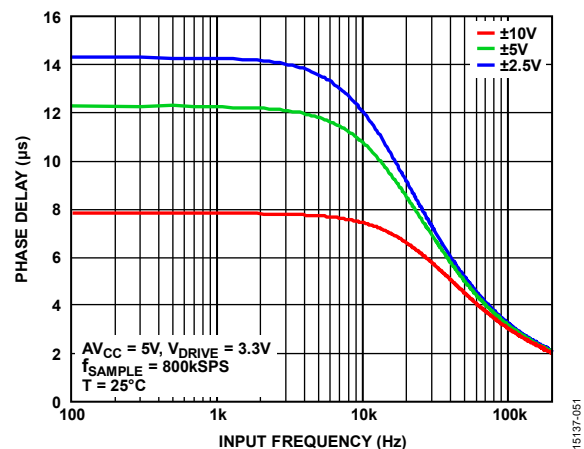


Figure 47. Analog Antialiasing Filter Phase Response

### SAR ADC

The AD7606B allows the ADC to accurately acquire an input signal of full-scale amplitude to 16-bit resolution. All eight SAR ADCs sample the respective inputs simultaneously on the rising edge of the CONVST signal.

The BUSY signal indicates when conversions are in progress. Therefore, when the rising edge of the CONVST signal is applied, the BUSY pin goes logic high and transitions low at the end of the entire conversion process. The end of the conversion process across all eight channels is indicated by the falling edge of the BUSY signal. When the BUSY signal edge falls, the acquisition time for the next set of conversions begins. The rising edge of the CONVST signal has no effect while the BUSY signal is high.

New data can be read from the output register via the parallel or serial interface after the BUSY output goes low. Alternatively, data from the previous conversion can be read while the BUSY pin is high, as explained in the Reading During Conversion section.

The AD7606B contains an on-chip oscillator that performs the conversions. The conversion time for all ADC channels is  $t_{CONV}$  (see Table 3). In software mode, there is an option to apply an external clock through the CONVST pin. Providing a low jitter external clock improves SNR performance for large oversampling ratios. See the Digital Filter section and Figure 15 to Figure 20 for further information.

Connect all unused analog input channels to AGND. The results for any unused channels are still included in the data read because all channels are always converted.

### ADC Transfer Function

The output coding of the AD7606B is twos complement. The designed code transitions occur midway between successive integer LSB values, that is,  $1/2$  LSB and  $3/2$  LSB. The LSB size is FSR/65,536 for the AD7606B. The ideal transfer characteristics for the AD7606B are shown in Figure 48. The LSB size is dependent on the analog input range selected, as shown in Table 10.

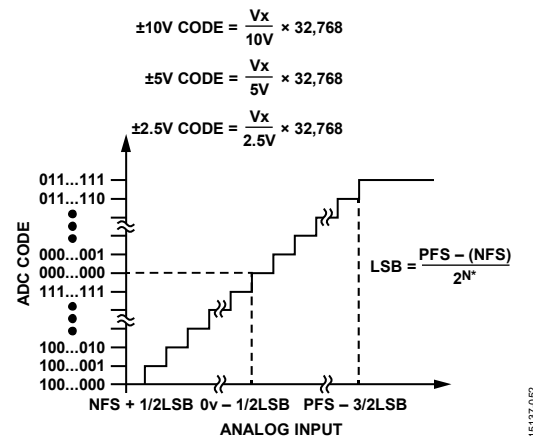


Figure 48. Ideal Transfer Characteristics

Table 10. Input Voltage Ranges

Range (V)	PFS (V)	Midscale (V)	NFS (V)	LSB ( $\mu$ V)
$\pm 10$	+10	0	-10	305
$\pm 5$	+5	0	-5	152
$\pm 2.5$	+2.5	0	-2.5	76

### REFERENCE

The AD7606B contains an on-chip, 2.5 V, band gap reference. The REFIN/REFOUT pin allows either

- Access to the internal 2.5 V reference, if the REF SELECT pin is tied to logic high.
- Application of an external reference of 2.5 V, if the REF SELECT pin is tied to logic low.

Table 11. Reference Configuration

REF SELECT Pin	Reference Selected
Logic High	Internal reference enabled
Logic Low	Internal reference disabled; an external 2.5 V reference voltage must be applied to the REFIN/REFOUT pin

The AD7606B contains a reference buffer configured to gain the reference voltage up to approximately 4.4 V, as shown in Figure 49. The 4.4 V buffered reference is the reference used by the SAR ADC, as shown in Figure 49. After a reset, the AD7606B operates in the reference mode selected by the REF SELECT pin. The REFCAPA and REFCAPB pins must be shorted together externally, and a ceramic capacitor of 10  $\mu$ F must be applied to the REFGND pin to ensure that the reference buffer is in closed-loop operation. A 10  $\mu$ F ceramic capacitor is required on the REFIN/REFOUT pin.

When the AD7606B is configured in external reference mode, the REFIN/REFOUT pin is a high input impedance pin.

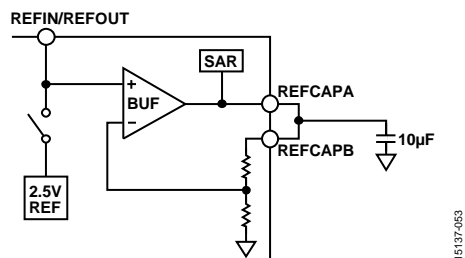


Figure 49. Reference Circuitry

### Using Multiple AD7606B Devices

For applications using multiple AD7606B devices, the following configurations are recommended, depending on the application requirements.

#### External Reference Mode

One external reference can drive the REFIN/REFOUT pins of all AD7606B devices (see Figure 50). In this configuration, decouple each REFIN/REFOUT pin of the AD7606B with at least a 100 nF decoupling capacitor.

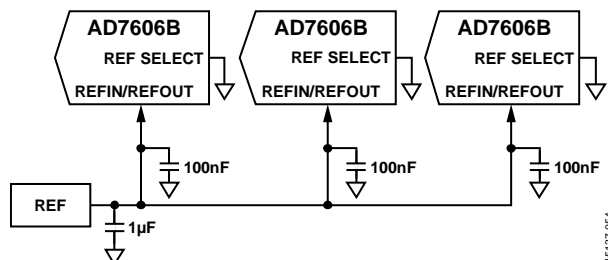


Figure 50. Single External Reference Driving Multiple AD7606B REFIN/REFOUT Pins

#### Internal Reference Mode

One AD7606B device, configured to operate in internal reference mode, can drive the remaining AD7606B devices, which are configured to operate in external reference mode (see Figure 51). Decouple the REFIN/REFOUT pin of the AD7606B, configured in internal reference mode, using a 10  $\mu$ F ceramic decoupling capacitor. The other AD7606B devices, configured in external reference mode, must use at least a 100 nF decoupling capacitor on their REFIN/REFOUT pins.

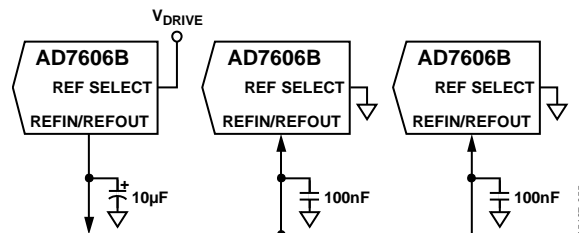


Figure 51. Internal Reference Driving Multiple AD7606B REFIN/REFOUT Pins

### OPERATION MODES

The AD7606B can be operated in hardware or software mode by controlling the OSx pins (Pin 3, Pin 4, and Pin 5), described in Table 12.

In hardware mode, the AD7606B is configured depending on the logic level on the RANGE, OSx, or  $\overline{\text{STBY}}$  pins.

In software mode, that is, when all three OSx pins are connected to logic high level, the AD7606B is configured by the corresponding registers accessed via the serial or parallel interface. Additional features are available, as described in Table 13.

The reference and the data interface is selected using the REF SELECT and PAR/SER SEL pins, in both hardware and software modes.

Table 12. Oversampling Pin Decoding

OSx Pins	AD7606B
000	No OS
001	2
010	4
011	8
100	16
101	32
110	64
111	Enters software mode



Table 13. Functionality Matrix

Parameter	Hardware Mode	Software Mode
Analog Input Range <sup>1</sup>	$\pm 10\text{ V}$ or $\pm 5\text{ V}$ <sup>2</sup>	$\pm 10\text{ V}$ , $\pm 5\text{ V}$ , or $\pm 2.5\text{ V}$ <sup>3</sup>
System Gain, Phase, and Offset Calibration	Not accessible	Available <sup>3</sup>
OSR	From no OS to OSR = 64	From no OS to OSR = 256
Analog Input Open Circuit Detection	Not accessible	Available <sup>3</sup>
Serial Data Output Lines	2	Selectable: 1, 2, or 4
Diagnostics	Not accessible	Available
Power-Down Modes	Standby and shutdown	Standby, shutdown, and autostandby

<sup>1</sup> See Table 9 for the analog input range selection.<sup>2</sup> Same input range configured in all input channels.<sup>3</sup> On a per channel basis.

### Reset Functionality

The AD7606B has two reset modes: full or partial. The reset mode selected is dependent on the length of the reset high pulse. A partial reset requires the RESET pin to be held high between 55 ns and 2  $\mu$ s. After 50 ns from the release of the RESET pin ( $t_{\text{DEVICE\_SETUP}}$ , partial reset), the device is fully functional and a conversion can be initiated. A full reset requires the RESET pin to be held high for a minimum of 3  $\mu$ s. After 253  $\mu$ s ( $t_{\text{DEVICE\_SETUP}}$ , full reset) from the release of the RESET pin, the device is completely reconfigured and a conversion can be initiated.

A partial reset reinitializes the following modules:

- Digital filter.
- SPI and parallel, resetting to ADC mode.
- SAR ADCs.
- CRC logic.

After the partial reset, the RESET\_DETECT bit of the status register asserts (Address 0x01, Bit 7). The current conversion result is discarded after the completion of a partial reset. The partial reset does not affect the register values programmed in software mode or the latches that store the user configuration in both hardware and software modes.

A full reset returns the device to the default power-on state, the RESET\_DETECT bit of the status register asserts (Address 0x01, Bit 7), and the current conversion result is discarded. The following features, in addition to those listed previously, are configured when the AD7606B is released from full reset:

- Hardware mode or software mode.
- Interface type (serial or parallel).

### Power-Down Modes

In hardware mode, two power-down modes are available on the AD7606B: standby mode and shutdown mode. The  $\overline{\text{STBY}}$  pin controls whether the AD7606B is in normal mode or in one of the two power-down modes, as shown in Table 14. If the  $\overline{\text{STBY}}$  pin is low, the power-down mode is selected by the state of the RANGE pin.

**Table 14. Power-Down Mode Selection, Hardware Mode**

Power Mode	$\overline{\text{STBY}}$ Pin	RANGE Pin
Normal Mode	1	X <sup>1</sup>
Standby	0	1
Shutdown	0	0

<sup>1</sup> X = don't care.

In software mode, the power-down mode is selected through the OPERATION\_MODE bits on the CONFIG register (Address 0x02, Bits[1:0]) within the memory map. There is an extra power-down mode available in software mode called autostandby mode.

**Table 15. Power-Down Mode Selection, Software Mode, Through CONFIG Register (Address 0x02)**

Operation Mode	Address 0x02, Bit 1	Address 0x02, Bit 0
Normal	0	0
Standby	0	1
Autostandby	1	0
Shutdown	1	1

When the AD7606B is placed in shutdown mode, all circuitry is powered down and the current consumption reduces to 5  $\mu$ A, maximum. The power-up time is approximately 10 ms. When the AD7606B is powered up from shutdown mode, a full reset must be applied to the AD7606B after the required power-up time elapses.

When the AD7606B is placed in standby mode, all the PGAs and all the SAR ADCs enter a low power mode, such that the overall current consumption reduces to 4.5 mA, maximum. No reset is required after exiting standby mode.

When the AD7606B is placed in autostandby mode, available only in software mode the device automatically enters standby mode on the BUSY signal falling edge. The AD7606B exits standby mode automatically on the CONVST signal rising edge. Therefore, the CONVST signal low pulse time is longer than  $t_{\text{WAKE\_UP}}$  (standby mode) = 1  $\mu$ s.

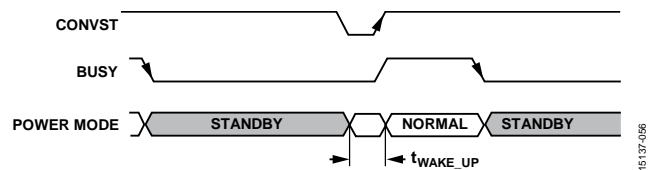


Figure 52. Autostandby Mode Operation

## DIGITAL FILTER

The AD7606B contains an optional digital averaging filter that can be enabled in slower throughput rate applications that require higher SNR or dynamic range.

In hardware mode, the oversampling ratio of the digital filter is controlled using the oversampling pins, OSx, as shown in Table 12. The OSx pins are latched on the falling edge of the BUSY signal.

In software mode, that is, if all OSx pins are tied to logic high, the oversampling ratio is selected through the oversampling register (Address 0x08). Two additional oversampling ratios ( $OS \times 128$  and  $OS \times 256$ ) are available in software mode.

In oversampling mode, the ADC takes the first sample for each channel on the rising edge of the CONVST signal. After converting the first sample, the subsequent samples are taken by the internally generated sampling signal, as shown in Figure 53. Alternatively, this sampling signal can be applied externally as described in the External Oversampling Clock section.

For example, if oversampling by eight is configured, eight samples are taken, averaged, and the result is provided on the output. A CONVST signal rising edge triggers the first sample, and the remaining seven samples are taken with an internally generated sampling signal. Consequently, turning on the

averaging of multiple samples leads to an improvement in SNR performance, at the expense of reducing the maximum throughput rate. When the oversampling function is turned on, the BUSY signal high time ( $t_{CONV}$ ) extends, as shown in Table 3. Table 16 shows the trade-off in SNR vs. bandwidth and throughput for the  $\pm 10$  V,  $\pm 5$  V, and  $\pm 2.5$  V ranges.

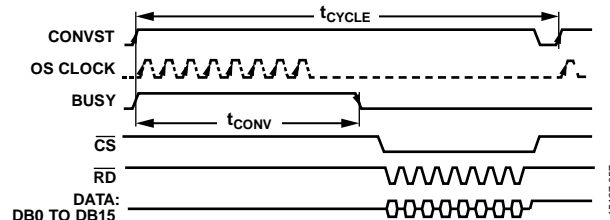


Figure 53. Oversampling by 8 Example, Read After Conversion, Parallel Interface, OS Clock Internally Generated Sampling Signal

Figure 53 shows that the conversion time ( $t_{CONV}$ ) extends when oversampling is turned on. The throughput rate ( $1/t_{CYCLE}$ ) must be reduced to accommodate the longer conversion time and to allow the read operation to occur. To achieve the fastest throughput rate possible when oversampling is turned on, the read can be performed during the BUSY signal high time as explained in the Reading During Conversion section.

Table 16. Oversampling Performance

OS Ratio	Input Frequency (Hz)	$\pm 10$ V Range		$\pm 5$ V Range		$\pm 2.5$ V Range		Maximum Throughput (kSPS)
		SNR (dB)	3 dB BW (kHz)	SNR (dB)	3 dB BW (kHz)	SNR (dB)	3 dB BW (kHz)	
No OS	1000	89.5	23.0	88.5	13.9	86	11.6	800
2	1000	91	22.7	89.9	13.8	87.2	11.5	400
4	1000	92.2	22.0	90.8	13.6	88	11.4	200
8	1000	93	20.0	91.5	13.0	88.4	11.1	100
16	1000	93.5	15.4	92	11.4	89	10.0	50
32	130	95.4	9.7	93.7	8.4	90.4	7.7	25
64	130	96.3	5.3	95	5.0	91.8	4.9	12.5
128 <sup>1</sup>	50	97.1	2.7	95.9	2.7	93.3	2.7	6.25
256 <sup>1</sup>	50	97.6	1.4	96.8	1.4	94.7	1.4	3.125

<sup>1</sup> Only available in software mode.

## PADDING OVERSAMPLING

As shown in Figure 53, an internally generated clock triggers the samples to be averaged, and then the ADC remains idle until the following CONVST signal rising edge. In software mode, through the oversampling register (Address 0x08), the internal clock (OS clock) frequency can be changed such that idle time is minimized, that is sampling instants are equally spaced, as shown in Figure 54.

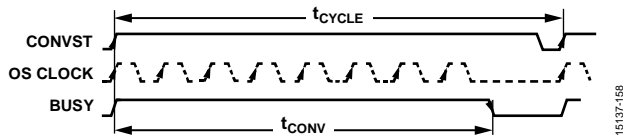


Figure 54. Oversampling by 8 Example, Oversampling Padding Enabled

Table 17. OS\_PAD Bit Decoding

OS_PAD (Address 0x08, Bits[7:5])	OS Clock Frequency (kHz)
0000	800
0001	753
0010	711
0011	673.5
0100	640
0101	609.5
0110	582
0111	556.5
1000	533
1001	512
1010	492.5
1011	474
1100	457
1101	441.5
1110	426.5
1111	413

## EXTERNAL OVERSAMPLING CLOCK

In software mode, there is an option to apply an external clock through the CONVST pin when oversampling mode is enabled. Providing a low jitter external clock improves SNR performance for large oversampling ratios. By applying an external clock, the input is sampled at regular time intervals, which is optimum for antialiasing performance.

To enable the external oversampling clock, Bit 5 in the CONFIG register (Address 0x02, Bit 5) must be set. Then, the throughput rate is

$$\text{Throughput} = \frac{1}{t_{\text{CONVST}} \times \text{OSR}}$$

That is, the sampling signal is provided externally through the CONVST pin, and every OSR number of clocks, an output is averaged and provided, as shown in Figure 55. This feature is available using either the parallel interface or the serial interface.

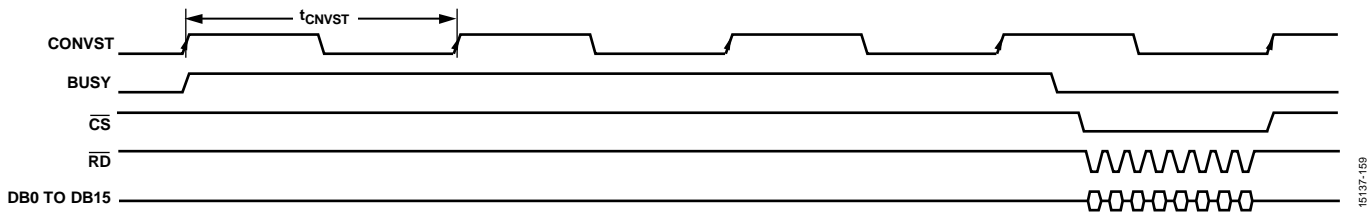


Figure 55. External Oversampling Clock Applied on the CONVST Pin (OSR = 4); Parallel Interface

## SYSTEM CALIBRATION FEATURES

The following system calibration features are available in software mode by writing to corresponding registers in the memory map:

- Phase calibration.
- Gain calibration.
- Offset calibration.
- Analog Input open circuit detection.

### SYSTEM PHASE CALIBRATION

When using an external filter, as shown in Figure 57, any mismatch on the discrete components, or in the sensor used, can cause phase mismatch between channels. This phase mismatch can be compensated for in software mode, on a per channel basis, by delaying the sampling instant on individual channels.

The sampling instant on any particular channel can be delayed with regard to the CONVST signal rising edge, with a resolution of 1.25  $\mu$ s, and up to 318.75  $\mu$ s, by writing to the corresponding CHx\_PHASE register (Address 0x19 through Address 0x20).

For example, if the CH4\_PHASE register (Address 0x1C) is written with 10d, Channel 4 is effectively sampled 12.5  $\mu$ s ( $t_{\text{PHASE\_REG}}$ ) after the CONVST signal rising edge, as shown in Figure 56.

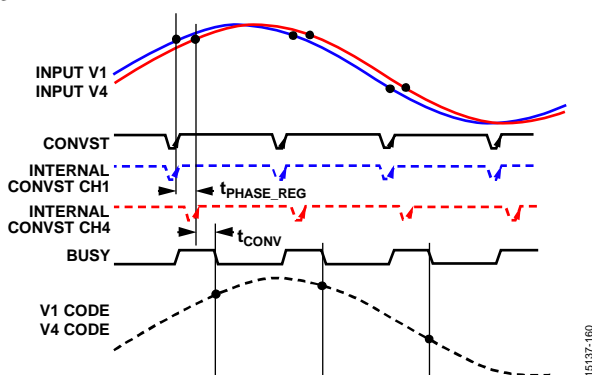


Figure 56. System Phase Calibration Functionality

The BUSY signal high time equals  $t_{\text{CONV}}$  plus  $t_{\text{PHASE\_REG}}$ , as shown in Figure 56. In the previously explained example and Figure 56, if only CH4\_PHASE\_REGISTER is programmed,  $t_{\text{CONV}}$  increases by 12.5  $\mu$ s. Therefore, this scenario must be taken into account when running at higher throughput rates.

### SYSTEM GAIN CALIBRATION

Using an external  $R_{\text{FILTER}}$ , as shown in Figure 57, generates a system gain error. This gain error can be compensated for in software mode, on a per channel basis, by writing the series resistor value used on the corresponding register, Address 0x09 through Address 0x10. These registers can compensate up to 65 k $\Omega$  series resistors, with a resolution of 1024  $\Omega$ .

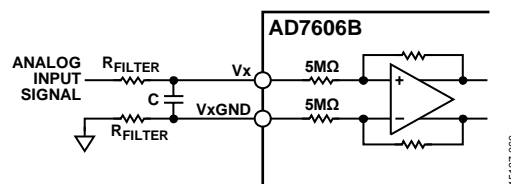


Figure 57. System Gain Error

For example, if a 27 k $\Omega$  resistor is placed in series to the analog input of Channel 5, the resistor generates –170 LSB positive full-scale error on the system (at  $\pm 10$  V range), as shown in Figure 58. In software mode, this error is eliminated by writing 27d to the CH5\_GAIN register (Address 0x0D).

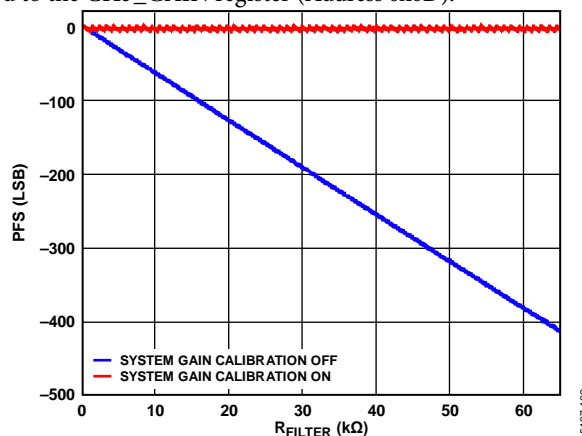


Figure 58. System Gain Calibration with and Without Calibration

### SYSTEM OFFSET CALIBRATION

A potential offset on the sensor, or any offset caused by a mismatch between the  $R_{\text{FILTER}}$  pair placed on a particular channel (as described in the Analog Front End section), can be compensated in software mode, on a per channel basis. The CHx\_OFFSET registers (Address 0x11 through Address 0x18) allow the ability to add or subtract up to 128 LSB from the ADC code automatically, with a resolution of 1 LSB, as shown in Table 18.

For example, if the signal connected to Channel 3 has a 9 mV offset, and the analog input range is set to the  $\pm 10$  V range (where LSB size = 305  $\mu$ V) to compensate for this offset, program –30 LSB to the corresponding register. Writing 128d – 30d = 0x80 – 0x1E = 0x62 to the CH3\_OFFSET register (Address 0x13) removes such offset.

Table 18. CHx\_OFFSET Register Bit Decoding

CHx_OFFSET Register	Offset Calibration (LSB)
0x00	–128
0x45	–59
0x80 (Default)	0
0x83	+3
0xFF	+127

## ANALOG INPUT OPEN CIRCUIT DETECTION

The AD7606B has an analog input open circuit detection feature available in software mode. To use this feature,  $R_{PD}$  must be placed as shown in Figure 59. If the analog input is disconnected, for example, if a switch opens in Figure 59, the source impedance changes from  $R_S$  to  $R_{PD}$ , as long as  $R_S < R_{PD}$ . It is recommended to use  $R_{PD} = 50\text{ k}\Omega$  so that the AD7606B can detect changes in the source impedance by internally switching the PGA common-mode voltage. Analog input open circuit detection operates in manual mode or in automatic mode.

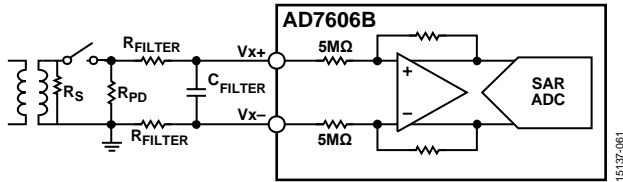


Figure 59. Analog Front End with  $R_{PD}$

### Manual Mode

In manual mode, enabled by writing 0x01 to OPEN\_DETECT\_QUEUE (Address 0x2C), each PGA common-mode voltage is controlled by the corresponding CHx\_OPEN\_DETECT\_EN bit on the OPEN\_DETECT\_ENABLE register (Address 0x23). Setting this bit high shifts up the PGA common-mode voltage. If there is an open circuit on the analog input, the ADC output changes proportionally to the  $R_{PD}$  resistor, as shown in Figure 60. If there is not an open circuit, any change on the PGA common-mode voltage has no effect on the ADC output.

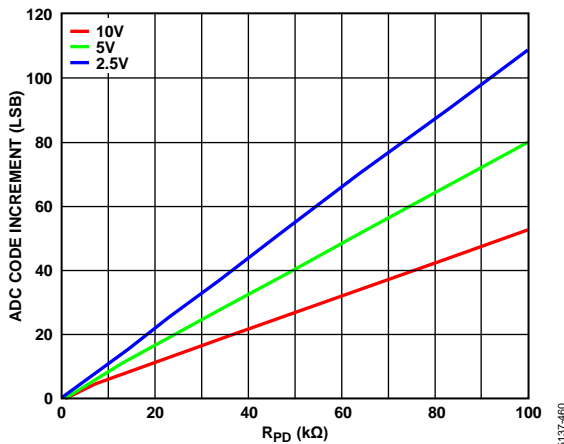


Figure 60. Open Circuit Code Error Increment, Dependent of  $R_{PD}$

### Automatic Mode

Automatic mode is enabled by writing any value greater than 0x01 to the OPEN\_DETECT\_QUEUE register (Address 0x2C), as shown in Table 19. If the AD7606B detects that the ADC reported a number (specified in the OPEN\_DETECT\_QUEUE register) of consecutive unchanged conversions, the analog input open circuit detection algorithm is performed internally and automatically. The analog input open circuit detection algorithm automatically

changes the PGA common-mode voltage, checks the ADC output, and returns to the initial common-mode voltage, as shown in Figure 61. If the ADC code changes in any channel with the PGA common-mode change, this implies that there is no input signal connected to that analog input, and the corresponding flag asserts within the OPEN\_DETECTED register (Address 0x24). Each channel can be individually enabled or disabled through the OPEN\_DETECT\_ENABLE register (Address 0x23).

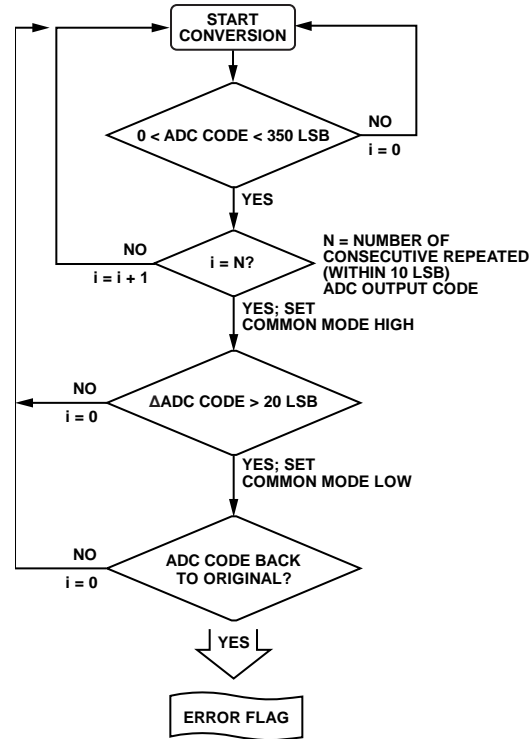


Figure 61. Automatic Analog Input Open Circuit Detect Flowchart

If no oversampling is used, the recommended minimum number of conversions to be programmed for the AD7606B to automatically detect an open circuit on the analog input is

$$\text{OPEN\_DETECT\_QUEUE} = 10 \times f_{\text{SAMPLE}} (R_{PD} + 2 \times R_{\text{FILTER}}) \times C_{\text{FILTER}}$$

However, when oversampling mode is enabled, the recommended minimum number of conversions to use is

$$\text{OPEN\_DETECT\_QUEUE} = 1 + (f_{\text{SAMPLE}} \times 2 (R_{PD} + 2 \times R_{\text{FILTER}}) \times C_{\text{FILTER}} \times \text{OSR})$$

Table 19. Analog Input Open Circuit Detect Mode Selection and Register Functionality

<b>OPEN_DETECT_QUEUE (Address 0x2C)</b>	<b>Open Detect Mode</b>	<b>OPEN_DETECT_ENABLE (Address 0x23)</b>
0x00 (Default)	Disabled	Not applicable
0x01	Manual mode	Sets common-mode voltage high or low, on a per channel basis
0x02 to 0xFF	Automatic; OPEN_DETECT_QUEUE is the number of consecutive conversions before asserting any CHx_OPENED flag	Enables or disables automatic analog input open circuit detection on a per channel basis

## DIGITAL INTERFACE

The AD7606B provides two interface options: a parallel interface and a high speed serial interface. The required interface mode is selected via the  $\overline{\text{PAR/SER SEL}}$  pin.

**Table 20. Interface Mode Selection**

$\overline{\text{PAR/SER SEL}}$	Interface Mode
0	Parallel interface mode
1	Serial interface mode

Operation of the interface modes is discussed in the following sections.

### HARDWARE MODE

In hardware mode, only ADC mode is available. ADC data can be read from the AD7606B via the parallel data bus with standard  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  signals or via the serial interface with standard  $\overline{\text{CS}}$ ,  $\text{SCLK}$ , and two  $\text{D}_{\text{OUTX}}$  signals.

See the Reading Conversion Results (Parallel ADC Mode) section and the Reading Conversion Results (Serial ADC Mode) section for more details on how ADC read mode operates.

### SOFTWARE MODE

In software mode, which is active only when all three oversampling pins are tied high, both ADC read mode and register mode are available. ADC data can be read from the AD7606B, and registers can also be read from and written to the AD7606B via the parallel data bus with standard  $\overline{\text{CS}}$ ,  $\overline{\text{RD}}$ , and  $\overline{\text{WR}}$  signals or via the serial interface with standard  $\overline{\text{CS}}$ ,  $\text{SCLK}$ ,  $\text{SDI}$ , and  $\text{D}_{\text{OUTA}}$  lines.

See the Parallel Register Mode (Writing Register Data) section and the Parallel Register Mode (Reading Register Data) section for more details on how register mode operates.

Pin functions differ depending on the interface selected (parallel or serial) and the operation mode (hardware or software), as shown in Table 21 and Table 22.

**Table 21. Data Interface Pin Function per Mode of Operation (Parallel Interface)**

Pin Name	Pin No.	Hardware Mode	Software Mode	
			ADC Mode	Register Mode
DB0 to DB6	16 to 22	DB0 to DB6		Register data
DB7/ $\text{D}_{\text{OUTA}}$	24	DB7		Register data (MSB)
DB8/ $\text{D}_{\text{OUTB}}$	25	DB8		ADD0
DB9/ $\text{D}_{\text{OUTC}}$	27	DB9		ADD1
DB10/ $\text{D}_{\text{OUTD}}$	28	DB10		ADD2
DB11/ $\text{SDI}$	29	DB11		ADD3
DB12 to DB14	30 to 32	DB12 to DB14		ADD4 to ADD6
DB15	33	DB15		R/W

**Table 22. Data Interface Pin Function per Mode of Operation (Serial Interface)**

Pin Name	Pin No.	Hardware Mode	Software Mode	
			ADC Mode	Register Mode
DB0 to DB6	16 to 22	N/A <sup>1</sup>		N/A
DB7/ $\text{D}_{\text{OUTA}}$	24	$\text{D}_{\text{OUTA}}$	$\text{D}_{\text{OUTA}}$	$\text{D}_{\text{OUTA}}$
DB8/ $\text{D}_{\text{OUTB}}$	25	$\text{D}_{\text{OUTB}}$	$\text{D}_{\text{OUTB}}$ <sup>2</sup>	Unused
DB9/ $\text{D}_{\text{OUTC}}$	27	N/A	$\text{D}_{\text{OUTC}}$ <sup>3</sup>	Unused
DB10/ $\text{D}_{\text{OUTD}}$	28		$\text{D}_{\text{OUTD}}$ <sup>3</sup>	Unused
DB11/ $\text{SDI}$	29		Unused	$\text{SDI}$
DB12 to DB14	30 to 32			N/A
DB15	33			

<sup>1</sup> N/A means not applicable. Tie all N/A pins to AGND.

<sup>2</sup> Only used if 2SDO or 4SDO mode is selected on the CONFIG register, otherwise leave unconnected.

<sup>3</sup> Only used if 4SDO mode is selected on the CONFIG register, otherwise leave unconnected.



## PARALLEL INTERFACE

To read ADC data or to read/write the register content over the parallel interface, tie the  $\overline{\text{PAR/SER SEL}}$  pin low.

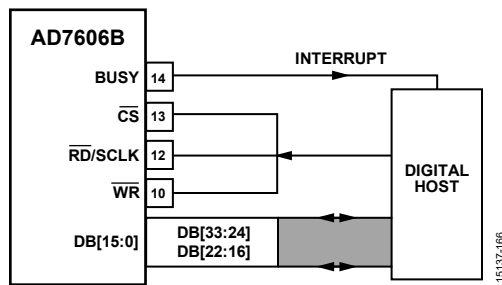


Figure 62. AD7606B Interface Diagram—One AD7606B Using the Parallel Bus, with  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  Shorted Together

The rising edge of the  $\overline{\text{CS}}$  input signal three-states the bus, and the falling edge of the  $\overline{\text{CS}}$  input signal takes the bus out of the high impedance state.  $\overline{\text{CS}}$  is the control signal that enables the data lines and it is the function that allows multiple AD7606B devices to share the same parallel data bus.

### Reading Conversion Results (Parallel ADC Mode)

The falling edge of the  $\overline{\text{RD}}$  pin reads data from the output conversion results register. Applying a sequence of  $\overline{\text{RD}}$  pulses to the  $\overline{\text{RD}}$  pin clocks the conversion results out from each channel to the parallel bus, [DB15:DB0], in ascending order, from V1 to V8, as shown in Figure 63.

The  $\overline{\text{CS}}$  signal can be permanently tied low, and the  $\overline{\text{RD}}$  signal can access the conversion results, as shown in Figure 3. A read operation of new data can take place after the BUSY signal goes low (see Figure 2). Alternatively, a read operation of data from the previous conversion process can take place while the BUSY pin is high.

When there is only one AD7606B in a system and it does not share the parallel bus, data can be read using one control signal from the digital host. The  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  signals can be tied together, as shown in Figure 4. In this case, the falling edge of the  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  signals bring the data bus out of three-state and clocks out the data.

The FRSTDATA output signal indicates when the first channel, V1, is being read back, as shown in Figure 4. When the  $\overline{\text{CS}}$  input is high, the FRSTDATA output pin is in three-state. The falling edge of  $\overline{\text{CS}}$  takes the FRSTDATA pin out of three-state. The falling edge of the  $\overline{\text{RD}}$  signal corresponding to the result of V1 sets the FRSTDATA pin high, indicating that the result from V1 is

available on the output data bus. The FRSTDATA pin returns to a logic low following the next falling edge of  $\overline{\text{RD}}$ .

### Reading During Conversion

Data can be read from the AD7606B while the BUSY pin is high and the conversions are in progress. This operation has little effect on the performance of the converter, and it allows a faster throughput rate to be achieved. Data can be read from the AD7606B at any time other than on the falling edge of the BUSY signal because this is when the output data registers are updated with the new conversion data. Any data read while the BUSY signal is high must be completed before the falling edge of the BUSY signal.

### Parallel ADC Mode with CRC Enabled

In software mode, the parallel interface supports reading the ADC data with the CRC appended, when enabled through the INT\_CRC\_ERR\_EN bit (Address 0x21, Bit 2). The CRC is 16 bits, and it is clocked out after reading all eight channel conversions, as shown in Figure 65. The CRC calculation includes all data on the DBx pins: data, status (when appended), and zeros. See the Diagnostics section for more details on the CRC.

### Parallel ADC Mode with Status Enabled

In software mode, the 8-bit status header is enabled (see Table 24) by setting Bit 6 in the CONFIG register (Address 0x02, Bit 6), and each channel then takes two frames of data:

- The first frame clocks the ADC data out normally through DBx.
- The second frame clocks out the status header of the channel on DB15 to DB8, DB15 being the MSB and DB8 the LSB, while the DB7 to DB0 pins clock out zeros.

This sequence is shown in Figure 64. Table 24 explains the status header content and describes each bit.

Table 23. CH.ID Bits Decoding in Status Header

CH.ID2	CH.ID1	CH.ID0	Channel Number
0	0	0	Channel 1 (V1)
0	0	1	Channel 2 (V2)
0	1	0	Channel 3 (V3)
0	1	1	Channel 4 (V4)
1	0	0	Channel 5 (V5)
1	0	1	Channel 6 (V6)
1	1	0	Channel 7 (V7)
1	1	1	Channel 8 (V8)

Table 24. Status Header, Parallel Interface

Bit Details	Bit 7 (MSB)	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0 (LSB)
Bit Name	RESET_DETECT	DIGITAL_ERROR	OPEN_DETECTED	AIN_OV_DIAG_ERR	AIN_UV_DIAG_ERR	CH.ID 2	CH.ID 1	CH.ID 0
Bit Description <sup>1</sup>	Reset detected	Error flag on Address 0x22	The analog input of this channel is open	Overvoltage detected on this channel	Undervoltage detected on this channel	Channel ID (see Table 23)		

<sup>1</sup> See the Diagnostics section for more information.

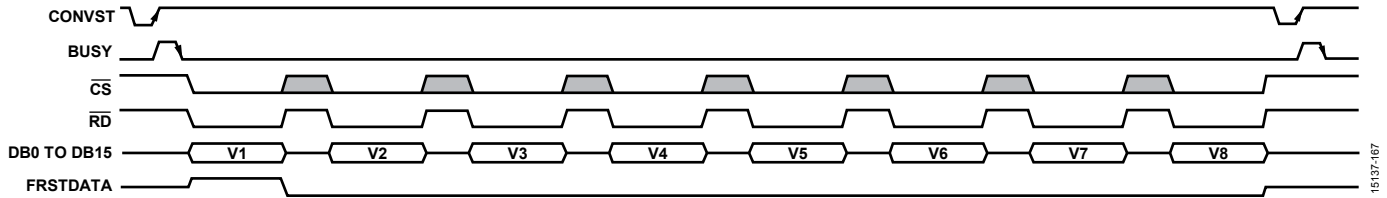


Figure 63. Parallel Interface, ADC Read Mode

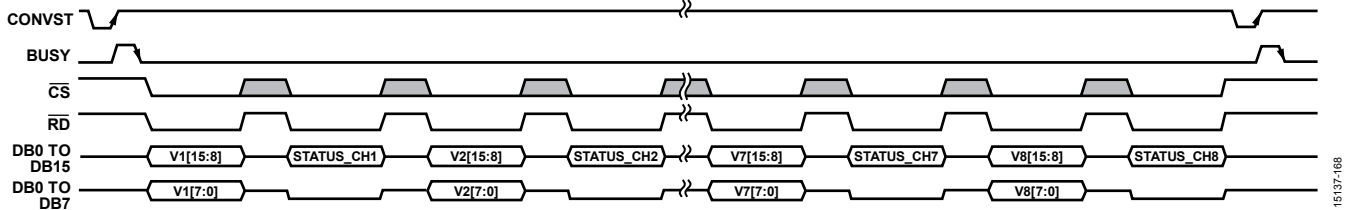


Figure 64. Parallel Interface, ADC Read Mode with Status Header Enabled

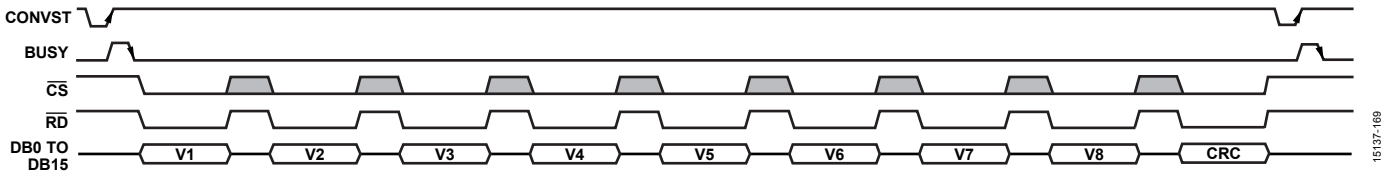


Figure 65. Parallel Interface, ADC Read Mode with CRC Enabled

### Parallel Register Mode (Reading Register Data)

In software mode, all the registers in Table 31 can be read over the parallel interface. [DB15:DB0] leave a high impedance state when both the  $\overline{\text{CS}}$  signal and  $\overline{\text{RD}}$  signal are logic low for reading register content, or when both the  $\overline{\text{CS}}$  signal and  $\overline{\text{WR}}$  signal are logic low for writing register address and/or register content.

A register read is performed through two frames: first, a read command is sent to the AD7606B and second, the AD7606B clocks out the register content. The format for a register read command is shown in Figure 66. On the first frame,

- Bit DB15 must be set to 1 to select a read command. The read command places the AD7606B in register mode.
- Bits DB[14:8] must contain the register address.
- The subsequent eight bits, DB[7:0], are ignored.

The register address is latched on the AD7606B on the rising edge of the  $\overline{\text{WR}}$  signal. The register content can then be read from the latched register by bringing the  $\overline{\text{RD}}$  line low on the following frame, as follows:

- Bit DB15 is pulled to 0 by the AD7606B.
- Bits DB[14:8] provide the register address being read.
- The subsequent eight bits, DB[7:0], provide the register content.

To revert to ADC read mode, write to Address 0x00, as shown in the Parallel Register Mode (Writing Register Data) section. No ADC data can be read while the device is in register mode.

### Parallel Register Mode (Writing Register Data)

In software mode, all the R/W registers in Table 31 can be written to over the parallel interface. To write a sequence of registers, exit ADC read mode (default mode) by reading any register on the memory map. A register write command is performed by a single frame, via the parallel bus (DB[15:0]),  $\overline{\text{CS}}$  signal, and  $\overline{\text{WR}}$  signal. The format for a write command is shown in Figure 66. The format of a write command, as shown in Figure 66, is structured as follows:

- Bit DB15 must be set to 0 to select a write command.
- Bits DB[14:8] contain the register address.
- The subsequent eight bits, DB[7:0], contain the data to be written to the selected register.

Data is latched onto the device on the rising edge of the  $\overline{\text{WR}}$  pin. To revert to ADC read mode, write to Address 0x00. No ADC data can be read while the device is in register mode.

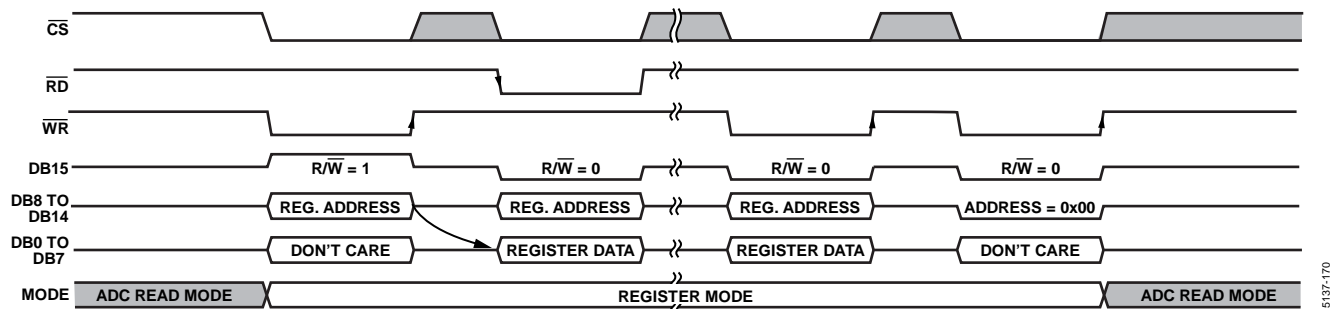


Figure 66. Parallel Interface Register Read Operation, Followed by a Write Operation

15137-170

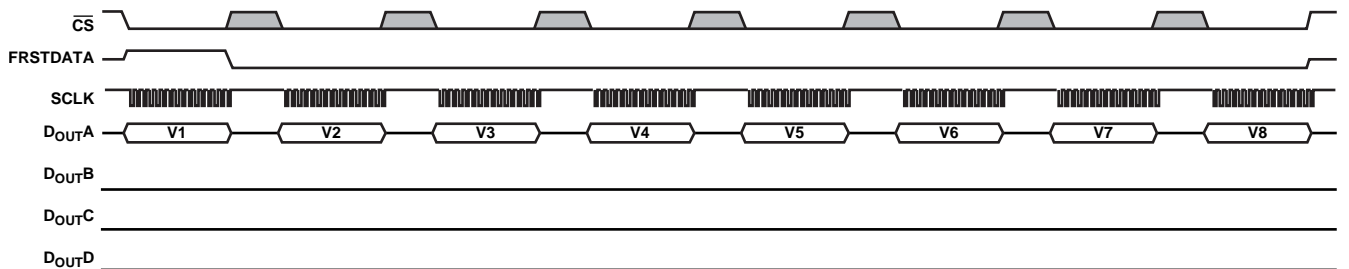


Figure 67. Serial Interface ADC Reading, One DOUTX Line

15137-171

## SERIAL INTERFACE

To read ADC data or to read/write the registers content over the serial interface, tie the  $\overline{\text{PAR/SER SEL}}$  pin high.

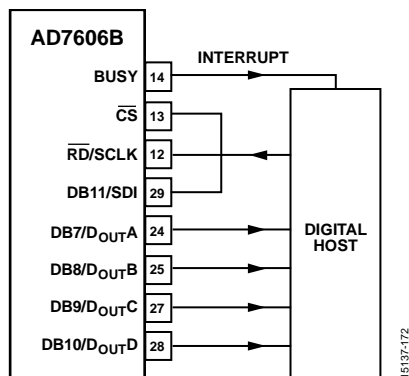


Figure 68. AD7606B Interface Diagram—One AD7606B Using the Serial Interface with Four DOUTX Lines

15137-172

### Reading Conversion Results (Serial ADC Mode)

The AD7606B has four serial data output pins: DOUTA, DOUTB, DOUTC, and DOUTD. In software mode, data can be read back from the AD7606B using either one (see Figure 68), two (see Figure 69), or four DOUTX lines (see Figure 70), depending on the configuration set in the CONFIG register.

**Table 25. DOUTX Format Selection, Using the CONFIG Register (Address 0x02)**

DOUTX Format	Address 0x02, Bit 4	Address 0x02, Bit 3
1 DOUTX	0	0
2 DOUTX	0	1
4 DOUTX	1	0
1 DOUTX	1	1

In hardware mode, only the 2 DOUTX lines option is available. However, all channels can be read from DOUTA by providing eight 16-bit SPI frames between two CONVST pulses.

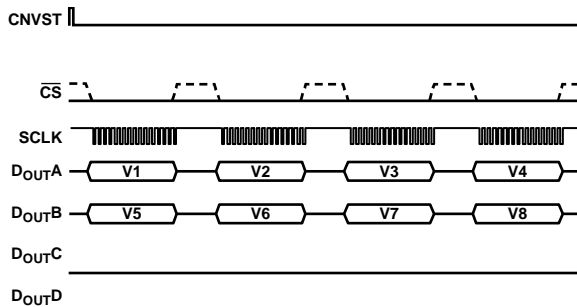


Figure 69. Serial Interface ADC Reading, Two DOUTX Lines

15137-173

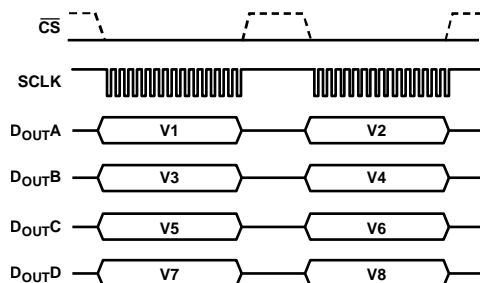


Figure 70. Serial Interface ADC Reading, Four DOUTX Lines

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The  $\overline{\text{CS}}$  falling edge takes the data output lines, DOUTA to DOUTD, out of three-state and clocks out the MSB of the conversion result.

In 3-wire mode ( $\overline{\text{CS}}$  tied low), instead of  $\overline{\text{CS}}$  clocking out the MSB, the falling edge of the BUSY signal clocks out the MSB. The rising edge of the SCLK signal clocks all the subsequent data bits on the serial data outputs, DOUTA to DOUTD, as shown in Figure 6. The  $\overline{\text{CS}}$  input can be held low for the entire serial read operation, or it can be pulsed to frame each channel read of 16 SCLK cycles (see

Figure 69). However, if  $\overline{CS}$  is pulsed during a channel conversion result transmission, the channel that was interrupted retransmits on the next frame, completely starting from the MSB.

Data can also be clocked out using only the  $D_{OUTA}$  pin, as shown in Figure 67. For the AD7606B to access all eight conversion results on one  $D_{OUTX}$  line, a total of 128 SCLK cycles is required. In hardware mode, these 128 SCLK cycles must be framed on groups of 16 SCLK cycles by the  $\overline{CS}$  signal. The disadvantage of using just one  $D_{OUTX}$  line is that the throughput rate is reduced if reading occurs after conversion. Leave the unused  $D_{OUTX}$  lines unconnected in serial mode.

Figure 70 shows a read of eight simultaneous conversion results using four  $D_{OUTX}$  lines on the AD7606B, available in software mode. In this case, a 32 SCLK transfer accesses data from the AD7606B, and  $\overline{CS}$  is either held low to frame the entire 32 SCLK cycles or is pulsed between two 16-bit frames. This mode is only available in software mode, and it is configured using the CONFIG register (Address 0x02).

Figure 6 shows the timing diagram for reading one channel of data, framed by the  $\overline{CS}$  signal, from the AD7606B in serial mode. The SCLK input signal provides the clock source for the serial read operation. The  $\overline{CS}$  signal goes low to access the data from the AD7606B.

The FRSTDATA output signal indicates when the first channel, V1, is being read back. When the  $\overline{CS}$  input is high, the FRSTDATA output pin is in three-state. In serial mode, the falling edge of the  $\overline{CS}$  signal takes the FRSTDATA pin out of three-state and sets the FRSTDATA pin high if the BUSY line is already deasserted, indicating that the result from V1 is available on the  $D_{OUTA}$  output data line. The FRSTDATA output returns to a logic low following the 16<sup>th</sup> SCLK falling edge. If the  $\overline{CS}$  pin is tied permanently low (3-wire mode), the falling edge of the BUSY

line sets the FRSTDATA pin high when the result from V1 is available on  $D_{OUTA}$ .

If SDI is tied low or high, nothing is clocked to the AD7606B. Therefore, the device remains clocking out conversion results. When using the AD7606B in 3-wire mode, keep the SDI at a high level. While in ADC read mode, single-write operations can be performed, as shown in Figure 71. For writing a sequence of registers, switch to register mode, as described in the Serial Register Mode (Writing Register Data) section.

### Reading During Conversion

Data can be read from the AD7606B while the BUSY signal is high and the conversions are in progress. This operation has little effect on the performance of the converter, and it allows a faster throughput rate to be achieved. Data can be read from the AD7606B at any time other than on the falling edge of the BUSY signal because this is when the output data registers are updated with the new conversion data. Any data read while the BUSY signal is high must be completed before falling edge of the BUSY signal.

### Serial ADC Mode, with CRC Enabled

In software mode, the CRC can be enabled by writing to the register map. In this case, the CRC is appended on each  $D_{OUTX}$  line after the last channel is clocked out as shown in Figure 78. See the Interface CRC Checksum section for more information on how the CRC is calculated.

### Serial ADC Mode, with Status Enabled

In software mode, the 8-bit status header can be turned on when using the serial interface, so that it is appended after each 16-bit data conversion, extending the frame size to 24 bits per channel, as shown in Figure 71.

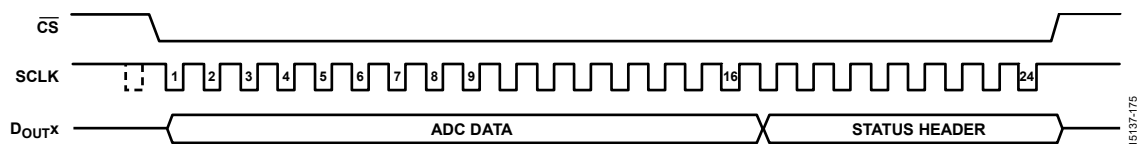


Figure 71. Serial Interface, ADC Mode, Status On

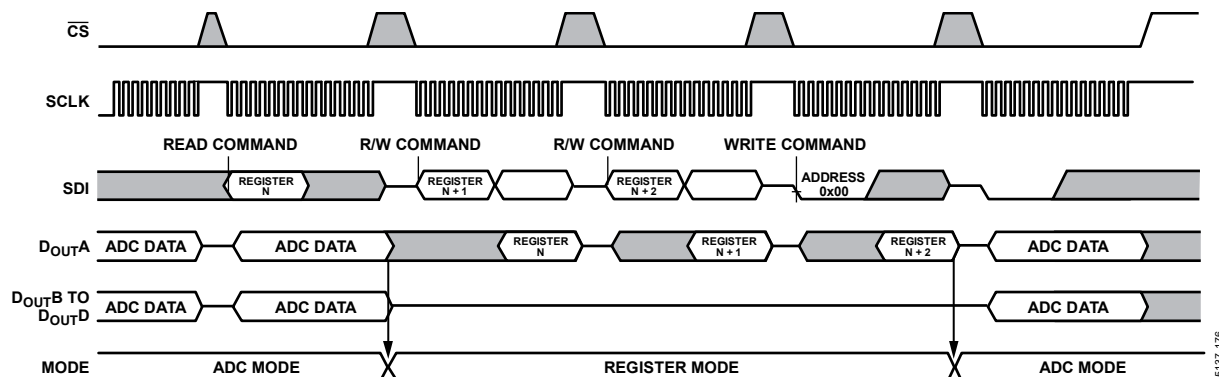


Figure 72. AD7606B Register Mode

Table 26. Status Header, Serial Interface

Bit Details	Bit 7 (MSB)	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0 (LSB)
Bit Name	RESET_DETECT	DIGITAL_ERROR	OPEN_DETECTED	AIN_OV_DIAG_ERR	AIN_UV_DIAG_ERR	CH.ID 2	CH.ID 1	CH.ID 0
Bit Description <sup>1</sup>	Reset detected	Error flag on Address 0x22	At least one analog input is open on a channel	Overvoltage detected on a channel	Undervoltage detected on a channel	Channel ID (see Table 23)		

<sup>1</sup> See the Diagnostics section for more information.

### Serial Register Mode (Reading Register Data)

All the registers in Table 31 can be read over the serial interface. The format for a read command is shown in Figure 73. It consists of two 16-bit frames. On the first frame,

- The first bit in SDI must be set to 0 to enable writing the address.
- The second bit must be set to 1 to select a read command.
- Bits[3:8] in SDI contain the register address to be clocked out on D<sub>OUTA</sub> on the following frame.
- The subsequent eight bits, Bits[9:16], in SDI are ignored.

If the AD7606B is in ADC mode, the SDO keeps clocking ADC data on Bits[9:16], and then the AD7606B switches to register mode.

If the AD7606B is in register mode, the SDO reads back the content from the previous addressed register, no matter if the previous frame was a read or a write command. To exit register mode, a write to Address 0x00 is required, as shown in Figure 72.

### Serial Register Mode (Writing Register Data)

In software mode, all the read/write registers in Table 31 can be written to over the serial interface. To write a sequence of registers, exit ADC read mode (default mode) by reading any register on the memory map. A register write command is performed by a single 16-bit SPI access. The format for a write command is shown in Figure 74.

The format for a write command, as shown in Figure 74, is structured as follows:

- The first bit in SDI must be set to 0 to enable a write command.
- The second bit, the  $\overline{R/W}$  bit, must be cleared to 0.
- Bits[ADD5:ADD0] contain the register address to be written.
- The subsequent eight bits (Bits[DIN7:DIN0]) contain the data to be written to the selected register. Data is clocked in from SDI on the falling edge of SCLK, while data is clocked out on D<sub>OUTA</sub> on the rising edge of SCLK.

When writing continuously to the device, the data that appears on D<sub>OUTA</sub> is from the register address that was written to on the previous frame, as shown in Figure 74. The D<sub>OUTB</sub>, D<sub>OUTC</sub>, and D<sub>OUTD</sub> pins are kept low during the transmission.

While in register mode, no ADC data is clocked out because the D<sub>OUTX</sub> lines are used to clock out register content. When finished writing all needed registers, a write to Address 0x00 returns the AD7606B to ADC read mode, where the ADC data is again clocked out on the D<sub>OUTX</sub> lines, as shown in Figure 72.

In software mode, when the CRC is turned on, eight additional bits are clocked in and out on each frame. Therefore, 24-bit frames are needed.

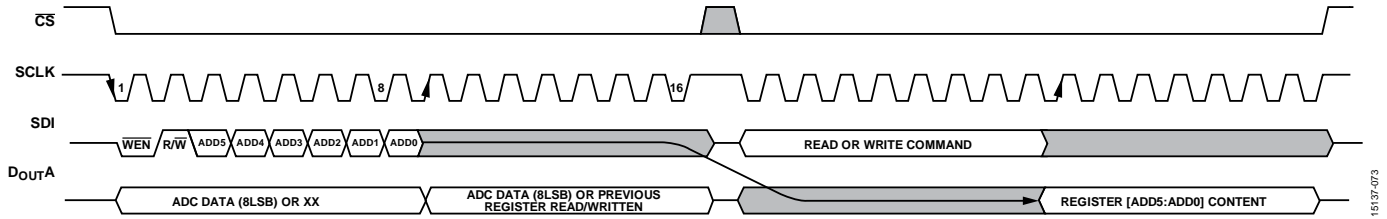


Figure 73. Serial Interface Read Command; First Frame Points the Address; Second Frame Provides the Register Content

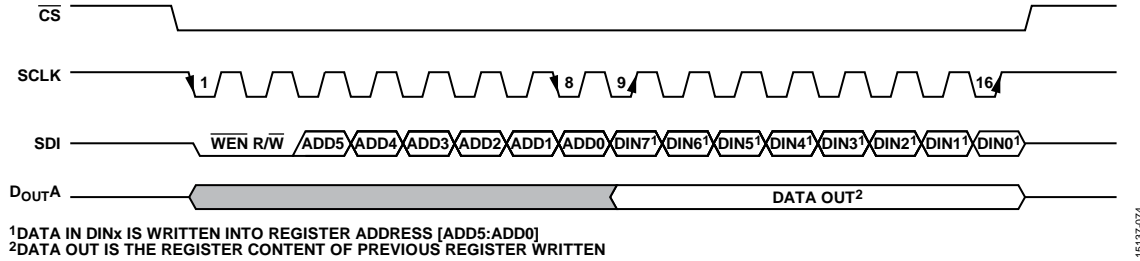


Figure 74. Serial Interface, Single-Write Command; SDI Clocks in the Address [ADD5:ADD0] and the Register Content [DINx] During the Same Frame, DOUTA Provides Register Content Requested on the Previous Frame

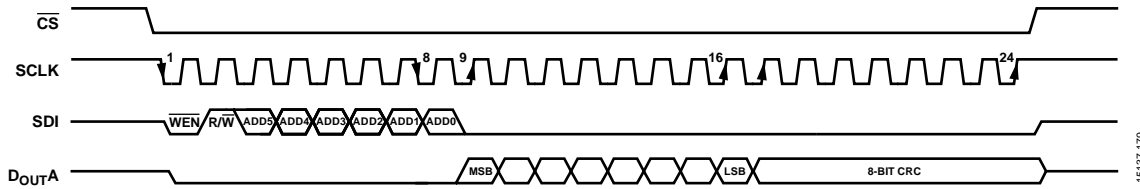


Figure 75. Reading Registers Through the SPI Interface with CRC Enabled

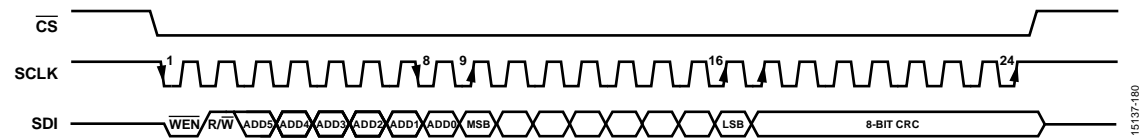


Figure 76. Writing Registers Through the SPI Interface with CRC Enabled

### Serial Register Mode with CRC

Registers can be written to and read from the AD7606B with CRC enabled, in software mode, by asserting the INT\_CRC\_ERR\_EN bit (Address 0x21, Bit 2).

When reading a register, the AD7606B provides eight additional bits on the DOUTA pin with the CRC resultant of the data shifted out previously on the same frame. The controller can then check whether the data received is correct by applying the following polynomial:

$$x^8 + x^2 + x + 1$$

With the CRC enabled, the SPI frames extend to 24 bits in length, as shown in Figure 75.

When writing a register, the controller must clock the data (register address plus register content) in the AD7606B followed by an 8-bit CRC word, calculated from the previous 16 bits using the previously described polynomial. The AD7606B reads the register address and the register content, calculates the corresponding 8-bit CRC word, and asserts the INT\_CRC\_ERR bit (Address 0x22, Bit 2) if the calculated CRC word does not match the CRC word received between the 17<sup>th</sup> and 24<sup>th</sup> bit through SDI, as shown in Figure 76.



## DIAGNOSTICS

Diagnostic features are available in software mode to verify correct operation of the AD7606B. The list of diagnostic monitors includes reset detection, overvoltage detection, undervoltage detection, analog input open circuit detection, and digital error detection.

If an error is detected, a flag asserts on the status header, if enabled, as described in the Digital Interface section. This flag points to the registers on which the error is located, as explained in the following sections.

In addition, a diagnostic multiplexer can dedicate any channel to verify a series of internal nodes, as explained in the Diagnostics Multiplexer section.

### RESET DETECTION

The RESET\_DETECT bit on the status register (Address 0x01, Bit 7) asserts if either a partial reset or full reset pulse is applied to the AD7606B. On power-up, a full reset is required. This reset asserts the RESET\_DETECT bit, indicating that the power-on reset (POR) initialized correctly on the device.

The POR monitors the REGCAP voltage and issues a full reset if the voltage drops under a certain threshold.

The RESET\_DETECT bit can be used to detect an unexpected device reset or a large glitch on the RESET pin, or a voltage drop on the supplies.

The RESET\_DETECT bit is only cleared by reading the status register.

### OVERVOLTAGE AND UNDERVOLTAGE EVENTS

The AD7606B includes on-chip overvoltage and undervoltage circuitry on each analog input pin. These comparators can be enabled or disabled using the AIN\_OV\_UV\_DIAG\_ENABLE register (Address 0x25).

After this register is enabled, when the voltage on any analog input pin goes above the overvoltage threshold shown in Table 27, the AIN\_OV\_DIAG\_ERROR register (Address 0x26) shows which channel or channels have an overvoltage event. When a bit within the AIN\_OV\_DIAG\_ERROR register asserts, it stays at a high state even after the overvoltage event disappears. To clear the error bit, the error bit must be overwritten to 1 or the error checker must be disabled.

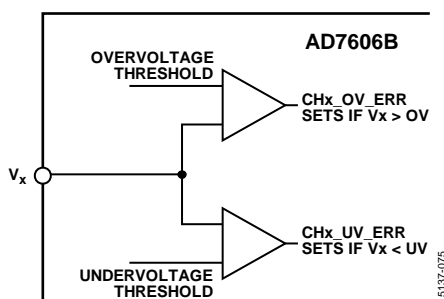


Figure 77. Overvoltage and Undervoltage Circuitry on Each Analog Input

When the voltage on any analog input pin goes below the undervoltage threshold shown in Table 27, the AIN\_UV\_DIAG\_ERROR register (Address 0x27) shows which channel or channels have an undervoltage event. When a bit within the AIN\_UV\_DIAG\_ERROR register asserts, it stays at high state after the undervoltage event disappears. To clear the error bit, the error bit must be overwritten to 1 or the error checker must be disabled.

Table 27. Overvoltage and Undervoltage Thresholds

Analog Input Range (V)	Overvoltage Threshold (V)	Undervoltage Threshold (V)
±2.5	+6.5	−3
±5	+8	−5.5
±10	+12	−11

### DIGITAL ERROR

Both the status register and status header contain a DIGITAL\_ERROR bit. This bit asserts when any of the following monitors trigger:

- Memory map CRC, read only memory (ROM) CRC, and digital interface CRC.
- SPI invalid read or write.
- BUSY stuck high.

To find out which monitor triggered the DIGITAL\_ERROR bit, the DIGITAL\_DIAG\_ERR address (Address 0x22) has a bit dedicated for each monitor, as explained in the following sections.

#### ROM CRC

The ROM stores the factory trimming settings for the AD7606B. After power-up, the ROM content is loaded to registers during device initialization. After the load, a CRC is calculated on the loaded data and verified if the result matches the CRC stored in the ROM. If an error is found, the ROM\_CRC\_ERR (Address 0x22, Bit 0) asserts. When ROM\_CRC\_ERR asserts after power-up, it is recommended to issue a full reset to reload all factory settings.

This ROM CRC monitoring feature is enabled by default, but can be disabled by clearing the ROM\_CRC\_ERR\_EN bit (Address 0x21, Bit 0).

#### Memory Map CRC

The memory map CRC is disabled by default. After the AD7606B is configured in software mode through writing the required registers, the memory map CRC can be enabled through the MM\_CRC\_ERR\_EN bit (Address 0x21, Bit 1). When enabled, the CRC calculation is performed on the entire memory map and stored. Every 4 μs, the CRC on the memory map is recalculated and compared to the stored CRC value. If the calculated and the stored CRC values do not match, the memory map is corrupted and the MM\_CRC\_ERR bit asserts. Every time the memory map is written, the CRC is recalculated and the new value stored.

If the MM\_CRC\_ERR bit asserts, it is recommended to write to the memory map to recalculate the CRC. If the error persists, it is recommended to issue a full reset to restore the default contents of the memory map.

### Interface CRC Checksum

The AD7606B has a CRC checksum mode to improve interface robustness by detecting errors in data transmission. The CRC feature is available in both ADC modes (serial and parallel) and register mode (serial only).

The AD7606B uses the following 8-bit CRC polynomial to calculate the CRC checksum value:

$$x^{16} + x^{14} + x^{13} + x^{12} + x^{10} + x^8 + x^6 + x^4 + x^3 + x + 1$$

To replicate the polynomial division in hardware, the data shifts left by 16 bits to create a number ending in 16 Logic 0s. The polynomial is aligned so that the MSB is adjacent to the leftmost Logic 1 of the data. An exclusive OR (XOR) function is applied to the data to produce a new, shorter number. The polynomial is again aligned so that the MSB is adjacent to the leftmost Logic 1 of the new result, and the procedure repeats. This process repeats until the original data is reduced to a value less than the polynomial, the 16-bit checksum.

An example of the CRC calculation for the 16-bit data is shown in Table 28. The CRC corresponding to the data 0x064E, using the previously described polynomial, is 0x2137.

The serial interface supports the CRC when enabled via the INT\_CRC\_ERR\_EN bit (Address 0x21, Bit 2). The CRC is a 16-bit word that is appended to the end of each D<sub>OUTX</sub> in use, after reading all the channels. An example using four D<sub>OUTX</sub> lines is shown in Figure 78.

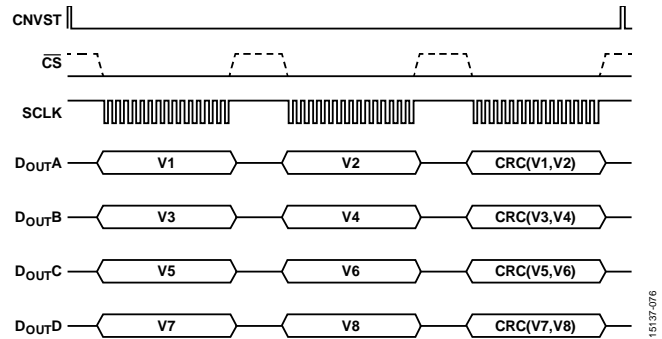


Figure 78. Serial Interface ADC Reading with CRC On, Four D<sub>OUTX</sub> Lines

If using two D<sub>OUTX</sub> lines (D<sub>OUTA</sub> and D<sub>OUTB</sub>), each 16-bit CRC word is calculated using data from four channels, that is 64 bits, as shown in Figure 79. If using only one D<sub>OUTX</sub> line, all eight channels are clocked out through D<sub>OUTA</sub>, followed by the 16-bit CRC word calculated using data from the eight channels, that is, 128 bits.

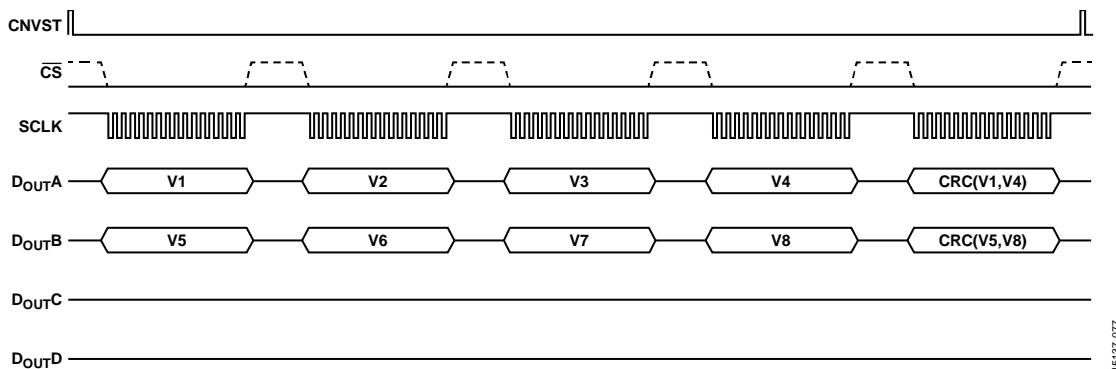


Figure 79. Serial Interface ADC Reading with CRC On, Two D<sub>OUTX</sub> Lines



When the AD7606B is in register mode, that is, when registers are being read or written, the CRC polynomial used is  $x^8 + x^2 + x + 1$ . When reading a register, and CRC is enabled, each SPI frame is 24 bits long and the CRC 8-bit word is clocked out from the 17<sup>th</sup> to 24<sup>th</sup> SCLK cycle. Similarly, when writing a register, a CRC word can be appended on the SDI line, as shown in Figure 80 and the AD7606B checks and triggers an error,

INT\_CRC\_ERR (Address 0x22, Bit 2), if the CRC given and the internally calculated do not match.

The parallel interface also supports CRC in ADC mode only, and it is clocked out through DB15 to DB0 after Channel 8, as shown in Figure 65. The 16-bit CRC word calculated using data from the eight channels, that is, 128 bits.

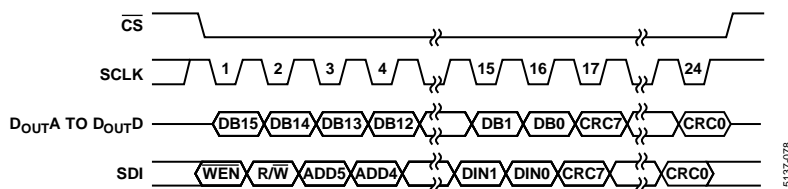


Figure 80. Register Write with CRC On

Table 28. Example CRC Calculation for 16-Bit Data<sup>1</sup>

Data <sup>2</sup>	0	0	0	0	0	1	1	0	0	1	0	0	1	1	1	0	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x	x
Process Data	0	0	0	0	0	1	1	0	0	1	0	0	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Polynomial						1	0	1	1	1	0	1	0	1	0	1	1	0	1	1														
						0	1	1	1	0	0	1	1	0	1	1	0	1	1	0														
							1	0	1	1	1	0	1	0	1	0	1	1	0	1	1													
							0	1	0	1	1	1	0	0	0	1	1	1	0	1	1	0	1	0										
								1	0	1	1	1	0	1	0	1	0	1	1	0	1	1												
								0	0	0	0	0	0		1	0	0	1	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	
																	1	0	1	1	1	0	1	0	1	0	1	1	0	1	1			
																		0	0	1	0	1	0	1	0	0	0	1	1	0	1	1	0	0
																			1	0	1	1	1	0	1	0	1	0	1	1	0	1	1	
																				1	0	1	1	1	0	1	0	1	1	0	1	1		
CRC																	0	0	1	0	0	0	0	1	0	0	1	1	0	1	1	1	1	

<sup>1</sup> This table represents the division of the data. Blank cells are for formatting purposes.

<sup>2</sup> X = don't care.

### Interface Check

The integrity of the digital interface can be checked by setting the INTERFACE\_CHECK\_EN bit (Address 0x21, Bit 7). Selecting the interface check forces the conversion result registers to a known value, as shown in Table 29.

Verifying that the controller receives the data shown in Table 29 ensures that the interface between the AD7606B and the controller operates properly. If the interface CRC is enabled because the data transmitted is known, this mode verifies that the controller performs the CRC calculation properly.

Table 29. Interface Check Conversion Results

Channel Number	Conversion Result Forced (Hex.)
V1	0xACCA
V2	0x5CC5
V3	0xA33A
V4	0x5335
V5	0xCAAC
V6	0xC55C
V7	0x3AA3
V8	0x3553

### SPI Invalid Read/Write

When attempting to read back an invalid register address, the SPI\_READ\_ERR bit (Address 0x22, Bit 4) is set. The invalid readback address detection can be enabled by setting the SPI\_READ\_ERR\_EN bit (Address 0x21, Bit 4). If an SPI read error is triggered, it is cleared by overwriting that bit or disabling the checker.

When attempting to write to an invalid register address or a read only register, the SPI\_WRITE\_ERR bit (Address 0x22, Bit 3) is set. The invalid write address detection can be enabled by setting the SPI\_WRITE\_ERR bit (Address 0x21, Bit 3). If an SPI write error is triggered, it is cleared by overwriting that bit or disabling the checker.

### BUSY Stuck High

BUSY stuck high monitoring is enabled by setting the BUSY\_STUCK\_HIGH\_ERR\_EN bit (Address 0x21, Bit 5). After this bit is enabled, the conversion time ( $t_{CONV}$  in Table 3) is monitored internally with an independent clock. If  $t_{CONV}$  exceeds 4  $\mu$ s, the AD7606B automatically issues a partial reset and asserts the BUSY\_STUCK\_HIGH\_ERR bit (Address 0x22, Bit 5). To clear this error flag, the BUSY\_STUCK\_HIGH\_ERR bit must be overwritten with a 1.

When oversampling mode is enabled, the individual conversion time for each internal conversion is monitored.

### DIAGNOSTICS MULTIPLEXER

All eight input channels contain a diagnostics multiplexer in front of the PGA that allows monitoring of the internal nodes described in Table 30 to ensure the correct operation of the AD7606B. Table 30 shows the bit decoding for the diagnostic mux register on Channel 1, as an example. When an internal node is selected, the input voltage at input pins are deselected from the PGA, as shown in Figure 81.

Each diagnostic multiplexer configuration is accessed, in software mode through the corresponding register (Address 0x28 to Address 0x2B). To use the multiplexer on one channel, the  $\pm 10$  V range must be selected on that channel.

Table 30. Diagnostic Mux Register Bit Decoding of Channel 1

Address 0x18			Signal on Channel 1
Bit 2	Bit 1	Bit 0	
0	0	0	V1
0	0	1	Temperature sensor
0	1	0	V <sub>REF</sub>
0	1	1	4 × ALDO
1	0	0	4 × DLDO
1	0	1	V <sub>DRIVE</sub>
1	1	0	AGND
1	1	1	AV <sub>CC</sub>

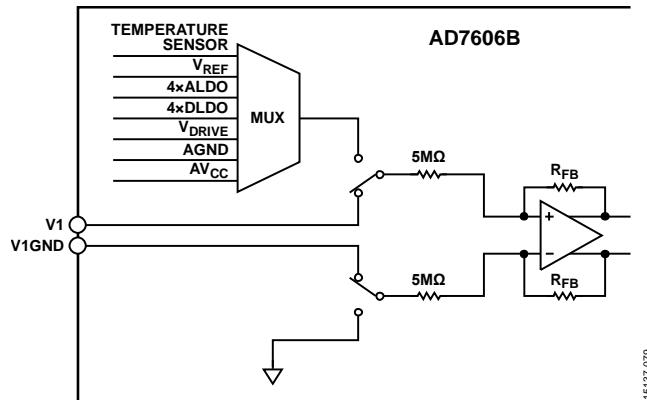


Figure 81. Diagnostic Multiplexer (Channel 1 Shown as an Example)

### Temperature Sensor

The temperature sensor can be selected through the diagnostic multiplexer and converted with the ADC, as shown in Figure 81. The temperature sensor voltage is measured and is proportional to the die temperature, as per the following equation:

$$\text{Temperature } (^{\circ}\text{C}) = \frac{\text{ADC}_{\text{OUT}} (V) - 0.69068 (V)}{0.019328 (V / ^{\circ}\text{C})} + 25 (^{\circ}\text{C})$$

with an accuracy of  $\pm 2^{\circ}\text{C}$ .

### Reference Voltage

The reference voltage can be selected through the diagnostic multiplexer and converted with the ADC, as shown in Figure 82. The internal or external reference is selected as input to the diagnostic multiplexer based on REF SELECT pin. Ideally, the ADC output follows the voltage reference level ratio metrically.

Therefore, if the ADC output goes beyond the expected 2.5 V, either the reference buffer or the PGA is malfunctioning.

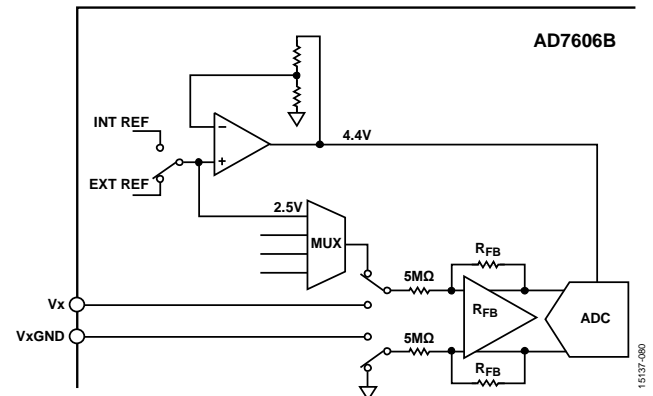


Figure 82. Reference Voltage Signal Path Through the Diagnostic Multiplexer

### Internal LDOs

The analog and digital LDO (REGCAP pins) can be selected through the diagnostic multiplexer and converted with the ADC, as shown in Figure 81. The ADC output is four times the voltage on the REGCAPA and REGCAPD pins, respectively. This measurement verifies that each LDO is at the correct operating voltage so that the internal circuitry is biased correctly.

### Supply Voltages

$\text{AV}_{\text{CC}}$ ,  $\text{V}_{\text{DRIVE}}$ , and  $\text{AGND}$  can be selected through the diagnostic multiplexer and converted with the ADC, as shown in Figure 81. This setup ensures the voltage and grounds are correctly applied to the device to ensure correct operation.

## TYPICAL CONNECTION DIAGRAM

There are four  $AV_{CC}$  supply pins on the device. It is recommended that each of the four pins are decoupled using a 100 nF capacitor at each supply pin and a 10  $\mu$ F capacitor at the supply source. The AD7606B can operate with the internal reference or an externally applied reference. When using a single AD7606B device on the board, decouple the REFIN/REFOUT pin with a 100 nF capacitor. Refer to the Reference section when using an application with multiple AD7606B devices. The REFCAPA and REFCAPB pins are shorted together and decoupled with a 10  $\mu$ F ceramic capacitor.

The  $V_{DRIVE}$  supply is connected to the same supply as the processor. The  $V_{DRIVE}$  voltage controls the voltage value of the output logic signals. For more information on layout, decoupling, and grounding, see the Layout Guidelines section.

After supplies are applied to the AD7606B, apply a reset to the AD7606B to ensure that it is configured for the correct mode of operation.

In Figure 83, the AD7606B is configured in hardware mode and is operating with the internal reference because the REF SELECT pin is set to logic high. In this example, the device also uses the

parallel interface because the  $\overline{PAR/SER}$  pin is tied to AGND. The analog input range for all eight channels is  $\pm 10$  V, provided the RANGE pin is tied to a high level and the oversampling ratio is controlled through the OS pins by the controller.

In Figure 84, the AD7606B is configured in software mode, because all three OS2, OS1, and OS0 pins are at logic level high. The oversampling ratio, as well as each channel range, are configured through accessing the memory map. In this example, the  $\overline{PAR/SER}$  pin is at logic level high. Therefore, the serial interface is used for both reading the ADC data and reading and writing the memory map. The REF SELECT pin is tied to AGND. Therefore, the internal reference is disabled and an external reference is connected externally to the REFIN/REFOUT pin and decoupled through a 100 nF capacitor.

Figure 83 and Figure 84 are examples of typical connection diagrams. Other combinations of reference, data interface, and operation mode are also possible, depending on the logic levels applied to each configuration pin.

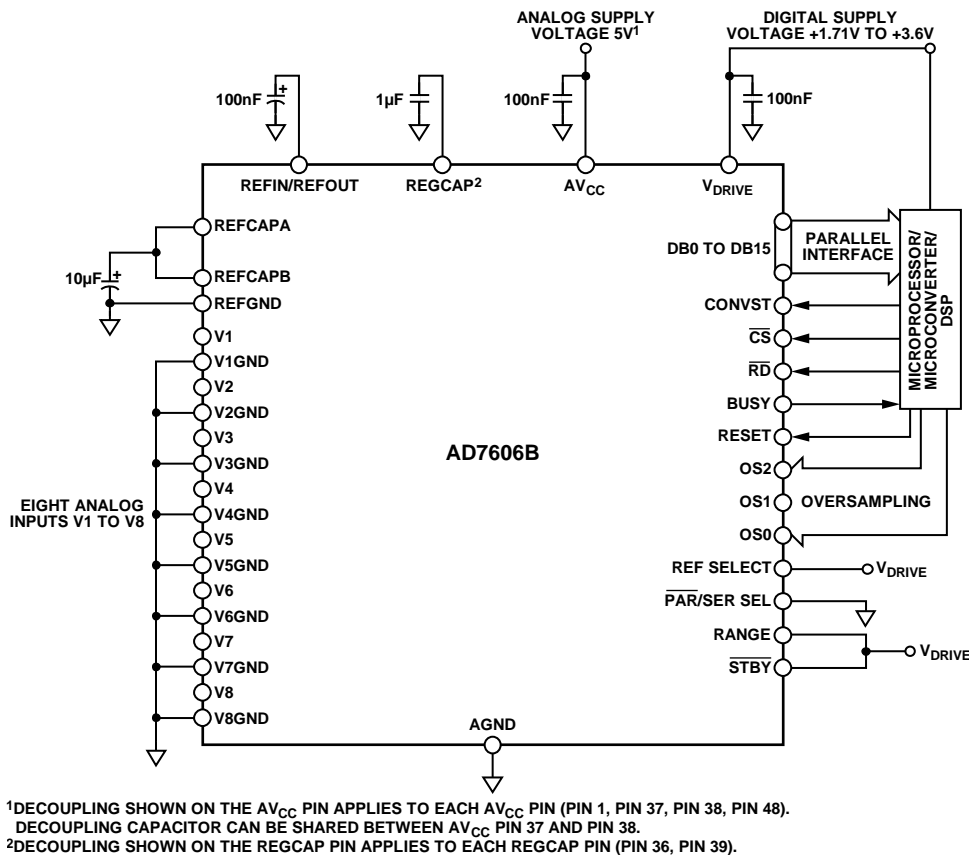
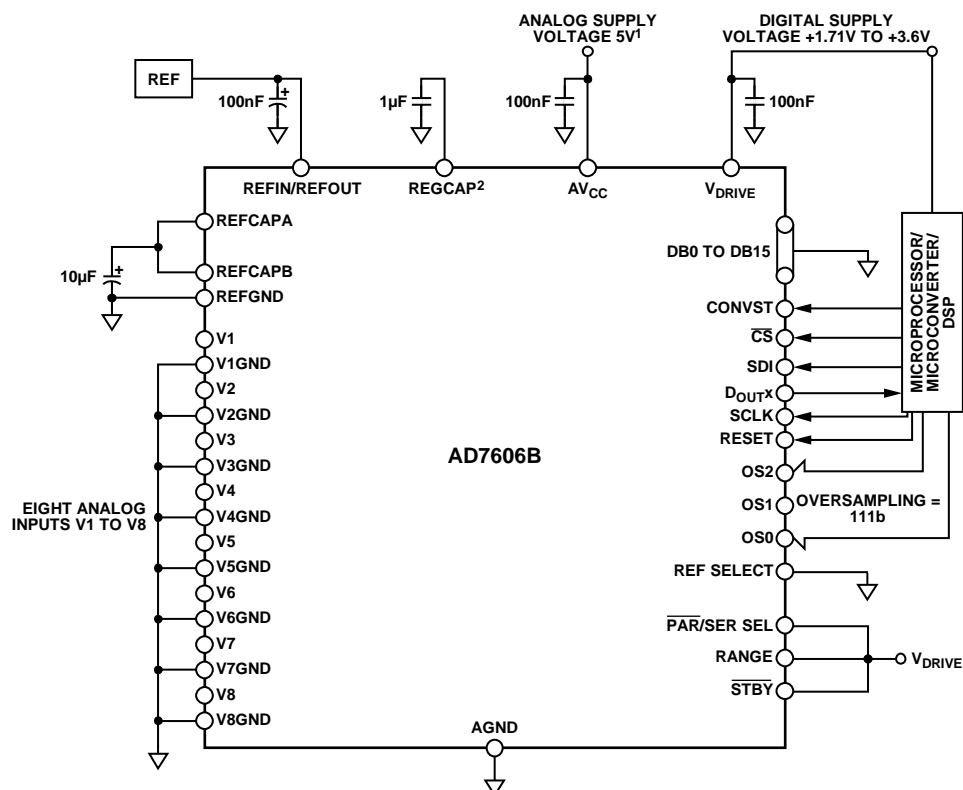


Figure 83. AD7606B Typical Connection Diagram, Hardware Mode



<sup>1</sup>DECOUPLING SHOWN ON THE AV<sub>CC</sub> PIN APPLIES TO EACH AV<sub>CC</sub> PIN (PIN 1, PIN 37, PIN 38, PIN 48).

DECOUPLING CAPACITOR CAN BE SHARED BETWEEN AV<sub>CC</sub> PIN 37 AND PIN 38.

<sup>2</sup>DECOUPLING SHOWN ON THE REGCAP PIN APPLIES TO EACH REGCAP PIN (PIN 36, PIN 39).

15137-082

Figure 84. Typical Connection Diagram, Software Mode

## APPLICATIONS INFORMATION

### LAYOUT GUIDELINES

The following layout guidelines are recommended to be followed when designing the PCB that houses the AD7606B:

- The analog and digital sections are separated and confined to different areas of the board.
- Use at least one ground plane. This plane can be common or split between the digital and analog sections. In the case of a split plane, join the digital and analog ground planes in only one place, preferably as close as possible to the AD7606B.
- If the AD7606B is in a system where multiple devices require analog-to-digital ground connections, make the connection at only one point: a star ground point that is established as close as possible to the AD7606B.
- Make stable connections to the ground plane. Avoid sharing one connection for multiple ground pins. Use individual vias or multiple vias to the ground plane for each ground pin.
- Avoid running digital lines under the device because doing so couples noise on the die. Allow the analog ground plane to run under the AD7606B to avoid noise coupling.
- Shield fast switching signals like CONVST, or clocks with digital ground to avoid radiating noise to other sections of the board and ensure that they never run near analog signal paths.
- Avoid crossover of digital and analog signals.
- Traces on layers in close proximity on the board run at right angles to each other to reduce the effect of feedthrough through the board.
- Power supply lines to the  $AV_{CC}$  and  $V_{DRIVE}$  pins on the AD7606B use as large a trace as possible to provide low impedance paths and reduce the effect of glitches on the power supply lines. Where possible, use supply planes and make stable connections between the AD7606B supply pins and the power tracks on the board. Use a single via or multiple vias for each supply pin.
- Place the decoupling capacitors close to (ideally, directly against) the supply pins and their corresponding ground pins. Place the decoupling capacitors for the REFIN/REFOUT pin and the REFCAPA pin and REFCAPB pin as close as possible to their respective AD7606B pins. Where possible, place the pins on the same side of the board as the AD7606B device.

Figure 85 shows the recommended decoupling on the top layer of the AD7606B board. Figure 86 shows bottom layer decoupling, which is used for the four  $AV_{CC}$  pins and the  $V_{DRIVE}$  pin decoupling. Where the ceramic 100 nF caps for the  $AV_{CC}$  pins are placed close to their respective device pins, a single 100 nF capacitor can be shared between Pin 37 and Pin 38.

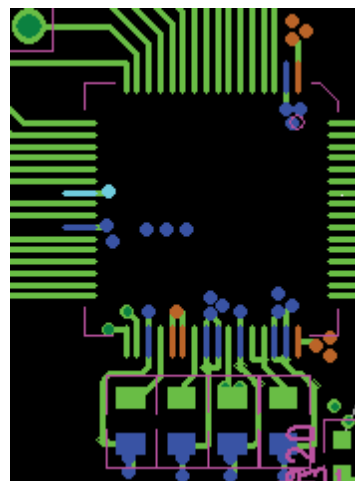


Figure 85. Top Layer Decoupling REFIN/REFOUT, REFCAPA, REFCAPB, and REGCAP Pins



Figure 86. Bottom Layer Decoupling

To ensure stable device to device performance matching in a system that contains multiple AD7606B devices, a symmetrical layout between the AD7606B devices is important.

Figure 87 shows a layout with two AD7606B devices. The  $AV_{CC}$  supply plane runs to the right of both devices, and the  $V_{DRIVE}$  supply track runs to the left of the two devices. The reference chip is positioned between the two devices, and the reference voltage track runs north to Pin 42 of U1 and south to Pin 42 of U2. A solid ground plane is used.

These symmetrical layout principles can also be applied to a system that contains more than two AD7606B devices. The AD7606B devices can be placed in a north/south direction, with the reference voltage located midway between the devices and the reference track running in the north/south direction, similar to Figure 87.

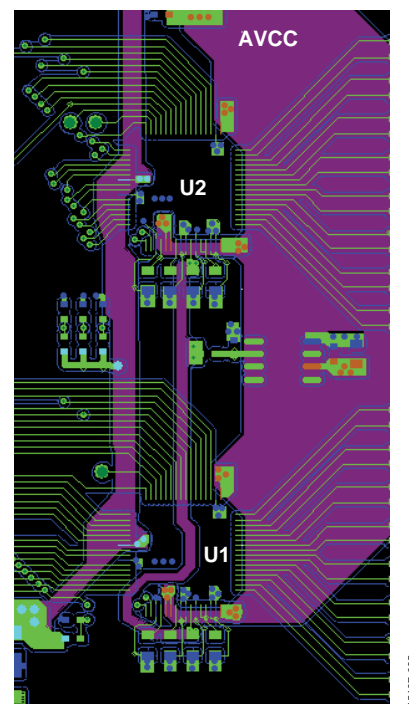


Figure 87. Layout for Multiple AD7606B Devices—Top Layer and Supply Plane Layer

## REGISTER SUMMARY

Table 31. Register Summary

Addr	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Reset	RW	
0x01	STATUS	RESET_DETECT	DIGITAL_ERROR	RESERVED							0x00	R
0x02	CONFIG	RESERVED	STATUS_HEADER	EXT_OS_CLOCK	DOUT_FORMAT		RESERVED	OPERATION_MODE		0x08	R/W	
0x03	RANGE_CH1_CH2	CH2_RANGE				CH1_RANGE					0x33	R/W
0x04	RANGE_CH3_CH4	CH4_RANGE				CH3_RANGE					0x33	R/W
0x05	RANGE_CH5_CH6	CH6_RANGE				CH5_RANGE					0x33	R/W
0x06	RANGE_CH7_CH8	CH8_RANGE				CH7_RANGE					0x33	R/W
0x08	OVERSAMPLING	OS_PAD				OS_RATIO					0x00	R/W
0x09	CH1_GAIN	RESERVED		CH1_GAIN						0x00	R/W	
0x0A	CH2_GAIN	RESERVED		CH2_GAIN						0x00	R/W	
0x0B	CH3_GAIN	RESERVED		CH3_GAIN						0x00	R/W	
0x0C	CH4_GAIN	RESERVED		CH4_GAIN						0x00	R/W	
0x0D	CH5_GAIN	RESERVED		CH5_GAIN						0x00	R/W	
0x0E	CH6_GAIN	RESERVED		CH6_GAIN						0x00	R/W	
0x0F	CH7_GAIN	RESERVED		CH7_GAIN						0x00	R/W	
0x10	CH8_GAIN	RESERVED		CH8_GAIN						0x00	R/W	
0x11	CH1_OFFSET					CH1_OFFSET				0x80	R/W	
0x12	CH2_OFFSET					CH2_OFFSET				0x80	R/W	
0x13	CH3_OFFSET					CH3_OFFSET				0x80	R/W	
0x14	CH4_OFFSET					CH4_OFFSET				0x80	R/W	
0x15	CH5_OFFSET					CH5_OFFSET				0x80	R/W	
0x16	CH6_OFFSET					CH6_OFFSET				0x80	R/W	
0x17	CH7_OFFSET					CH7_OFFSET				0x80	R/W	
0x18	CH8_OFFSET					CH8_OFFSET				0x80	R/W	
0x19	CH1_PHASE					CH1_PHASE_OFFSET				0x00	R/W	
0x1A	CH2_PHASE					CH2_PHASE_OFFSET				0x00	R/W	
0x1B	CH3_PHASE					CH3_PHASE_OFFSET				0x00	R/W	
0x1C	CH4_PHASE					CH4_PHASE_OFFSET				0x00	R/W	
0x1D	CH5_PHASE					CH5_PHASE_OFFSET				0x00	R/W	
0x1E	CH6_PHASE					CH6_PHASE_OFFSET				0x00	R/W	
0x1F	CH7_PHASE					CH7_PHASE_OFFSET				0x00	R/W	
0x20	CH8_PHASE					CH8_PHASE_OFFSET				0x00	R/W	
0x21	DIGITAL_DIAG_ENABLE	INTERFACE_CHECK_EN	CLK_FS_OS_COUNTER_EN	BUSY_STUCK_HIGH_ERR_EN	SPI_READ_ERR_EN	SPI_WRITE_ERR_EN	INT_CRC_ERR_EN	MM_CRC_ERR_EN	ROM_CRC_ERR_EN	0x01	R/W	
0x22	DIGITAL_DIAG_ERR	RESERVED		BUSY_STUCK_HIGH_ERR	SPI_READ_ERR	SPI_WRITE_ERR	INT_CRC_ERR	MM_CRC_ERR	ROM_CRC_ERR	0x00	R/W	
0x23	OPEN_DETECT_ENABLE	CH8_OPEN_DETECT_EN	CH7_OPEN_DETECT_EN	CH6_OPEN_DETECT_EN	CH5_OPEN_DETECT_EN	CH4_OPEN_DETECT_EN	CH3_OPEN_DETECT_EN	CH2_OPEN_DETECT_EN	CH1_OPEN_DETECT_EN	0x00	R/W	
0x24	OPEN_DETECTED	CH8_OPEN	CH7_OPEN	CH6_OPEN	CH5_OPEN	CH4_OPEN	CH3_OPEN	CH2_OPEN	CH1_OPEN	0x00	R/W	
0x25	AIN_OV_UV_DIAG_ENABLE	CH8_OV_UV_EN	CH7_OV_UV_EN	CH6_OV_UV_EN	CH5_OV_UV_EN	CH4_OV_UV_EN	CH3_OV_UV_EN	CH2_OV_UV_EN	CH1_OV_UV_EN	0x00	R/W	
0x26	AIN_OV_DIAG_ERROR	CH8_OV_ERR	CH7_OV_ERR	CH6_OV_ERR	CH5_OV_ERR	CH4_OV_ERR	CH3_OV_ERR	CH2_OV_ERR	CH1_OV_ERR	0x00	R/W	
0x27	AIN_UV_DIAG_ERROR	CH8_UV_ERR	CH7_UV_ERR	CH6_UV_ERR	CH5_UV_ERR	CH4_UV_ERR	CH3_UV_ERR	CH2_UV_ERR	CH1_UV_ERR	0x00	R/W	
0x28	DIAGNOSTIC_MUX_CH1_2	RESERVED		CH2_DIAG_MUX_CTRL			CH1_DIAG_MUX_CTRL			0x00	R/W	
0x29	DIAGNOSTIC_MUX_CH3_4	RESERVED		CH4_DIAG_MUX_CTRL			CH3_DIAG_MUX_CTRL			0x00	R/W	



Addr	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Reset	RW
0x2A	DIAGNOSTIC_MUX_CH5_6	RESERVED		CH6_DIAG_MUX_CTRL			CH5_DIAG_MUX_CTRL			0x00	R/W
0x2B	DIAGNOSTIC_MUX_CH7_8	RESERVED		CH8_DIAG_MUX_CTRL			CH7_DIAG_MUX_CTRL			0x00	R/W
0x2C	OPEN_DETECT_QUEUE	OPEN_DETECT_QUEUE								0x00	R/W
0x2D	FS_CLK_COUNTER	CLK_FS_COUNTER								0x00	R
0x2E	OS_CLK_COUNTER	CLK_OS_COUNTER								0x00	R
0x2F	ID	DEVICE_ID				SILICON_REVISION				0x14	R

## REGISTER DETAILS

Address: 0x01, Reset: 0x00, Name: STATUS

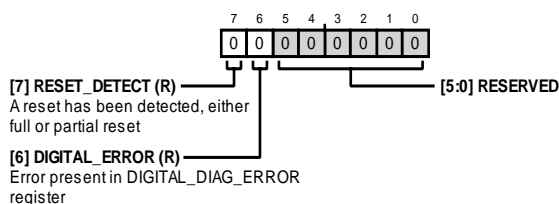


Table 32. Bit Descriptions for STATUS

Bits	Bit Name	Description	Reset	Access
7	RESET_DETECT	A reset has been detected, either full or partial reset.	0x0	R
6	DIGITAL_ERROR	Error present in DIGITAL_DIAG_ERROR register.	0x0	R
[5:0]	RESERVED	Reserved.	0x0	R

Address: 0x02, Reset: 0x08, Name: CONFIG

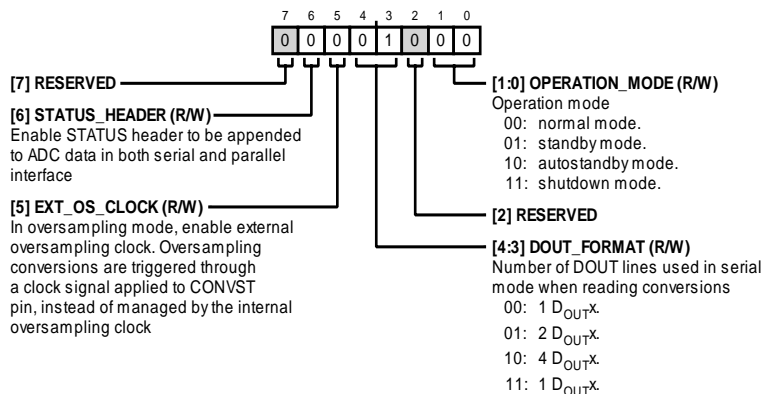


Table 33. Bit Descriptions for CONFIG

Bits	Bit Name	Description	Reset	Access
7	RESERVED	Reserved.	0x0	R
6	STATUS_HEADER	Enable STATUS header to be appended to ADC data in both serial and parallel interface.	0x0	R/W
5	EXT_OS_CLOCK	In oversampling mode, enable external oversampling clock. Oversampling conversions are triggered through a clock signal applied to CONVST pin, instead of managed by the internal oversampling clock.	0x0	R/W
[4:3]	DOUT_FORMAT	Number of D <sub>OUTX</sub> lines used in serial mode when reading conversions. 00: 1 D <sub>OUTX</sub> . 01: 2 D <sub>OUTX</sub> . 10: 4 D <sub>OUTX</sub> . 11: 1 D <sub>OUTX</sub> .	0x1	R/W
2	RESERVED	Reserved.	0x0	R
[1:0]	OPERATION_MODE	Operation mode. 00: normal mode. 01: standby mode. 10: autostandby mode. 11: shutdown mode.	0x0	R/W

Address: 0x03, Reset: 0x33, Name: RANGE\_CH1\_CH2

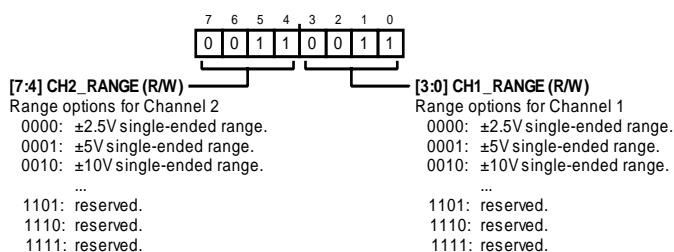


Table 34. Bit Descriptions for RANGE\_CH1\_CH2

Bits	Bit Name	Description	Reset	Access
[7:4]	CH2_RANGE	Range options for Channel 2. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W
[3:0]	CH1_RANGE	Range options for Channel 1. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W

Address: 0x04, Reset: 0x33, Name: RANGE\_CH3\_CH4

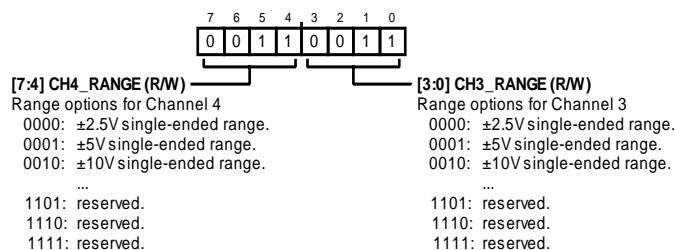


Table 35. Bit Descriptions for RANGE\_CH3\_CH4

Bits	Bit Name	Description	Reset	Access
[7:4]	CH4_RANGE	Range options for Channel 4. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W
[3:0]	CH3_RANGE	Range options for Channel 3. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W

Address: 0x05, Reset: 0x33, Name: RANGE\_CH5\_CH6

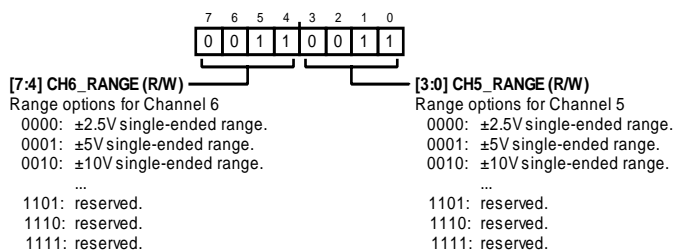


Table 36. Bit Descriptions for RANGE\_CH5\_CH6

Bits	Bit Name	Description	Reset	Access
[7:4]	CH6_RANGE	Range options for Channel 6. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W
[3:0]	CH5_RANGE	Range options for Channel 5. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W

Address: 0x06, Reset: 0x33, Name: RANGE\_CH7\_CH8

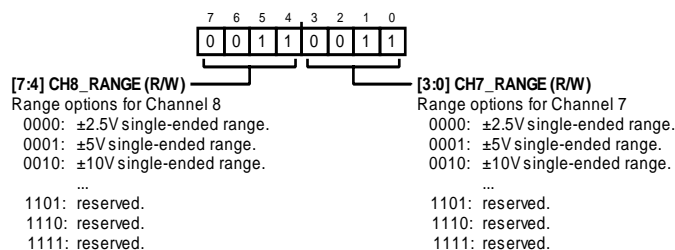


Table 37. Bit Descriptions for RANGE\_CH7\_CH8

Bits	Bit Name	Description	Reset	Access
[7:4]	CH8_RANGE	Range options for Channel 8. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W
[3:0]	CH7_RANGE	Range options for Channel 7. 0000: $\pm 2.5$ V single-ended range. 0001: $\pm 5$ V single-ended range. 0010: $\pm 10$ V single-ended range. 0011: $\pm 10$ V single-ended range. 0100: $\pm 10$ V single-ended range. 0101: $\pm 10$ V single-ended range. 0110: $\pm 10$ V single-ended range. 0111: $\pm 10$ V single-ended range. 1000: $\pm 10$ V single-ended range. 1001: $\pm 10$ V single-ended range. 1010: $\pm 10$ V single-ended range. 1011: $\pm 10$ V single-ended range. 1100: reserved. 1101: reserved. 1110: reserved. 1111: reserved.	0x3	R/W

Address: 0x08, Reset: 0x00, Name: OVERSAMPLING

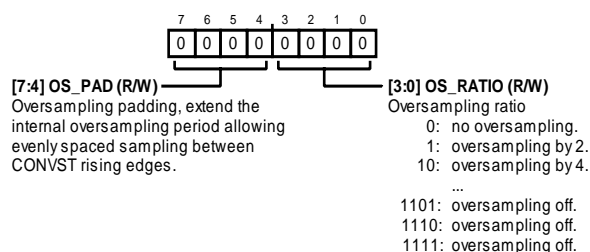


Table 38. Bit Descriptions for OVERSAMPLING

Bits	Bit Name	Description	Reset	Access
[7:4]	OS_PAD	Oversampling padding, extend the internal oversampling period allowing evenly spaced sampling between CONVST rising edges.	0x0	R/W
[3:0]	OS_RATIO	Oversampling ratio. 0: no oversampling. 1: oversampling by 2. 10: oversampling by 4. 11: oversampling by 8. 100: oversampling by 16. 101: oversampling by 32. 110: oversampling by 64. 111: oversampling by 128. 1000: oversampling by 256. 1001: oversampling off. 1010: oversampling off. 1011: oversampling off. 1100: oversampling off. 1101: oversampling off. 1110: oversampling off. 1111: oversampling off.	0x0	R/W

Address: 0x09, Reset: 0x00, Name: CH1\_GAIN

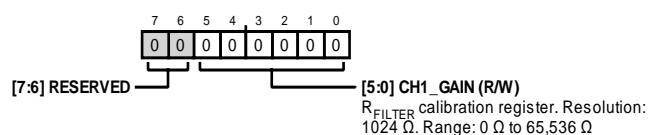


Table 39. Bit Descriptions for CH1\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH1_GAIN	$R_{FILTER}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W

Address: 0x0A, Reset: 0x00, Name: CH2\_GAIN

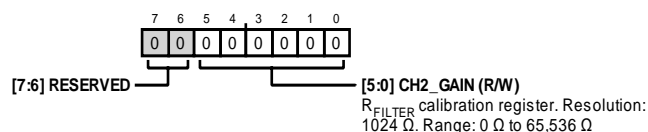


Table 40. Bit Descriptions for CH2\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH2_GAIN	$R_{FILTER}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W

Address: 0x0B, Reset: 0x00, Name: CH3\_GAIN

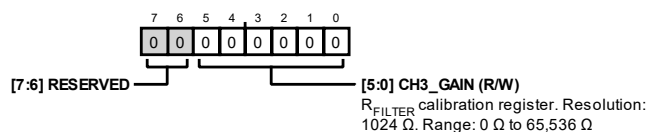


Table 41. Bit Descriptions for CH3\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH3_GAIN	$R_{\text{FILTER}}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W

Address: 0x0C, Reset: 0x00, Name: CH4\_GAIN

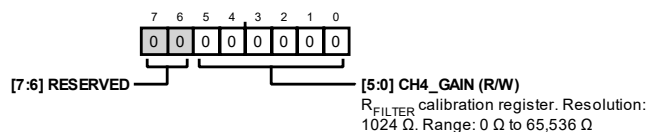


Table 42. Bit Descriptions for CH4\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH4_GAIN	$R_{\text{FILTER}}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W

Address: 0x0D, Reset: 0x00, Name: CH5\_GAIN

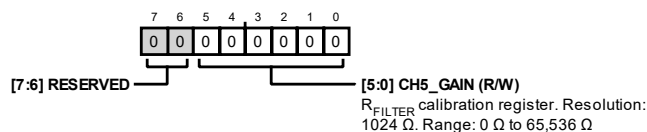


Table 43. Bit Descriptions for CH5\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH5_GAIN	$R_{\text{FILTER}}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W

Address: 0x0E, Reset: 0x00, Name: CH6\_GAIN

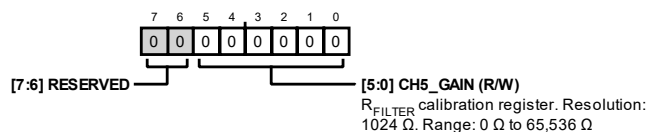


Table 44. Bit Descriptions for CH6\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH6_GAIN	$R_{\text{FILTER}}$ calibration register. Resolution: 1024 $\Omega$ . Range: 0 $\Omega$ to 65,536 $\Omega$ .	0x0	R/W



Address: 0x0F, Reset: 0x00, Name: CH7\_GAIN

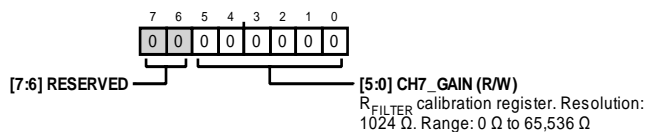


Table 45. Bit Descriptions for CH7\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH7_GAIN	R <sub>FILTER</sub> calibration register. Resolution: 1024 Ω. Range: 0 Ω to 65,536 Ω.	0x0	R/W

Address: 0x10, Reset: 0x00, Name: CH8\_GAIN

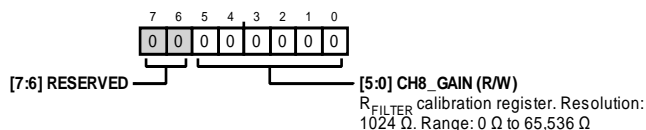


Table 46. Bit Descriptions for CH8\_GAIN

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:0]	CH8_GAIN	R <sub>FILTER</sub> calibration register. Resolution: 1024 Ω. Range: 0 Ω to 65,536 Ω.	0x0	R/W

Address: 0x11, Reset: 0x80, Name: CH1\_OFFSET

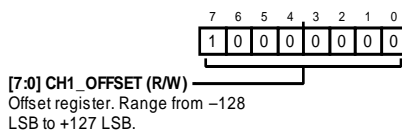


Table 47. Bit Descriptions for CH1\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH1_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x12, Reset: 0x80, Name: CH2\_OFFSET

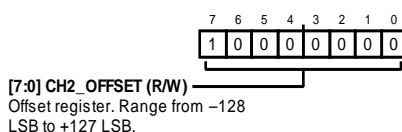


Table 48. Bit Descriptions for CH2\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH2_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x13, Reset: 0x80, Name: CH3\_OFFSET

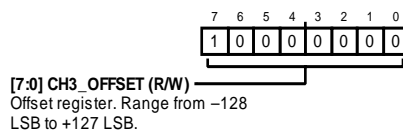


Table 49. Bit Descriptions for CH3\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH3_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x14, Reset: 0x80, Name: CH4\_OFFSET

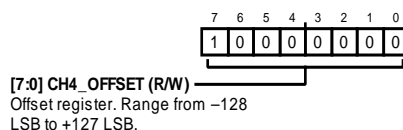


Table 50. Bit Descriptions for CH4\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH4_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x15, Reset: 0x80, Name: CH5\_OFFSET

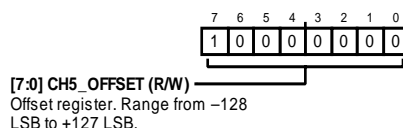


Table 51. Bit Descriptions for CH5\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH5_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x16, Reset: 0x80, Name: CH6\_OFFSET

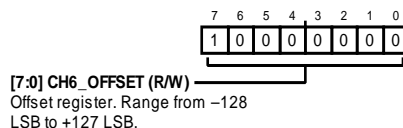


Table 52. Bit Descriptions for CH6\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH6_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x17, Reset: 0x80, Name: CH7\_OFFSET

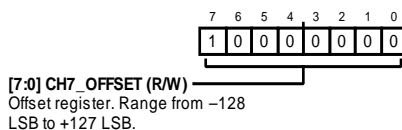


Table 53. Bit Descriptions for CH7\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH7_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x18, Reset: 0x80, Name: CH8\_OFFSET

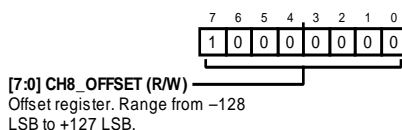


Table 54. Bit Descriptions for CH8\_OFFSET

Bits	Bit Name	Description	Reset	Access
[7:0]	CH8_OFFSET	Offset register. Range from -128 LSB to +127 LSB. 0x00 = -128 LSB offset; 0x80 = no offset; 0xFF = +127 LSB offset.	0x80	R/W

Address: 0x19, Reset: 0x00, Name: CH1\_PHASE

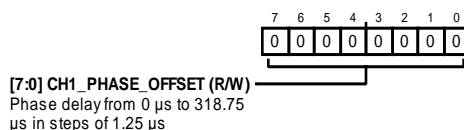


Table 55. Bit Descriptions for CH1\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH1_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1A, Reset: 0x00, Name: CH2\_PHASE

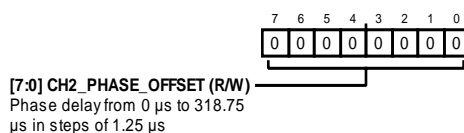


Table 56. Bit Descriptions for CH2\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH2_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1B, Reset: 0x00, Name: CH3\_PHASE

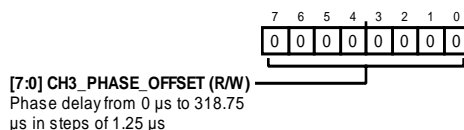


Table 57. Bit Descriptions for CH3\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH3_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1C, Reset: 0x00, Name: CH4\_PHASE

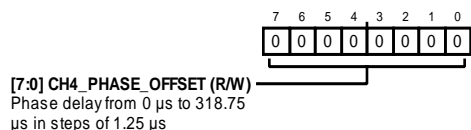


Table 58. Bit Descriptions for CH4\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH4_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1D, Reset: 0x00, Name: CH5\_PHASE

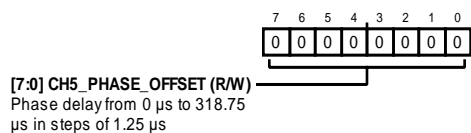


Table 59. Bit Descriptions for CH5\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH5_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1E, Reset: 0x00, Name: CH6\_PHASE

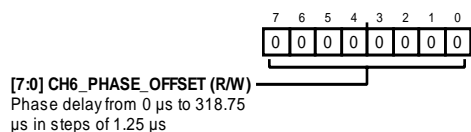


Table 60. Bit Descriptions for CH6\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH6_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x1F, Reset: 0x00, Name: CH7\_PHASE

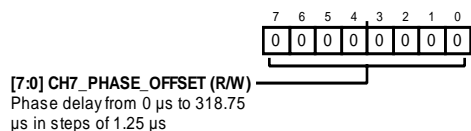


Table 61. Bit Descriptions for CH7\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH7_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x20, Reset: 0x00, Name: CH8\_PHASE

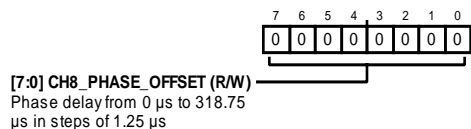


Table 62. Bit Descriptions for CH8\_PHASE

Bits	Bit Name	Description	Reset	Access
[7:0]	CH8_PHASE_OFFSET	Phase delay from 0 to 318.75 $\mu$ s in steps of 1.25 $\mu$ s.	0x0	R/W

Address: 0x21, Reset: 0x01, Name: DIGITAL\_DIAG\_ENABLE

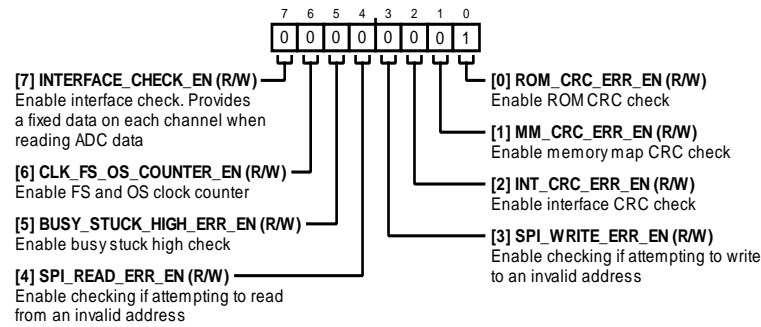


Table 63. Bit Descriptions for DIGITAL\_DIAG\_ENABLE

Bits	Bit Name	Description	Reset	Access
7	INTERFACE_CHECK_EN	Enable interface check. Provides a fixed data on each channel when reading ADC data.	0x0	R/W
6	CLK_FS_OS_COUNTER_EN	Enable FS and OS clock counter.	0x0	R/W
5	BUSY_STUCK_HIGH_ERR_EN	Enable busy stuck high check.	0x0	R/W
4	SPI_READ_ERR_EN	Enable checking if attempting to read from an invalid address.	0x0	R/W
3	SPI_WRITE_ERR_EN	Enable checking if attempting to write to an invalid address.	0x0	R/W
2	INT_CRC_ERR_EN	Enable interface CRC check.	0x0	R/W
1	MM_CRC_ERR_EN	Enable memory map CRC check.	0x0	R/W
0	ROM_CRC_ERR_EN	Enable ROM CRC check.	0x1	R/W

Address: 0x22, Reset: 0x00, Name: DIGITAL\_DIAG\_ERR

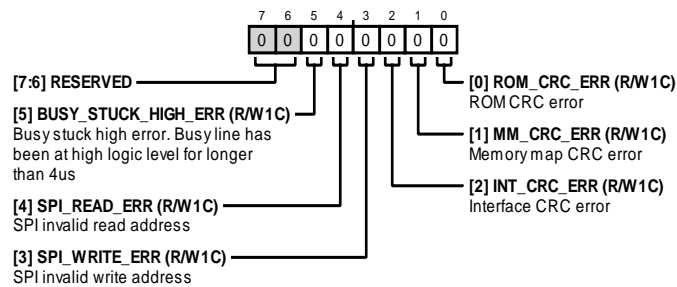


Table 64. Bit Descriptions for DIGITAL\_DIAG\_ERR

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
5	BUSY_STUCK_HIGH_ERR	Busy stuck high error. Busy line has been at high logic level for longer than 4 $\mu$ s.	0x0	R/W1C
4	SPI_READ_ERR	SPI invalid read address.	0x0	R/W1C
3	SPI_WRITE_ERR	SPI invalid write address.	0x0	R/W1C
2	INT_CRC_ERR	Interface CRC error.	0x0	R/W1C
1	MM_CRC_ERR	Memory map CRC error.	0x0	R/W1C
0	ROM_CRC_ERR	ROM CRC error.	0x0	R/W1C

Address: 0x23, Reset: 0x00, Name: OPEN\_DETECT\_ENABLE

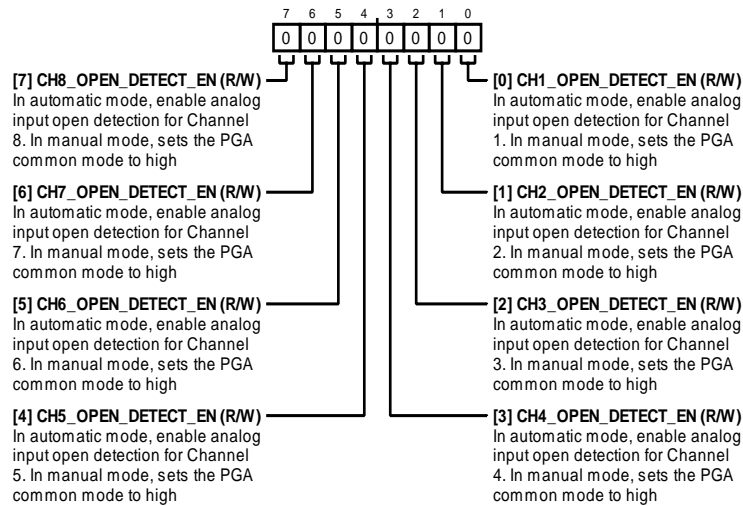


Table 65. Bit Descriptions for OPEN\_DETECT\_ENABLE

Bits	Bit Name	Description	Reset	Access
7	CH8_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 8. In manual mode, sets the PGA common mode to high.	0x0	R/W
6	CH7_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 7. In manual mode, sets the PGA common mode to high.	0x0	R/W
5	CH6_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 6. In manual mode, sets the PGA common mode to high.	0x0	R/W
4	CH5_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 5. In manual mode, sets the PGA common mode to high.	0x0	R/W
3	CH4_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 4. In manual mode, sets the PGA common mode to high.	0x0	R/W
2	CH3_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 3. In manual mode, sets the PGA common mode to high.	0x0	R/W
1	CH2_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 2. In manual mode, sets the PGA common mode to high.	0x0	R/W
0	CH1_OPEN_DETECT_EN	In automatic mode, enables analog input open detection for Channel 1. In manual mode, sets the PGA common mode to high.	0x0	R/W

Address: 0x24, Reset: 0x00, Name: OPEN\_DETECTED

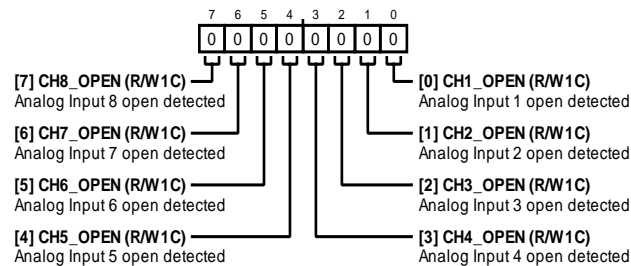


Table 66. Bit Descriptions for OPEN\_DETECTED

Bits	Bit Name	Description	Reset	Access
7	CH8_OPEN	Analog Input 8 open detected.	0x0	R/W1C
6	CH7_OPEN	Analog Input 7 open detected.	0x0	R/W1C
5	CH6_OPEN	Analog Input 6 open detected.	0x0	R/W1C
4	CH5_OPEN	Analog Input 5 open detected.	0x0	R/W1C
3	CH4_OPEN	Analog Input 4 open detected.	0x0	R/W1C

Bits	Bit Name	Description	Reset	Access
2	CH3_OPEN	Analog Input 3 open detected.	0x0	R/W1C
1	CH2_OPEN	Analog Input 2 open detected.	0x0	R/W1C
0	CH1_OPEN	Analog Input 1 open detected.	0x0	R/W1C

Address: 0x25, Reset: 0x00, Name: AIN\_OV\_UV\_DIAG\_ENABLE

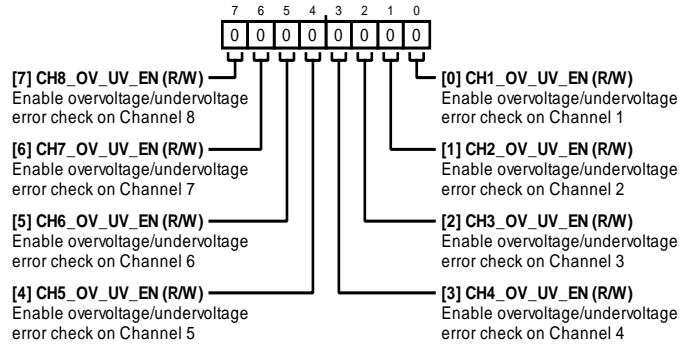


Table 67. Bit Descriptions for AIN\_OV\_UV\_DIAG\_ENABLE

Bits	Bit Name	Description	Reset	Access
7	CH8_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 8.	0x0	R/W
6	CH7_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 7.	0x0	R/W
5	CH6_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 6.	0x0	R/W
4	CH5_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 5.	0x0	R/W
3	CH4_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 4.	0x0	R/W
2	CH3_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 3.	0x0	R/W
1	CH2_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 2.	0x0	R/W
0	CH1_OV_UV_EN	Enable overvoltage/undervoltage error check on Channel 1.	0x0	R/W

Address: 0x26, Reset: 0x00, Name: AIN\_OV\_DIAG\_ERROR

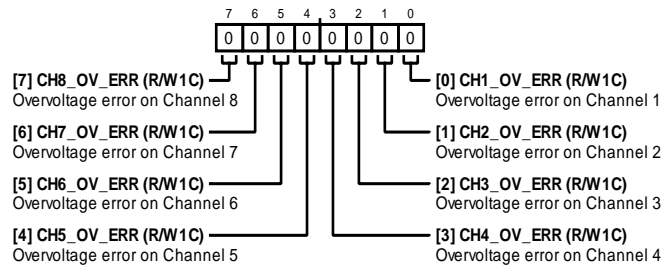


Table 68. Bit Descriptions for AIN\_OV\_DIAG\_ERROR

Bits	Bit Name	Description	Reset	Access
7	CH8_OV_ERR	Overvoltage error on Channel 8.	0x0	R/W1C
6	CH7_OV_ERR	Overvoltage error on Channel 7.	0x0	R/W1C
5	CH6_OV_ERR	Overvoltage error on Channel 6.	0x0	R/W1C
4	CH5_OV_ERR	Overvoltage error on Channel 5.	0x0	R/W1C
3	CH4_OV_ERR	Overvoltage error on Channel 4.	0x0	R/W1C
2	CH3_OV_ERR	Overvoltage error on Channel 3.	0x0	R/W1C
1	CH2_OV_ERR	Overvoltage error on Channel 2.	0x0	R/W1C
0	CH1_OV_ERR	Overvoltage error on Channel 1.	0x0	R/W1C

Address: 0x27, Reset: 0x00, Name: AIN\_UV\_DIAG\_ERROR

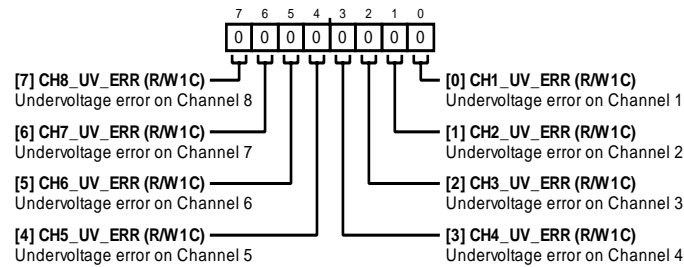


Table 69. Bit Descriptions for AIN\_UV\_DIAG\_ERROR

Bits	Bit Name	Description	Reset	Access
7	CH8_UV_ERR	Undervoltage error on Channel 8.	0x0	R/W1C
6	CH7_UV_ERR	Undervoltage error on Channel 7.	0x0	R/W1C
5	CH6_UV_ERR	Undervoltage error on Channel 6.	0x0	R/W1C
4	CH5_UV_ERR	Undervoltage error on Channel 5.	0x0	R/W1C
3	CH4_UV_ERR	Undervoltage error on Channel 4.	0x0	R/W1C
2	CH3_UV_ERR	Undervoltage error on Channel 3.	0x0	R/W1C
1	CH2_UV_ERR	Undervoltage error on Channel 2.	0x0	R/W1C
0	CH1_UV_ERR	Undervoltage error on Channel 1.	0x0	R/W1C

Address: 0x28, Reset: 0x00, Name: DIAGNOSTIC\_MUX\_CH1\_2

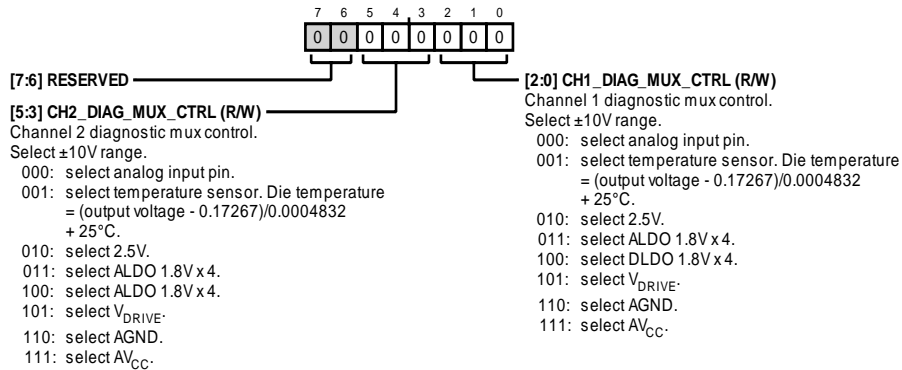


Table 70. Bit Descriptions for DIAGNOSTIC\_MUX\_CH1\_2

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:3]	CH2_DIAG_MUX_CTRL	Channel 2 diagnostic mux control. Select ±10 V range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage - 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V × 4. 100: select ALDO 1.8 V × 4. 101: select $V_{DRIVE}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W
[2:0]	CH1_DIAG_MUX_CTRL	Channel 1 diagnostic mux control. Select ±10 V range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage - 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V × 4. 100: select DLDO 1.8 V × 4.	0x0	R/W



Bits	Bit Name	Description	Reset	Access
		101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .		

Address: 0x29, Reset: 0x00, Name: DIAGNOSTIC\_MUX\_CH3\_4

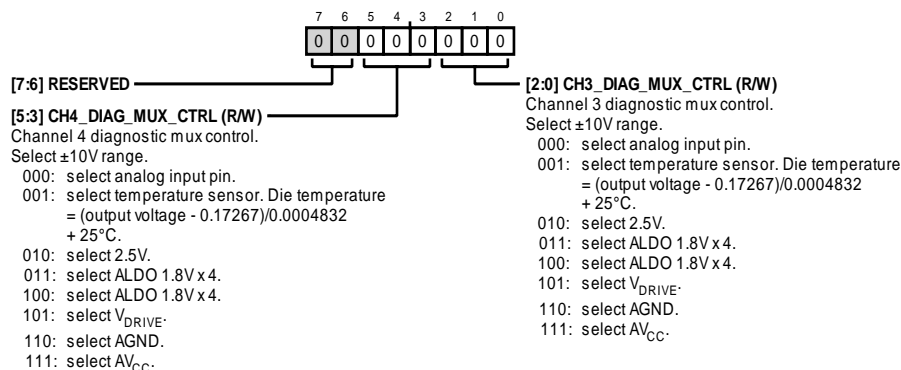


Table 71. Bit Descriptions for DIAGNOSTIC\_MUX\_CH3\_4

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:3]	CH4_DIAG_MUX_CTRL	Channel 4 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V x 4. 100: select ALDO 1.8 V x 4. 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W
[2:0]	CH3_DIAG_MUX_CTRL	Channel 3 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V x 4. 100: select ALDO 1.8 V x 4. 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W

Address: 0x2A, Reset: 0x00, Name: DIAGNOSTIC\_MUX\_CH5\_6

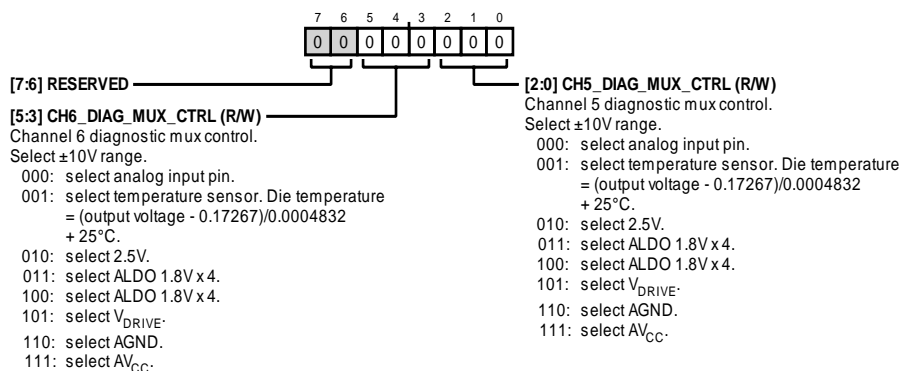


Table 72. Bit Descriptions for DIAGNOSTIC\_MUX\_CH5\_6

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:3]	CH6_DIAG_MUX_CTRL	Channel 6 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V $\times 4$ . 100: select ALDO 1.8 V $\times 4$ . 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W
[2:0]	CH5_DIAG_MUX_CTRL	Channel 5 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V $\times 4$ . 100: select ALDO 1.8 V $\times 4$ . 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W

Address: 0x2B, Reset: 0x00, Name: DIAGNOSTIC\_MUX\_CH7\_8

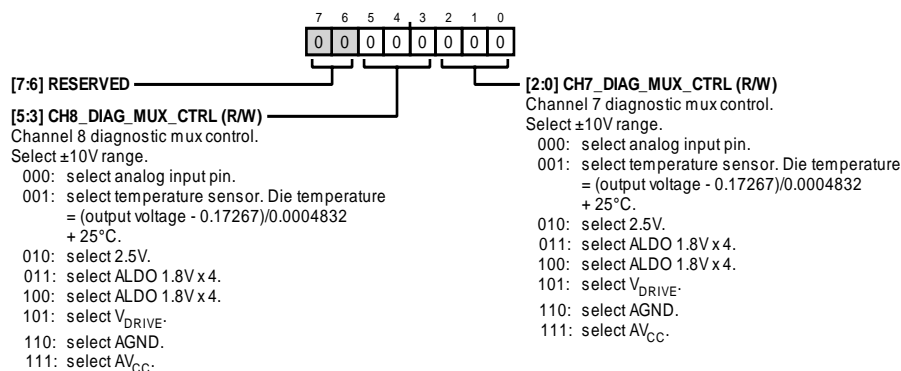


Table 73. Bit Descriptions for DIAGNOSTIC\_MUX\_CH7\_8

Bits	Bit Name	Description	Reset	Access
[7:6]	RESERVED	Reserved.	0x0	R
[5:3]	CH8_DIAG_MUX_CTRL	Channel 8 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V $\times 4$ . 100: select ALDO 1.8 V $\times 4$ . 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W
[2:0]	CH7_DIAG_MUX_CTRL	Channel 7 diagnostic mux control. Select $\pm 10V$ range. 000: select analog input pin. 001: select temperature sensor. Die temperature = (output voltage – 0.17267)/0.0004832 + 25°C. 010: select 2.5 V. 011: select ALDO 1.8 V $\times 4$ . 100: select ALDO 1.8 V $\times 4$ . 101: select $V_{DRIVE-}$ . 110: select AGND. 111: select $AV_{CC}$ .	0x0	R/W

Address: 0x2C, Reset: 0x00, Name: OPEN\_DETECT\_QUEUE

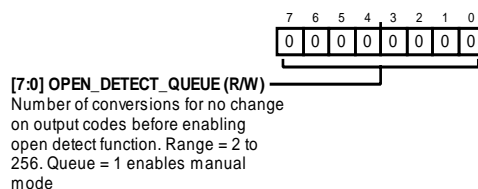


Table 74. Bit Descriptions for OPEN\_DETECT\_QUEUE

Bits	Bit Name	Description	Reset	Access
[7:0]	OPEN_DETECT_QUEUE	Number of conversions for no change on output codes before enabling open detect function. Range = 2 to 256. Queue = 1 enables manual mode.	0x0	R/W

Address: 0x2D, Reset: 0x00, Name: FS\_CLK\_COUNTER

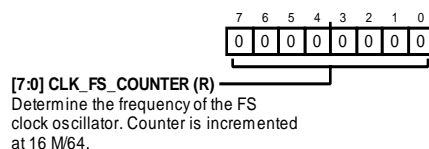


Table 75. Bit Descriptions for FS\_CLK\_COUNTER

Bits	Bit Name	Description	Reset	Access
[7:0]	CLK_FS_COUNTER	Determine the frequency of the FS clock oscillator. Counter is incremented at 16 M/64.	0x0	R

Address: 0x2E, Reset: 0x00, Name: OS\_CLK\_COUNTER

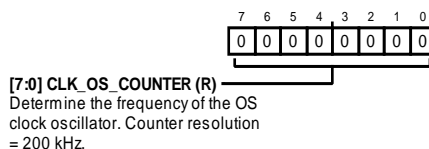


Table 76. Bit Descriptions for OS\_CLK\_COUNTER

Bits	Bit Name	Description	Reset	Access
[7:0]	CLK_OS_COUNTER	Determine the frequency of the OS clock oscillator. Counter resolution = 200 kHz.	0x0	R

Address: 0x2F, Reset: 0x14, Name: ID

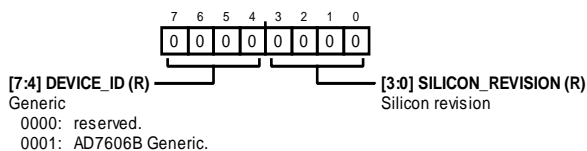
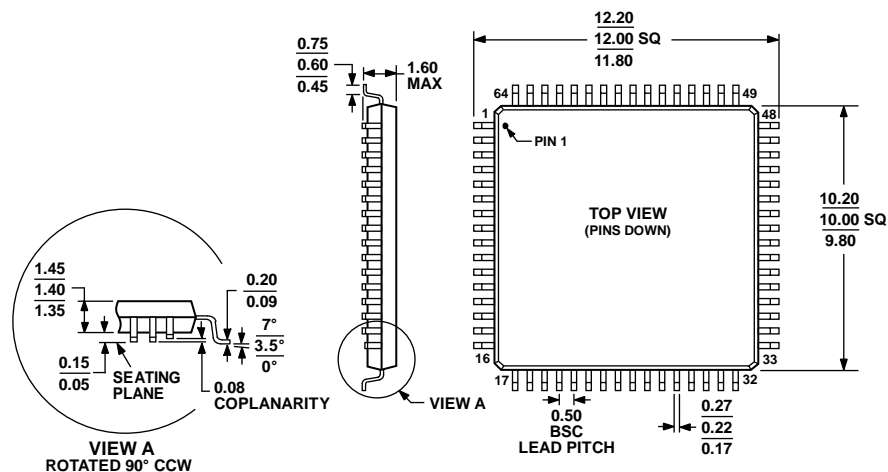


Table 77. Bit Descriptions for ID

Bits	Bit Name	Description	Reset	Access
[7:4]	DEVICE_ID	Generic. 0000: reserved. 0001: AD7606B generic.	0x1	R
[3:0]	SILICON_REVISION	Silicon revision.	0x4	R

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-026-BCD

Figure 88. 64-Lead Low Profile Quad Flat Package [LQFP]  
(ST-64-2)

Dimensions shown in millimeters

051706-A

## ORDERING GUIDE

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
AD7606BBSTZ	−40°C to +125°C	64-Lead Low Profile Quad Flat Package [LQFP]	ST-64-2
AD7606BBSTZ-RL	−40°C to +125°C	64-Lead Low Profile Quad Flat Package [LQFP]	ST-64-2
EVAL-AD7606BFMCZ		Evaluation Board for the AD7606B	
EVAL-SDP-CH1Z		Evaluation Controller Board	

<sup>1</sup> Z = RoHS Compliant Part.